## TLE9461-3ES V33

## Lite CAN SBC Family

## ( RoHS (C) DD CAN PN $^{\text {PD }}$

## 1 Overview

## Features

## Key Features

- Very low quiescent current consumption in Stop- and Sleep Mode

- Periodic Cyclic Wake in SBC Normal-, Stop- and Sleep Mode
- Periodic Cyclic Sense in SBC Normal-, Stop- and Sleep Mode
- Low-Drop Linear Voltage Regulator 3.3 V, 150 mA ( 250 mA peak) for main supply,
- Low-Drop Linear Voltage Regulator $5 \mathrm{~V}, 100 \mathrm{~mA}$, protection feature for off-board usage
- High-Speed CAN transceiver supporting FD communication up to $5 \mathrm{Mbit} / \mathrm{s}$ and featuring CAN Partial Networking \& CAN FD tolerant mode according to ISO 11898-2:2016 \& SAE J2284
- Fully compliant to "Hardware Requirements for LIN, CAN and FlexRay Interfaces in Automotive Applications" Revision 1.3, 2012-05-04
- Charge pump-output for N-channel MOSFET reverse-polarity protection or load switch feature with integrated spread spectrum modulation feature for optimum EMC performance
- Universal High-Voltage Wake input for voltage level monitoring and wake-up detection
- General Purpose High-Voltage in- and output (GPIO) configurable as Fail Output, Wake Input, Low-Side switch or High-Side switch
- High-Voltage Measurement function as alternative pin assignment
- Fail Output for Fail-Safe signalization
- Configurable wake-up sources
- Reset \& Interrupt outputs
- Configurable timeout and window watchdog
- Overtemperature and short circuit protection feature
- Dedicated TEST pin for SBC Development Mode entry (watchdog counter stopped)
- Software compatible to other SBC families TLE926x and TLE927x
- Wide input voltage and temperature range
- Optimized for Electromagnetic Compatibility (EMC) and low Electromagnetic Emission (EME)
- Optimized for high immunity against Electromagnetic Interference (EMI)
- AEC Qualified \& Green Product (RoHS compliant)


## Overview

## Scalable System Basis Chip (SBC) Family

- Product family for complete scalable application coverage
- Optimized feature set for optimal system design
- Dedicated Data Sheets are available for all product variants
- Complete compatibility (hardware- and software across the family)
- Same PG-TSDSO-24-1 package with exposed pad (EP) for all product variants
- CAN Partial Networking variants (-3ES)
- Product variants for 5 V (TLE94xxyy) and 3.3 V (TLE94xxyyV33) output voltage for main regulator
- Software compatible to other SBC families TLE926x and TLE927x


## Potential applications

- HVAC ECU and Control panel
- Light Control Unit (LCU) for front, rear and ambient
- Seat control module
- Seat belt pretension
- Steering column and steering lock
- Closure (trunk, sliding door, etc.)
- Gear shifters and selectors
- Smart power distribution modules


## Product validation

Qualified for automotive applications. Product validation according to AEC-Q100/101.

## Description

The TLE9461-3ES V33 is a monolithically integrated circuit in an exposed pad PG-TSDSO-24-1 (150 mil) power package. The device is designed for various CAN automotive applications as main supply for the microcontroller and as interface for a CAN bus network.
To support these applications, the System Basis Chip (SBC) provides the main functions, such as a 3.3 V lowdropout voltage regulator (LDO) for e.g. a microcontroller supply, another 5 V low-dropout voltage regulator with off-board protection for e.g. sensor supply, a HS-CAN transceiver supporting CAN FD and CAN Partial Networking (incl. FD tolerant mode) for data transmission, a high-voltage GPIO with embedded protective functions and a 16-bit Serial Peripheral Interface (SPI) to control and monitor the device. Also a configurable timeout / window watchdog circuit with a reset feature, one dedicated fail output and an undervoltage reset feature are implemented.
The device offers low-power modes in order to minimize current consumption in applications that are connected permanently to the battery. A wake-up from the low-power mode is possible via a message on the CAN bus, via the bi-level sensitive monitoring/wake-up input as well as via Cyclic Wake.
The device is designed to withstand the severe conditions of automotive applications

| Type | Package | Marking |
| :--- | :--- | :--- |
| TLE9461-3ES V33 | PG-TSDSO-24-1 | TLE9461-3ESV33 |

Table of Contents
1 Overview ..... 1
2 Block Diagram ..... 7
3 Pin Configuration ..... 8
3.1 Pin Assignment ..... 8
3.2 Pin Definitions and Functions ..... 8
3.3 Hints for Unused Pins ..... 10
3.4 Hints for Alternative Pin Functions ..... 10
4 General Product Characteristics ..... 11
4.1 Absolute Maximum Ratings ..... 11
4.2 Functional Range ..... 13
4.3 Thermal Resistance ..... 14
4.4 Current Consumption ..... 15
5 System Features ..... 19
5.1 Block Description of State Machine ..... 20
5.1.1 Device Configuration and SBC Init Mode ..... 21
5.1.1.1 Device Configuration ..... 21
5.1.1.2 SBC Init Mode ..... 24
5.1.2 SBC Normal Mode ..... 25
5.1.3 SBC Stop Mode ..... 26
5.1.4 SBC Sleep Mode ..... 27
5.1.5 SBC Restart Mode ..... 28
5.1.6 SBC Fail-Safe Mode ..... 29
5.1.7 SBC Development Mode ..... 30
5.1.8 Electrical Characteristics for Pin TEST ..... 32
5.2 Wake Features ..... 33
5.2.1 Cyclic Sense ..... 33
5.2.1.1 Configuration and Operation of Cyclic Sense ..... 34
5.2.1.2 Cyclic Sense in Low-Power Mode ..... 37
5.2.2 Cyclic Wake ..... 37
5.2.3 Internal Timer ..... 38
5.3 Charge Pump Output for Reverse Polarity Protection ..... 39
5.3.1 Electrical Characteristics for Charge Pump ..... 40
5.4 High-Voltage Measurement Interface ..... 41
5.4.1 Block Description ..... 41
5.4.2 Functional Description ..... 41
5.4.3 Electrical Characteristics for Measurement Interface ..... 43
5.5 Spread Spectrum Modulation Frequency Function ..... 44
5.6 Partial Networking on CAN ..... 45
5.6.1 CAN Partial Networking - Selective Wake Feature ..... 45
5.6.2 SBC Partial Networking Function ..... 46
5.6.2.1 Activation of SWK ..... 47
5.6.2.2 Wake-up Pattern (WUP) ..... 48
5.6.2.3 Wake-up Frame (WUF) ..... 48
5.6.2.4 CAN Protocol Error Counter ..... 49
5.6.3 Diagnoses Flags ..... 50
5.6.3.1 PWRON/RESET-FLAG

50
5.6.3.2 BUSERR-Flag . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 50
5.6.3.3 TXD Dominant Time-out flag . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 50
5.6.3.4 WUP Flag ....................................................................................................... . . . . . 50
5.6.3.5 WUF Flag (WUF) . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 50
5.6.3.6 SYSERR Flag (SYSERR) . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 50
5.6.3.7 Configuration Error ............................................................................................. . . . 51
5.6.3.8 CAN Bus Timeout-Flag (CANTO) . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 51
5.6.3.9 CAN Bus Silence-Flag (CANSIL) . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 51
5.6.3.10 SYNC-FLAG (SYNC) . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 51
5.6.3.11 SWK_SET FLAG (SWK_SET) . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 51
5.6.4 SBC Modes for Selective Wake (SWK) . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 52
5.6.4.1 SBC Normal Mode with SWK . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 52
5.6.4.2 SBC Stop Mode with SWK . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 53
5.6.4.3 SBC Sleep Mode with SWK . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 54
5.6.4.4 SBC Restart Mode with SWK . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 55
5.6.4.5 SBC Fail-Safe Mode with SWK . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 56

5.6.6 Configuration for SWK . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 56
5.6.7 CAN Flexible Data Rate (CAN FD) Tolerant Mode . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 57
5.6.8 Clock and Data Recovery ..................................................................................... . . . . . . 58
5.6.8.1 Configuring the Clock Data Recovery for SWK . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 58
5.6.8.2 Setup of Clock and Data Recovery . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 59
5.6.9 Electrical Characteristics ......................................................................................... . . . . . . 60

6 Voltage Regulator 1 . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 62
6.1 Block Description . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 62
6.2 Functional Description . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 63
6.3 Electrical Characteristics . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 64

7 Voltage Regulator 2......................................................................................... . . . 66
7.1 Block Description . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 66

7.2.1 Short to Battery Protection . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 67
7.3 Electrical Characteristics .......................................................................................... . . . . . 68

8 High-Speed CAN FD Transceiver ....................................................................... 71
8.1 Block Description . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 71
8.2 Functional Description ................................................................................................ 71
8.2.1 CAN Off Mode . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 73

8.2.3 CAN Receive Only Mode ............................................................................................. 74

8.2.5 CAN Bus termination ............................................................................................. . . . . . 75
8.2.6 TXD Time-out Feature ................................................................................................ 75
8.2.7 Bus Dominant Clamping . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 76
8.2.8 Undervoltage Detection ........................................................................................ . . . 76
8.3 Electrical Characteristics . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 77

9 High-Voltage Wake and Voltage Monitoring Input . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . . 84
9.1 Block Description ..... 84
9.2 High-Voltage Wake Function ..... 85
9.2.1 Functional Description ..... 85
9.2.2 Wake Input Configuration ..... 86
9.2.3 Wake configuration for Cyclic Sense ..... 87
9.2.4 High-Voltage Sensing as Alternate Function ..... 87
9.3 Electrical Characteristics ..... 88
10 Interrupt Function ..... 89
10.1 Block and Functional Description ..... 89
10.2 Electrical Characteristics ..... 91
11 Fail Output (FO) and General Purpose I/O (GPIO) ..... 92
11.1 Block and Functional Description ..... 92
11.1.1 Fail-Output Function ..... 93
11.1.2 General Purpose I/O Function as Alternative Function ..... 94
11.1.3 WK and FO/GPIO HV-Sensing Function as Alternative Function ..... 97
11.2 Electrical Characteristics ..... 98
12 Supervision Functions ..... 100
12.1 Reset Function ..... 100
12.1.1 Reset Output Description ..... 100
12.1.2 Soft Reset Description ..... 101
12.2 Watchdog Function ..... 102
12.2.1 Time-Out Watchdog ..... 103
12.2.2 Window Watchdog ..... 103
12.2.3 Watchdog Setting Check Sum ..... 104
12.2.4 Watchdog during SBC Stop Mode ..... 104
12.2.5 Watchdog Start in SBC Stop Mode due to Bus Wake ..... 105
12.3 VS Power-On Reset ..... 106
12.4 VS Under- and Overvoltage ..... 107
12.4.1 VS Undervoltage ..... 107
12.4.2 VS Overvoltage ..... 107
12.5 VCC1 Over-/ Undervoltage and Undervoltage Prewarning ..... 107
12.5.1 VCC1 Undervoltage and Undervoltage Prewarning ..... 107
12.5.2 VCC1 Overvoltage ..... 108
12.6 VCC1 Short Circuit Diagnostics ..... 109
12.7 VCC2 Undervoltage and VCAN Undervoltage ..... 109
12.8 Thermal Protection ..... 110
12.8.1 Individual Thermal Shutdown ..... 110
12.8.2 Temperature Prewarning ..... 110
12.8.3 SBC Thermal Shutdown ..... 110
12.9 Electrical Characteristics ..... 111
13 Serial Peripheral Interface ..... 115
13.1 SPI Block Description ..... 115
13.2 Failure Signalization in the SPI Data Output ..... 116
13.3 SPI Programming ..... 117
13.4 SPI Bit Mapping ..... 120
13.5 SPI Control Registers ..... 123
13.5.1 General Control Registers ..... 126
13.5.2 Selective Wake Control Registers ..... 139
13.6 SPI Status Information Registers ..... 151
13.6.1 General Status Registers ..... 152
13.6.2 Selective Wake Status Registers ..... 159
13.6.3 Family and Product Information Register ..... 161
13.7 Electrical Characteristics ..... 162
14 Application Information ..... 164
14.1 Application Diagrams ..... 164
14.2 ESD Tests ..... 170
14.3 Thermal Behavior of Package ..... 171
14.4 Further Application Information ..... 172
15 Package Outlines ..... 173
16 Revision History ..... 174

Lite CAN SBC Family
Block Diagram

## 2 <br> Block Diagram



Figure 1 TLE9461-3ES V33 Block Diagram

Lite CAN SBC Family
Pin Configuration

## 3 Pin Configuration

### 3.1 Pin Assignment



Figure 2 Pin Configuration

### 3.2 Pin Definitions and Functions

| Pin | Symbol | Function |
| :--- | :--- | :--- |
| 1 | VCAN | HS-CAN Supply Input; Supply needed for CAN Normal and Receive Only Mode |
| 2 | TXDCAN | Transmit CAN |
| 3 | RXDCAN | Receive CAN |
| 4 | CLK | SPI Clock Input |
| 5 | SDI | SPI Data Input; input for SBC (=MOSI) |
| 6 | SDO | SPI Data Output; output from SBC (=MISO) |
| 7 | CSN | SPI Chip Select Input; active low |
| 8 | Interrupt Output; used as wake-up flag for microcontroller in SBC Stop or <br> Normal Mode and for indicating failures. Active low. <br> During start-up used to set the SBC configuration in case of watchdog trigger <br> failure. External pull-up (typ. 47 $\mathrm{k} \Omega)$ sets config $1 / 3$, otherwise config 2/4 is <br> selected. |  |

## Pin Configuration

| Pin | Symbol | Function |
| :---: | :---: | :---: |
| 9 | RSTN | Reset Output; active low, internal pull-up |
| 10 | TEST | Test Pin; Connect to GND or leave open for normal user mode operation; Connect to VCC1 at device power-on to activate SBC Development Mode (see Chapter 5.1.7). Integrated pull-down resistor. |
| 11 | GND | Ground; LDO 1 Power GND |
| 12 | VIO | Digital I/O Pin Voltage Supply; Must be connected to the buffered VCC1 voltage (see also Figure 50) |
| 13 | VCC1 | Voltage Regulator 1 Output |
| 14 | n.c. | not connected; internally not bonded |
| 15 | VS | Supply Voltage; Supply for VCC1 power stage - both VS pins must be connected together on same battery potential for proper operation; Connect to battery voltage via reverse polarity protection diode and filter against EMC |
| 16 | VS | Supply Voltage; Main supply of device - both VS pins must be connected together on same battery potential for proper operation; Connect to battery voltage via reverse polarity protection diode and filter against EMC |
| 17 | VCP | Charge Pump Output; For driving the gate of external N-channel MOSFETs, e.g. for reverse polarity protection or Kl. 30 load switch. Always place a $1 \mathrm{k} \Omega$ resistor in series for protection |
| 18 | WK/VSENSE | Wake Input; <br> Sense Input; Alternative function: HV-measurement function input |
| 19 | FO/GPIO | Fail Output; Open Drain Output, active low; <br> GPIO; Alternative function: configurable pin as WK, LS-, or HS-witch supplied by VS (default is FO, see also Chapter 11.1.1) <br> Sense Output; Alternative function: if HV-measurement function is configured |
| 20 | VCC2 | Voltage Regulator 2 Output |
| 21 | GND | Ground; Analog GND |
| 22 | GND | Ground; CAN GND |
| 23 | CANH | CAN High Bus Pin |
| 24 | CANL | CAN Low Bus Pin |
| Cooling Tab | GND | Cooling Tab - Exposed Die Pad; For cooling purposes only, connect to but do not use as an electrical ground ${ }^{1)}$ |

1) The exposed die pad at the bottom of the package allows better power dissipation of heat from the SBC via the PCB. The exposed die pad is not connected to any active part of the IC. However, it should be connected to GND for the best EMC performance.

Note: $\quad$ Both VS Pins must be connected to same battery potential; all GND pins as well as the Cooling Tab must be connected to one common GND potential

## Pin Configuration

### 3.3 Hints for Unused Pins

In case functions or pins are not used, it must be ensured that the configurations are done properly, e.g. disabled via SPI. Unused pins should be handled as follows:

- WK/VSENSE: connect to GND and disable WK inputs via SPI
- RSTN / INTN / FO: leave open
- VCC2 / VCP: leave open and keep disabled
- VCAN: connect to VCC1
- CANH/L, RXDCAN, TXDCAN: leave all pins open
- TEST: Leave open or connect to GND for normal user mode operation or connect to VIO to activate SBC Development Mode;
- n.c.: not connected; internally not bonded; leave open
- If unused pins are routed to an external connector which leaves the ECU, then these pins should have provision for a jumper (depopulated if unused)


### 3.4 Hints for Alternative Pin Functions

In case of SPI selectable alternative pin functions, it must be ensured that the correct configurations are also selected via SPI (in case it is not done automatically). Please consult the respective chapter. In addition, following topics shall be considered:

- WK/VSENSE: The pin can be either used as high-voltage wake-up and monitoring function or for a voltage measurement function (via bit setting WK_MEAS = ' 1 '). In the second case, the WK pin shall not be used / assigned for any wake-up detection nor Cyclic Sense functionality, i.e. WK must be disabled in the register WK_CTRL_1 and the level information must be ignored in the register WK_LVL_STAT.
- FO/GPIO: The pin can also be configured as a GPIO in the GPIO_CTRL register. In this case, the pin shall not be used for any fail output functionality.
The default configuration after start-up or power on reset (POR) is FO.


## General Product Characteristics

## 4 General Product Characteristics

### 4.1 Absolute Maximum Ratings

Table 1 Absolute Maximum Ratings ${ }^{1)}$
$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Voltages |  |  |  |  |  |  |  |
| Supply Voltage VS | $V_{S, \text { max }}$ | -0.3 | - | 28 | V | - | P_4.1.1 |
| Supply Voltage VS | $V_{S, ~ m a x}$ | -0.3 | - | 40 | V | Load Dump, max. 400 ms | P_4.1.2 |
| Voltage Regulator 1 Output | $V_{\text {CC1, max }}$ | -0.3 | - | 5.5 | V | ${ }^{2)}$ | P_4.1.3 |
| Voltage Regulator 2 Output | $V_{\text {CC2, max }}$ | -0.3 | - | 28 | V | $V_{C C 2}=40 \mathrm{~V}$ for Load Dump, max. 400 ms ; | P_4.1.5 |
| Charge Pump Output | $V_{\text {CP, max }}$ | -0.3 | - | $\begin{aligned} & V_{\mathrm{s}} \\ & +16 \end{aligned}$ | v |  | P_4.1.6 |
| Wake Input WK/VSENSE | $V_{\text {WK, max }}$ | -0.3 | - | 40 | V | - | P_4.1.7 |
| Fail Output FO/GPIO | $V_{\text {FO_TEST, max }}$ | -0.3 | - | $\begin{aligned} & V_{s} \\ & +0.3 \end{aligned}$ | V | - | P_4.1.8 |
| CANH, CANL | $V_{\text {BUS, max }}$ | -27 | - | 40 | V | - | P_4.1.9 |
| Logic Input Pins (CSN, CLK, SDI, TXDCAN, TEST) | $V_{1, \text { max }}$ | -0.3 | - | $\begin{aligned} & v_{c C 1} \\ & +0.3 \end{aligned}$ | V | - | P_4.1.10 |
| Logic Output Pins (SDO, RSTN, INTN, RXDCAN) | $V_{0, \max }$ | -0.3 | - | $\begin{aligned} & v_{c C 1} \\ & +0.3 \end{aligned}$ | v | - | P_4.1.11 |
| VCAN Input Voltage | $V_{\text {VCAN, max }}$ | -0.3 | - | 5.5 | V | - | P_4.1.12 |
| I/O Supply Voltage | $V_{\text {VII, } \text { max }}$ | -0.3 | - | 5.5 | V | Must be connected to VCC1 | P_4.1.19 |
| Maximum Differential CAN Bus Voltage | $V_{\text {CAN_Diff, max }}$ | -5 | - | 10 | v | - | P_4.1.20 |

## Temperatures

| Junction Temperature | $T_{\mathrm{j}}$ | -40 | - | 150 | ${ }^{\circ} \mathrm{C}$ | - | P_4.1.13 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Storage Temperature | $T_{\text {stg }}$ | -55 | - | 150 | ${ }^{\circ} \mathrm{C}$ | - | P_4.1.14 |

ESD Susceptibility

| ESD Resistivity | $V_{\text {ESD,11 }}$ | -2 | - | 2 | kV | HBM $^{3)}$ | P_4.1.15 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| ESD Resistivity to GND, <br> CANH, CANL | $V_{\text {ESD,12 }}$ | -8 | - | 8 | kV | HBM $^{433}$ | P_4.1.16 |

## General Product Characteristics

## Table 1 Absolute Maximum Ratings ${ }^{1)}$ (cont'd)

$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | Min. | Typ. | Max. |  |  |  |
| ESD Resistivity to GND |  | -500 | - | 500 | V | CDM $^{5)}$ | P_4.1.17 |
| ESD Resistivity Pin 1, <br> $12,13,24 ~(c o r n e r ~ p i n s) ~ t o ~$ <br> GND | $V_{\text {ESD,22 }}$ | -750 | - | 750 | V | CDM $^{5)}$ | P_4.1.18 |

1) Not subject to production test, specified by design.
2) The VCC1 and digital I/O maximum rating can be 6.0 V for a limited time (up to 100 h ).
3) ESD susceptibility, HBM according to ANSI/ESDA/JEDEC JS-001 ( $1.5 \mathrm{k} \Omega, 100 \mathrm{pF}$ )
4) Please see chapter "Application Information" For ESD "GUN" resistivity (according to IEC61000-4-2 "gun test" ( 150 pF , $330 \Omega$ )).
5) ESD susceptibility, Charged Device Model "CDM" EIA/JESD22-C101 or ESDA STM5.3.1

## Notes

1. Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
2. Integrated protection functions are designed to preventIC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

General Product Characteristics

### 4.2 Functional Range

Table 2 Functional Range ${ }^{1)}$

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Supply Voltage | $V_{\text {S,func }}$ | $V_{\text {POR }}$ | - | 28 | V | ${ }^{2)} V_{\text {POR }}$ see section Chapter 12.9 | P_4.2.1 |
| CAN Supply Voltage | $V_{\text {CAN,func }}$ | 4.75 | - | 5.25 | V | - | P_4.2.2 |
| SPI Frequency | $f_{\text {SPI }}$ | - | - | 4 | MHz | see <br> Chapter 13.7 for $\mathrm{f}_{\mathrm{SPI}, \max }$ | P_4.2.3 |
| Junction Temperature | $T_{\mathrm{j}}$ | -40 | - | 150 | ${ }^{\circ} \mathrm{C}$ | - | P_4.2.4 |

1) Not subject to production test, specified by design.
2) Including Power-On Reset, Over- and Undervoltage Protection

Note: Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

## Device Behavior Outside of Specified Functional Range:

- $28 \mathrm{~V}<V_{\text {s,func }}<40 \mathrm{~V}$ : Device is still functional (including the state machine); the specified electrical characteristics might not be ensured anymore. The regulators VCC1/2 are working properly, however, a thermal shutdown might occur due to high power dissipation. The specified SPI communication speed is ensured; the absolute maximum ratings are not violated, however the device is not intended for continuous operation of $\mathrm{VS}>28 \mathrm{~V}$. The device operation at high junction temperatures for long periods might reduce the operating life time;
- $V_{\text {CAN }}<4.75 \mathrm{~V}$ : The undervoltage bit VCAN_UV is set in the SPI register BUS_STAT and the transmitter is disabled as long as the UV condition is present;
- 5.25 V < $V_{\text {CAN }}<6.0 \mathrm{~V}$ : CAN transceiver is still functional. However, the communication might fail due to out-of-spec operation;
- $\mathbf{V}_{\text {POR,f,f }}<\mathrm{VS}<5.5 \mathrm{~V}$ : Device is still functional; the specified electrical characteristics might not be ensured anymore:
- The voltage regulators will enter the linear ( $\mathrm{R}_{\mathrm{DS} \_\mathrm{on}}$ ) operation mode,
- A VCC1_UV reset could be triggered depending on the Vrtx settings,
- GPIO behavior depends on the respective configuration: - HS/LS switches remain switched On as long as the control voltage is sufficient.
- An unwanted overcurrent shutdown may occur. - OC shutdown bit set and the respective HS/LS switch will turn Off;
- FO output remains On if it was enabled before VS $>5.5 \mathrm{~V}$,
- The specified SPI communication speed is ensured.


## General Product Characteristics

### 4.3 Thermal Resistance

Table 3 Thermal Resistance ${ }^{\text {1) }}$

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | Min. | Typ. | Max. |  |  |  |
| Junction to Soldering Point |  | - | 14 | - | K/W | Exposed Pad | P_4.3.1 |
| Junction to Ambient | $R_{\text {th }(\mathrm{JA})}$ | - | 35 | - | K/W | $2)$ | P_4.3.2 |

1) Not subject to production test, specified by design.
2) Specified $R_{\text {th(JA) }}$ value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2 s 2 p board for a power dissipation of 1.5 W ; the product (chip+package) was simulated on a $76.2 \times 114.3 \times 1.5 \mathrm{~mm}^{3}$ with 2 inner copper layers ( $2 \times 70 \mu \mathrm{~m} \mathrm{Cu}, 2 \times 35 \mu \mathrm{~m}$ C); where applicable a thermal via array under the exposed pad contacted the first inner copper layer and 300 mm 2 cooling areas on the top layer and bottom layers ( $70 \mu \mathrm{~m}$ ).

General Product Characteristics

### 4.4 Current Consumption

## Table 4 Current Consumption

Current consumption values are specified at $T_{\mathrm{j}}=25^{\circ} \mathrm{C}, V_{\mathrm{S}}=13.5 \mathrm{~V}$, all outputs open (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  |  | Min. | Typ. | Max. |  |  |

## SBC Normal Mode

| Normal Mode current <br> consumption | $I_{\text {Normal }}$ | - | 3.5 | 6.5 | mA | $V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ;$ <br> $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ;$ <br> $\mathrm{VCCL}, \mathrm{CAN}=\mathrm{Off}$ | P_4.4.1 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

## SBC Stop Mode

| Stop Mode current consumption | $I_{\text {Stop_ } 1,25}$ | - | 44 | 55 | $\mu \mathrm{A}$ | ${ }^{1)}$ VCC2 \& $\mathrm{CAN}^{2)}=\mathrm{Off}$, Cyclic Wake/Sense \& Watchdog = Off; no load on VCC1; I_PEAK_TH = '0' | P_4.4.2 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Stop Mode current consumption | $I_{\text {Stop_ } 1,85}$ | - | 50 | 72 | $\mu \mathrm{A}$ | ${ }^{1 / 3)} T_{\mathrm{j}}=85^{\circ} \mathrm{C}$; <br> VCC2 \& CAN $^{2)}=$ Off; <br>  <br> Watchdog = Off; <br> no load on VCC1; <br> I_PEAK_TH = '0' | P_4.4.3 |
| Stop Mode current consumption (high active peak threshold) | $I_{\text {Stop_ } \_2,25}$ | - | 65 | 72 | $\mu \mathrm{A}$ | ${ }^{1)}$ VCC2 \& CAN ${ }^{2)}=$ Off; Cyclic Wake/Sense \& Watchdog = Off; no load on VCC1; <br> I_PEAK_TH = ' 1 ' | P_4.4.4 |
| Stop Mode current consumption (high active peak threshold) | $I_{\text {Stop_2,85 }}$ | - | 70 | 92 | $\mu \mathrm{A}$ | ${ }^{1) 3} \mathrm{~T}_{\mathrm{j}}=85^{\circ} \mathrm{C}$; <br> VCC2 \& $\mathrm{CAN}^{2)}=$ Off; <br>  <br> Watchdog = Off; <br> no load on VCC1; <br> I_PEAK_TH = '1' | P_4.4.5 |

## SBC Sleep Mode

| Sleep Mode current consumption | $I_{\text {sleep, } 25}$ | - | 15 | 25 | $\mu \mathrm{A}$ | VCC2 \& CAN $^{2)}=$ Off; Cyclic Wake/Sense = Off | P_4.4.6 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Sleep Mode current consumption | $I_{\text {Sleep, } 85}$ | - | 25 | 35 | $\mu \mathrm{A}$ | ${ }^{3)} T_{\mathrm{j}}=85^{\circ} \mathrm{C} \text {; }$ <br> VCC2 \& CAN ${ }^{2)}=$ Off; <br> Cyclic Wake/Sense = Off | P_4.4.7 |

General Product Characteristics

Table 4 Current Consumption (cont'd)
Current consumption values are specified at $T_{\mathrm{j}}=25^{\circ} \mathrm{C}, V_{\mathrm{S}}=13.5 \mathrm{~V}$, all outputs open (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Feature Incremental Current Consumption |  |  |  |  |  |  |  |
| Current consumption for CAN module, recessive state | $I_{\text {CAN,rec }}$ | - | 2 | 3 | mA | ${ }^{33}$ SBC Normal/Stop Mode; CAN Normal Mode; VCC2 connected to VCAN; VTXDCAN = VCC2; no RL on CAN | P_4.4.8 |
| Current consumption for CAN module, dominant state | $I_{\text {CAN,dom }}$ | - | 3 | 5 | mA | ${ }^{3}$ SBC Normal/Stop Mode; CAN Normal Mode; VCC1 connected to VCAN; VTXDCAN = GND; no RL on CAN | P_4.4.9 |
| Current consumption for CAN module, Receive Only Mode | $I_{\text {CAN,RcvOnly }}$ | - | 0.9 | 1.2 | mA | ${ }^{3 / 4}$ SBC Normal/Stop Mode; CAN Receive Only Mode; VCC1 connected to VCAN; VTXDCAN = VCC1; no RL on CAN | P_4.4.10 |
| Current consumption during CAN Partial Networking frame detect mode ( RX_WK_S $^{\prime}$ SEL = '0') | $I_{\text {CAN,SWK,25 }}$ | - | 360 | 470 | $\mu \mathrm{A}$ | ${ }^{3) 5)} T_{\mathrm{j}}=25^{\circ} \mathrm{C} ;$ <br> SBC Stop Mode; WK, VCC2 = Off; CAN SWK Wake Capable, SWK Receiver enabled, WUF detect; no RL on CAN; | P_4.4.11 |
| Current consumption during CAN Partial Networking frame detect mode (RX_WK_SEL = '0') | $I_{\text {CAN,SWK,85 }}$ | - | 390 | 500 | $\mu \mathrm{A}$ | ${ }^{3) 5)} T_{\mathrm{j}}=85^{\circ} \mathrm{C}$; SBC Stop Mode; WK, VCC2 = Off; CAN SWK Wake Capable, SWK Receiver enabled, WUF detect; no RL on CAN; | P_4.4.12 |
| Current consumption for WK, GPIO wake capability (all wake inputs) | $I_{\text {Wake,WK,25 }}$ | - | 0.2 | 2 | $\mu \mathrm{A}$ | ${ }^{516) 77}$ SBC Sleep Mode; WK wake capable; no activity on WK pin; CAN $=$ Off; VCC2 $=0$ ff | P_4.4.13 |

General Product Characteristics

Table 4 Current Consumption (cont'd)
Current consumption values are specified at $T_{\mathrm{j}}=25^{\circ} \mathrm{C}, V_{\mathrm{S}}=13.5 \mathrm{~V}$, all outputs open (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Current consumption for WK, GPIO wake capability (all wake inputs) | $I_{\text {Wake,WK,85 }}$ | - | 0.5 | 3 | $\mu \mathrm{A}$ | ${ }^{3 / 5) 6677}$ SBC Sleep Mode; $T_{\mathrm{j}}=85^{\circ} \mathrm{C} ;$ <br> WK wake capable; no activity on WK pin; CAN $=$ Off; VCC2 $=0$ ff | P_4.4.14 |
| Current consumption for CAN wake capability (tsilence expired) | $I_{\text {Wake,CAN,25 }}$ | - | 4.5 | 6 | $\mu \mathrm{A}$ | ${ }^{2) 5}$ SBC Sleep Mode; CAN Wake Capable; WK = Off; VCC2 = Off; | P_4.4.15 |
| Current consumption for CAN wake capability (tsilence expired) | $I_{\text {Wake,CAN,85 }}$ | - | 5.5 | 7 | $\mu \mathrm{A}$ | ${ }^{23315)}$ SBC Sleep Mode; $T_{\mathrm{j}}=85^{\circ} \mathrm{C} ;$ <br> CAN Wake Capable; WK = Off; VCC2 = Off; | P_4.4.16 |
| VCC2 Normal Mode current consumption | $I_{\text {Normal, VcC2 }}$ | - | 2.5 | 3.5 | mA | $\begin{aligned} & V_{\mathrm{S}}=5.5 \mathrm{~V} \text { to } 28 \mathrm{~V} ; \\ & T_{\mathrm{j}}=-40^{\circ} \mathrm{C} \text { to }+150^{\circ} \mathrm{C} ; \\ & \mathrm{VCC} 2=\mathrm{On} \text { (no load) } \end{aligned}$ | P_4.4.17 |
| Current consumption for VCC2 in SBC Sleep Mode | $I_{\text {Sleep,VCC2,25 }}$ | - | 25 | 35 | $\mu \mathrm{A}$ | ${ }^{155)}$ SBC Sleep Mode; <br> VCC2 = On (no load); <br> CAN, WK = Off | P_4.4.18 |
| Current consumption for VCC2 in SBC Sleep Mode | $I_{\text {Sleep,VCC2,85 }}$ | - | 30 | 40 | $\mu \mathrm{A}$ | ${ }^{1335)}$ SBC Sleep Mode; $T_{\mathrm{j}}=85^{\circ} \mathrm{C} ; \mathrm{VCC} 2=\mathrm{On}$ <br> (no load); CAN, WK = Off | P_4.4.19 |
| Current consumption for GPIO if configured as lowside / high-side in SBC Stop Mode | $I_{\text {Stop,GPIO,25 }}$ | - | 400 | 550 | $\mu \mathrm{A}$ | ${ }^{315)}$ SBC Stop Mode; GPIO configured as HS or LS with $100 \%$ duty cycle (no load); CAN, WK = Off | P_4.4.20 |
| Current consumption for GPIO if configured as lowside / high-side in SBC Stop Mode | $I_{\text {Stop,GPIO,85 }}$ | - | 450 | 600 | $\mu \mathrm{A}$ | ${ }^{315)}$ SBC Stop Mode; $T_{\mathrm{j}}=85^{\circ} \mathrm{C}$ <br> GPIO configured as HS or LS with $100 \%$ duty cycle (no load); CAN, WK = Off | P_4.4.21 |
| Current consumption for Cyclic Sense function | $I_{\text {Stop,Cs25 }}$ | - | 20 | 26 | $\mu \mathrm{A}$ | ${ }^{58899}$ SBC Stop Mode; WD = Off; | P_4.4.22 |
| Current consumption for Cyclic Sense function | $I_{\text {Stop,Cs85 }}$ | - | 24 | 35 | $\mu \mathrm{A}$ | ${ }^{315) 8(9)}$ SBC Stop Mode; $\begin{aligned} & T_{\mathrm{j}}=85^{\circ} \mathrm{C} ; \\ & \mathrm{WD}=\text { Off; } \end{aligned}$ | P_4.4.23 |

## General Product Characteristics

## Table 4 Current Consumption (cont'd)

Current consumption values are specified at $T_{\mathrm{j}}=25^{\circ} \mathrm{C}, V_{\mathrm{S}}=13.5 \mathrm{~V}$, all outputs open (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Current consumption for watchdog active in Stop Mode | $I_{\text {Stop,WD25 }}$ | - | 20 | 26 | $\mu \mathrm{A}$ | ${ }^{3)}$ SBC Stop Mode; Watchdog running; | P_4.4.24 |
| Current consumption for watchdog active in Stop Mode | $I_{\text {Stop,WD85 }}$ | - | 24 | 35 | $\mu \mathrm{A}$ | ${ }^{3)}$ SBC Stop Mode; $T_{\mathrm{j}}=85^{\circ} \mathrm{C} ;$ <br> Watchdog running; | P_4.4.25 |

1) If the load current on VCC1 exceeds the configured VCC1 active peak threshold $\mathbf{I}_{\text {vcci,lpeaki,r }}$ or $I_{\text {VCc1,Ipeak2,r }}$, the current consumption will increase by typ. 2.9 mA to ensure optimum dynamic load behavior. Same applies to VCC2. See also Chapter 6, Chapter 7.
2) CAN not configured in selective wake mode.
3) Not subject to production test, specified by design.
4) Current consumption adder also applies for WUF detection (frame detect mode) when CAN Partial Networking is activated.
5) Current consumption adders of the features defined for SBC Stop Mode also apply for SBC Sleep Mode and vice versa. The wake input signals are stable (i.e. not toggling), Cyclic Wake/Sense \& watchdog are Off (unless otherwise specified).
6) No pull-up or pull-down configuration selected.
7) The specified WK current consumption adder for wake capability applies regardless of how many WK inputs are activated, i.e GPIO configured as wake input.
8) GPIO configured as HS used for Cyclic Sense, Timer with 20 ms period, 0.1 ms on-time, no load on GPIO.

In general the current consumption adder for Cyclic Sense in SBC Stop Mode can be calculated with below equation (no load on FO/GPIO):
IStop,CS_typ $=18 \mu \mathrm{~A}+\left(\mathbf{I}_{\text {stop,GPIO,25 }} \times\right.$ ton/TPer $)$
where 18 uA is the base current consumption of the digital Cyclic Sense / wake-up functionality;
9) Also applies to Cyclic Wake but without the contribution of the HS biasing

## Notes

1. There is no additional current consumption in SBC Normal Mode due to PWM generators or Timers.
2. To ensure the device functionality down to $V_{\text {por, } f}$ the quiescent current will increase gradually by $\sim 35$ uA for $V_{S}$ < 9 V in SBC Stop Mode and Sleep Mode..

## System Features

## 5 System Features

This chapter describes the system features and behavior of the TLE9461-3ES V33:

- State machine
- Device configuration
- SBC mode control
- State of supplies and peripherals
- System functions such as Cyclic Sense or Cyclic Wake
- Charge pump output for reverse polarity protection and Kl. 30 load switching
- High-voltage measurement interface

The System Basis Chip (SBC) offers six operating modes:

- SBC Init Mode: Power-up of the device (initial and after a soft reset),
- SBC Normal Mode: The main operating mode of the device,
- SBC Stop Mode: The first-level power saving mode (the main voltage regulator VCC1 remains enabled),
- SBC Sleep Mode: The second-level power saving mode (VCC1 is disabled),
- SBC Restart Mode: An intermediate mode after a wake-up event from SBC Sleep or Fail-Safe Mode or after a failure (e.g. WD failure, VCC1 under voltage reset) to bring the microcontroller into a defined state via a reset. Once the failure condition is not present anymore the device will automatically change to SBC Normal Mode after a delay time ( $\mathrm{t}_{\mathrm{RD} 1}$ or $\mathrm{t}_{\mathrm{RD} 2}$ ).
- SBC Fail-Safe Mode: A safe-state mode after critical failures (e.g. WD failure, VCC1 under voltage reset) to bring the system into a safe state and to ensure a proper restart of the system later on. VCC1 is disabled. It is a permanent state until either a wake-up event (via CAN, WK/VSENSE or GPIO configured as wake-up) occurs or the over temperature condition is not present anymore.

A special mode, called SBC Development Mode, is available during software development or debugging of the system. All above mentioned operating modes can be accessed in this mode. However, the watchdog counter is stopped and does not need to be triggered. In addition, CAN is set to normal mode and VCC2 is On. This mode can be accessed by connecting the TEST pin to VCC1 during SBC Init Mode.
The device can be configured via hardware to determine the device behavior after a watchdog trigger failure.
See Chapter 5.1.1 for further information.
The System Basis Chip is controlled via a 16-bit SPI interface. A detailed description can be found in Chapter 13. The device configuration as well as the diagnosis is handled via the SPI. The SPI mapping of the TLE9461-3ES V33 is compatible to other devices of the TLE926x and TLE927x families.
The device offers various supervision features to support functional safety requirements. Please see Chapter $\mathbf{1 2}$ for more information.

System Features

### 5.1 Block Description of State Machine

The different SBC operating modes are selected via SPI by setting the respective SBC MODE bits in the register M_S_CTRL. The SBC MODE bits are cleared when going through SBC Restart Mode and thus always show the current SBC mode.


Figure 3 State Diagram showing the SBC Operating Modes including CAN Partial Networking

System Features

### 5.1.1 Device Configuration and SBC Init Mode

The device starts up in SBC Init Mode after crossing the power-on reset threshold $\mathbf{V}_{\text {POR, }}$ (see also Chapter 12.3) and the watchdog starts with a long open window ( $\mathbf{t}_{\mathrm{Lw}}$ ) after RSTN is released (High level). During this power-on phase the following configurations are stored in the device:

- The device behavior regarding a watchdog trigger failure and a VCC1 over voltage condition is determined by the external circuit on the INTN pin (typ. $47 \mathrm{k} \Omega$ pull-up resistor to VCC1, see also below)
- The selection of the normal user mode operation or the SBC Development Mode (watchdog = Off, CAN = On, VCC2 = On for debugging purposes) is set depending on the voltage level of the TEST pin (see also Chapter 5.1.7).


### 5.1.1.1 Device Configuration

The configuration selection selects the SBC behavior due to a watchdog trigger failure and VCC1 overvoltage detection. Depending on the requirements of the application, two different configurations can be chosen: - If the VCC1 output shall be switched Off and the device shall go to SBC Fail-Safe Mode in case of a watchdog failure ( 1 or 2 fails). To set this configuration (Config 2/4), the INTN pin does not need an external pull-up resistor.

- If VCC1 should not be switched Off (Config $1 / 3$ ), the INTN pin needs to have an external pull-up resistor connected to VCC1 (see application diagram in Chapter 14).

Figure 4 shows the timing diagram of the hardware configuration selection. The hardware configuration is defined during SBC Init Mode. The INTN pin is internally pulled Low with a weak pull-down resistor during the reset delay time $\mathbf{t}_{\text {RD1 }}$, i.e. after VCC1 crosses the reset threshold VRT1 and before the RSTN pin goes High. The INTN pin is monitored during this time (with a continuous filter time of $\mathbf{t}_{\text {CFG_F }}$ ) and the configuration (depending on the voltage level at INTN) is stored at the rising edge of RSTN.

Note: If the POR bit is not cleared, then the internal pull-down resistor at INTN is reactivated every time RSTN is pulled Low the configuration is updated at the rising edge of RSTN. Therefore it is recommended to clear the POR bit right after initialization. In case there is no stable signal at INTN, then the last filtered value is taken. If no filtered value is taken then the default value '0' is taken as the config select value (= SBC Fail-Safe Mode).

Note: $\quad$ During device power up, the SPI status bits VCC1_ WARN, VCC1_UV and VS_UV are updated only if RSTN is released after the reset delay time.


Figure 4 Hardware Configuration Selection Timing Diagram

There are four different device configurations (Table 5) available defining the watchdog failure and the VCC1 over voltage behavior. The configurations can be selected via the external connection on the INTN pin and the SPI bit CFG1 in the HW_CTRL_0 register (see also Chapter 13.4):

- CFGO_STATE = ' 1 ': Config 1 and Config 3:
- A watchdog trigger failure leads to SBC Restart Mode and depending on CFG1 the Fail Output (FO) is activated after the 1st (Config 1) or 2nd (Config 3) watchdog trigger failure;
- A VCC1 over voltage detection leads to SBC Restart Mode if VCC1_OV_RST is set. VCC1_OV is set and the Fail Output is activated;
- CFGO_STATE = '0': Config 2 and Config 4:
- A watchdog trigger failure leads to SBC Fail-Safe Mode and depending on CFG1 the Fail Output (FO) is activated after the 1st (Config 2) or 2nd (Config 4) watchdog trigger failure. The first watchdog trigger failure in Config 4 leads to SBC Restart Mode;
- A VCC1 over voltage detection leads to SBC Fail-Safe Mode if VCC1_OV_RST is set. VCC1_OV is set and the Fail Output is activated;
The respective device configuration can be identified by reading the SPI bit CFG1 in the HW_CTRL_0 register and the CFGO_STATE bit in the WK_LVL_STAT register.
Table 5 shows the configurations and the device behavior in case of a watchdog trigger failure:

Table 5 Watchdog Trigger Failure Configuration

| Config | INTN Pin <br> (CFG0_STATE) | SPI Bit <br> CFG1 | Event | FO Activation | SBC Mode Entry |
| :--- | :--- | :--- | :--- | :--- | :--- |
| 1 | External pull-up | 1 | $1 \times$ Watchdog Failure | after 1st WD Failure | SBC Restart Mode |
| 2 | No ext. pull-up | 1 | $1 \times$ Watchdog Failure | after 1st WD Failure | SBC Fail-Safe Mode |
| 3 | External pull-up | 0 | $1 \& 2 \times$ Watchdog <br> Failure | after 2nd WD Failure | SBC Restart Mode |
| 4 | No ext. pull-up | 0 | $2 \times$ Watchdog Failure | after 2nd WD Failure | SBC Fail-Safe Mode ${ }^{1)}$ |

1) SBC Restart Mode is entered after the 1. watchdog failure. The 2nd watchdog failure leads to SBC Fail-Safe Mode

Table 6 shows the configurations and the device behavior in case of a VCC1 over voltage detection when VCC1_OV_RST is set:

Table 6 Device Behavior in Case of VCC1 Over Voltage Detection

| Config | INTN Pin <br> (CFG0_STATE) | CFG1 <br> Bit | VCC1_0 <br> V_RST | Event | VCC1_ <br> OV | FO Activation | SBC Mode Entry |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| $1-4$ | any value | x | 0 | $1 \times$ VCC1 OV | 1 | no FO activation | unchanged |
| 1 | External pull- <br> up | 1 | 1 | $1 \times$ VCC1 OV | 1 | after 1st VCC1 OV | SBC Restart Mode |
| 2 | No ext. pull-up | 1 | 1 | $1 \times$ VCC1 OV | 1 | after 1st VCC1 OV | SBC Fail-Safe Mode |
| 3 | External pull- <br> up | 0 | 1 | $1 \times$ VCC1 OV | 1 | after 1st VCC1 OV | SBC Restart Mode |
| 4 | No ext. pull-up | 0 | 1 | $1 \times$ VCC1 OV | 1 | after 1st VCC1 OV | SBC Fail-Safe Mode |

The respective configuration is stored for all conditions and can only be changed in SBC Init Mode, when RSTN is 'Low' or by powering down the device (VS $<\mathbf{V}_{\text {POR,f }}$ ) assuming the bit POR is cleared right after the device power up (see also not on Page 21).

System Features

### 5.1.1.2 SBC Init Mode

In SBC Init Mode, the device waits for the microcontroller to finish its startup and initialization sequence.
The SBC starts with a long open watchdog window (see also Chapter 12.2).
All diagnosis functions which are enabled by default at device power-up are active.

While in SBC Init Mode any valid SPI command (from the SPI protocol, i.e. 16-bit or 32-bit word) sets the device to SBC Normal Mode, i.e. any register can be written, cleared and read. During the long open window the watchdog has to be triggered (i.e. thereby the watchdog is automatically configured).
A missing watchdog trigger during the long open window will cause a watchdog failure and the device will enter SBC Restart Mode.
Wake-up events are ignored during SBC Init Mode.
A SBC Soft Reset command (MODE = '11') sets the SBC back into SBC Init Mode and the SPI registers are changed to their respective Soft Reset values. In case one or both lock bits are set (CFG_LOCK_0 or CFG_LOCK_1) the locked bits keep their previous values and stay unchanged.

| Note: | Any SPI command sets the SBC to SBC Normal Mode even if it is an illegal SPI command (see Chapter 13.2). |
| :---: | :---: |
| Note: | For a safe start-up, it is recommended to use the first SPI command to trigger and to configure the watchdog (see Chapter 12.2). |
| Note: | At power up, the SPI bit VCC1_UV is not set nor is the FO triggered as long as VCC1 is below the $V_{R T, x}$ threshold and VS is below the $V_{s, U v}$ threshold. The RSTN pin is kept Low as long as VCC1 is below the selected $V_{R T, x}$ threshold and the reset delay time is not expired. After the first threshold crossing (VCC1 > Vrt1,r) and the RSTN transition from Low to High, all subsequent undervoltage events lead to SBC Restart Mode. |

Note: $\quad$ The bit VS_UV is updated only in SBC INIT Mode once RSTN resumes a high level.

System Features

### 5.1.2 SBC Normal Mode

The SBC Normal Mode is the standard operating mode for the SBC. All remaining configurations must be done in SBC Normal Mode before entering a low-power mode (see also Chapter 5.1.6). A wake-up event on CAN, WK/VSENSE, FO/GPIO configured as wake input, the Timer will create an interrupt on pin INTN - however, no change of the SBC mode will occur. The configuration options are listed below:

- VCC1 is always active
- VCC2 can be switched On or Off (default = Off)
- CAN is configurable (it is Off coming from SBC Init Mode; Off or Wake Capable coming from SBC Restart Mode, see also Chapter 5.1.5)
- WK/VSENSE pin shows the input level and can be selected to be wake capable (interrupt), the alternative measurement function with the voltage output at FO/GPIO can be activated by setting WK_MEAS
- Cyclic Sense can be configured with the HS function of the GPIO (GPIO = ‘ 011 '), WK/VSENSE input and Timer
- Cyclic Wake can be configured using the timer
- Watchdog period is configurable
- The Charge Pump Output can be switched On or Off (default = Off)
- The FO/GPIO output is inactive by default. Coming from SBC Restart Mode and configured as FO it can be active (due to a failure event, e.g. watchdog trigger failure, VCC1 short circuit, etc.) or inactive (no failure occurred)
- GPIO is configurable and is controlled by PWM; GPIO is Off coming from SBC Restart Mode

Certain SPI control bits with the bit type 'rwl' can be protected against unintentional modification by setting the CFG_LOCK_1 bit in the register HW_CTRL_2. The locking mechanism stays activated until the device is powered down ( $V S<\mathbf{V}_{\text {POR,f }}$ ). The charge pump and GPIO configuration can also be locked by setting the CFG_LOCK_0 bit in the register HW_CTRL_1. The lock can be reset in SBC Normal Mode.
In SBC Normal Mode, the FO output can be tested within the system (i.e. to verify whether setting the FO/GPIO pin to Low creates the intended behavior). The FO output can be enabled and then disabled again by the microcontroller setting or resetting the FO_ON SPI bit. This feature is only intended for testing purposes.

System Features

### 5.1.3 SBC Stop Mode

The SBC Stop Mode is the first level technique to reduce the overall current consumption by setting the voltage regulators VCC1, VCC2 into a low-power mode. In this mode VCC1 is still active, supplying the microcontroller, which can enter a power-down mode. The VCC2 supply can be configured to stay enabled and CAN to stay in Normal Mode. All settings have to be done before entering SBC Stop Mode. In SBC Stop Mode all SPI WRITE commands are ignored and the SPI_FAIL bit is set. Exceptions are changing to SBC Normal Mode, triggering a SBC Soft Reset, refreshing the watchdog as well as reading and clearing the SPI status registers. A wake-up event on CAN, WK/VSENSE, FO/GPIO (if configured as wake input) and Timer create an interrupt on pin INTN - however, the SBC mode remains unchanged. The configuration options are listed below:

- VCC1 is always On
- VCC2 is fixed as configured in SBC Normal Mode
- CAN mode is fixed as configured in SBC Normal Mode
- WK/VSENSE pin is fixed as configured in SBC Normal Mode
- Cyclic Sense is fixed as configured in SBC Normal Mode
- Cyclic Wake is fixed as configured in SBC Normal Mode
- Watchdog is fixed as configured in SBC Normal Mode
- SBC Soft Reset can be triggered
- The Charge Pump state is fixed as configured in SBC Normal Mode
- FO output works as configured in SBC Normal Mode unless it is changed by the software (i.e. by clearing the FAILURE bit and triggering the watchdog properly)
- GPIO is fixed as configured in SBC Normal Mode

If not all wake source signalization flags from WK_STAT_0 and WK_STAT_1 are cleared before entering SBC Stop Mode, then an interrupt is triggered on the pin INTN.

Note: If outputs are kept enabled during SBC Stop Mode, e.g. HS of GPIO, then the SBC current consumption increases respectively (see Chapter 4.4).

Note: It is not possible to switch directly from SBC Stop Mode to SBC Sleep Mode. Doing so sets the SPI_FAIL flag and SBC into Restart Mode is entered.

Note: $\quad$ When WK/VSENSE and FO/GPIO are configured for the alternative measurement function (WK_MEAS = 1) the pins cannot be selected as wake input sources.

System Features

### 5.1.4 SBC Sleep Mode

The SBC Sleep Mode is the second level technique to reduce the overall current consumption to a minimum needed to react on wake-up events or for the SBC to perform autonomous actions (e.g. Cyclic Sense). In this mode, VCC1 is Off, not supplying the microcontroller anymore. The VCC2 supply can be configured to stay enabled. The settings have to be done before entering SBC Sleep Mode. A wake-up event on CAN, WK/VSENSE, FO/GPIO (if configured as wake input) and the internal Timer brings the device via the SBC Restart Mode subsequently to SBC Normal Mode again and signals the wake source.
The configuration options are listed below:

- VCC1 is always Off
- VCC2 is fixed as configured in SBC Normal Mode
- CAN mode changes automatically from On or Receive Only Mode to Wake Capable mode or can be selected to be Off
- WK/VSENSE pin is fixed as configured in SBC Normal Mode
- Cyclic Sense is fixed as configured in SBC Normal Mode
- Cyclic Wake is fixed as configured in SBC Normal Mode, it can be the only activated wake source
- Watchdog is Off
- The Charge Pump state is fixed as configured in SBC Normal Mode
- FO output is fixed as configured in SBC Normal Mode is maintained
- GPIO is fixed as configured in SBC Normal Mode, it can be the only wake source if configured as WK/VSENSE
- RSTN is pulled low
- SPI communication and all digital I/Os are disabled because VCC1 is Off
- The Sleep Mode entry is signalled in the SPI register DEV_STAT with the bit DEV_STAT

It is not possible to switch Off all wake sources in SBC Sleep Mode. Doing so sets the SPI_FAIL flag and the device enters SBC Restart Mode.
In order to enter SBC Sleep Mode successfully, all wake source signalization flags from WK_STAT_0 and WK_STAT_1 need to be cleared. A failure to do so results in an immediate wake-up from SBC Sleep Mode by going via SBC Restart to Normal Mode.
All settings must be done before entering SBC Sleep Mode.
Note: If outputs are kept enabled during SBC Sleep Mode, e.g. HS of GPIO, then the SBC current consumption increases respectively (see Chapter 4.4).

Note: $\quad$ The Cyclic Sense function might not work properly anymore in case of a failure event (e.g. overcurrent, over temperature, reset) because the configured HS of the GPIO and Timer might be disabled.

Note: When WK/VSENSE and FO/GPIO are configured for the alternative measurement function (WK_MEAS = 1) then the pins cannot be selected as wake input sources.

## System Features

### 5.1.5 SBC Restart Mode

There are multiple reasons to enter the SBC Restart Mode. The main purpose of the SBC Restart Mode is to reset the microcontroller:

- in case of under voltage at VCC1 in SBC Normal and SBC Stop Mode and SBC Init Mode after RSTN has been released,
- in case of over voltage at VCC1 (if the bit VCC1_OV_RST is set and if CFGO_STATE = ' 1 '),
- due to 1 st incorrect Watchdog triggering (only if Config1, Config3 or Config 4 is selected, otherwise SBC Fail-Safe Mode is immediately entered),
- In case of a wake event from SBC Sleep or Fail-Safe Mode or a release of over temperature shutdown (TSD2) out of SBC Fail-Safe Mode (this transition is used to ramp up VCC1 in a defined way).
From SBC Restart Mode, the device enters automatically to SBC Normal Mode. The SBC MODE bits are cleared. As shown in Figure 37 the Reset Output (RSTN) is pulled Low when entering Restart Mode and is released (going High) at the transition to SBC Normal Mode after the reset delay time ( $\mathbf{t}_{\mathrm{RD1}}$ ). The watchdog timer starts with a long open window starting from the moment of the rising edge of RSTN. The watchdog period settings in the register WD_CTRL are changed to the respective default value ' 100 '.
Leaving the SBC Restart Mode does not result in changing / deactivating the Fail Output.
The behavior of the blocks is listed below:
- FO (if configured as FO) is activated in case of a 1st watchdog trigger failure (Config1) or a 2nd watchdog failure (Config3) or in case of VCC1 over voltage detection (if VCC1_OV_RST is set)
- VCC1 stays On or is ramping up (coming from SBC Sleep or Fail-Safe Mode)
- VCC2 is disabled if it was activated before
- CAN is "woken" due to a wake-up event or Off depending on the previous SBC and transceiver mode (see also Chapter 8). It is Wake Capable when it was in CAN Normal-, Receive Only or Wake Capable mode before SBC Restart Mode
- GPIO behavior: switched Off if configured as LS- or HS-switch, see also Chapter 11.1.2
- RSTN is internally pulled Low during SBC Restart Mode
- SPI communication is ignored by the SBC, i.e. it is not interpreted
- The SBC Restart Mode entry is signalled in the SPI register DEV_STAT with the bits DEV_STAT

Table 7 Reasons for Restart - State of SPI Status Bits (after Return to SBC Normal Mode)

| Prev. SBC Mode | Event | DEV_STAT | WD_FAIL | VCC1_UV | VCC1_OV | VCC1_SC |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Normal | $1 x$ Watchdog Failure | 01 | 01 | x | x | x |
| Normal | $2 x$ Watchdog Failure | 01 | 10 | x | x | x |
| Normal | VCC1 under voltage reset | 01 | xx | 1 | x | x |
| Normal | VCC1 over voltage reset | 01 | xx | x | 1 | x |
| Stop | 1 x Watchdog Failure | 01 | 01 | x | x | x |
| Stop | $2 x$ Watchdog Failure | 01 | 10 | x | x | x |
| Stop | VCC1 under voltage reset | 01 | xx | 1 | x | x |
| Stop | VCC1 over voltage reset | 01 | xx | x | 1 | x |
| Sleep | Wake-up event | 10 | xx | x | x | x |
| Fail-Safe | Wake-up event | 01 | see "Reasons for Fail Safe, Table 8" |  |  |  |

## System Features

Note: $\quad$ An over voltage event at VCC1 leads to SBC Restart Mode only if the bit VCC1_OV_RST is set and if CFGO_STATE = '1'(Config 1/3).

Note: $\quad$ The content of the WD_FAIL bits depends on the device configuration, e.g. 1 or 2 watchdog failures.

### 5.1.6 SBC Fail-Safe Mode

The purpose of this mode is to bring the system in a safe status after a failure condition by turning Off the VCC1 supply and powering Off the microcontroller. After a wake-up event the system restarts again.
The Fail-Safe Mode is automatically entered after following events:

- SBC thermal shutdown (TSD2) (see also Chapter 12.8.3),
- over voltage on VCC1 if the bit VCC1_OV_RST is set and if CFGO_STATE = ' 0 ',
- 1st incorrect watchdog trigger in Config2 (CFG1 = 1) and after a 2nd incorrect watchdog trigger in Config4 (CFG1 = 0) (see also Chapter 5.1.1),
- VCC1 is shorted to GND (see also Chapter 12.6),

In this case, the default wake sources CAN, WK/VSENSE and FO/GPIO (if configured as wake input - see also registers BUS_CTRL_0, WK_CTRL_1 and GPIO_CTRL) are activated, the previous wake-up events are cleared in the register WK_STAT_0 and WK_STAT_1, and both voltage regulators and the GPIO - if configured as HS or LS - are switched Off.
The SBC Fail-Safe Mode is entered regardless of the FO/GPIO pin configuration. If WK/VSENSE and FO/GPIO are configured for the alternative measurement function (WK_MEAS =1) then these pins keep their configuration for the measurement function when SBC Fail-Safe Mode is entered, i.e. they are not automatically activated as wake sources.

The SBC Fail-Safe Mode is maintained until a wake-up event on the default wake sources occurs. To avoid any fast toggling behavior a filter time of typ. $100 \mathrm{~ms}\left(\mathbf{t}_{\mathrm{Fs}, \boldsymbol{\operatorname { m i n }}}\right)$ is implemented. Wake-up events during this time is stored and automatically lead to SBC Restart Mode after the filter time.
In case of a VCC1 over temperature shutdown (TSD2), the SBC Restart Mode is entered automatically after a filter time of typ. 1s ( $\mathbf{t}_{\text {TSD2 }}$ ) (without the need of a wake-up event) once the device temperature has fallen below the TSD2 threshold. Please see Chapter $\mathbf{1 2 . 8 . 3}$ on how to extend the minimum TSD2 waiting time. Leaving the SBC Fail-Safe Mode does not result in a deactivation of the Fail Output pins.

The following functions are controlled by the C Fail-Safe Mode:

- FO output (if configured as FO) is activated (see also Chapter 11)
- VCC1 is switched Off
- VCC2 is switched Off
- CAN is set to Wake Capable
- GPIO behavior:
- if configured as HS or LS: it is switched Off
- if configured as wake input: it is set to wake capable in Static Sense mode
- WK/VSENSE pin is set to wake capable in Static Sense mode (only if WK_MEAS = 0)
- Cyclic Sense and Cyclic Wake is disabled
- SPI communication is disabled because VCC1 is Off, RSTN and digital I/O pins are pulled Low
- The Fail-Safe Mode activation is signalled in the SPI register DEV_STAT with the bits FAILURE and DEV_STAT

System Features

Table 8 Reasons for Fail-Safe - State of SPI Status Bits after Return to Normal Mode

| Prev. SBC <br> Mode | Failure Event | DEV_ <br> STAT | TSD2 | WD_ <br> FAIL | VCC1_ <br> UV | VCC1_ <br> OV | VCC1_ <br> SC |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Normal | $1 \times$ Watchdog Failure | 01 | x | 01 | x | x | x |
| Normal | $2 \times$ Watchdog Failure | 01 | x | 10 | x | x | x |
| Normal | TSD2 | 01 | 1 | xx | x | x | x |
| Normal | VCC1 short to GND | 01 | x | xx | 1 | x | 1 |
| Normal | VCC1 over voltage | 01 | x | xx | x | 1 | x |
| Stop | $1 \times$ Watchdog Failure | 01 | x | 01 | x | x | x |
| Stop | $2 \times$ Watchdog Failure | 01 | x | 10 | x | x | x |
| Stop | TSD2 | 01 | 1 | xx | x | x | x |
| Stop | VCC1 short to GND | 01 | x | xx | 1 | x | 1 |
| Stop | VCC1 over voltage | 01 | x | xx | x | 1 | x |

Note: $\quad$ An over voltage event on VCC1 leads to SBC Fail-Safe Mode only if the bit VCC1_OV_RST is set and if CFGO_STATE = '0' (Config 2/4).

Note: $\quad$ The content of the WD_FAIL bits depends on the device configuration, e.g. 1 or 2 watchdog failures.

### 5.1.7 SBC Development Mode

The SBC Development Mode is used during the development phase of the module. It is especially useful for software development.

Compared to the default SBC user mode operation, this mode is a super set of the state machine. The device starts also in SBC Init Mode and it is possible to use all the SBC Modes and functions with the following differences:

- Watchdog is stopped and does not need to be triggered. Therefore no reset is triggered due to watchdog failure
- SBC Fail-Safe and SBC Restart Mode are not activated by a watchdog trigger failure (but the other reasons to enter these modes are still valid)
- CAN and VCC2 default values in SBC Init Mode and if entering SBC Normal Mode from SBC Init Mode is On (instead of Off)
The SBC Development Mode is entered automatically, if the TEST pin is set High (i.e. connected to VCC1 with (3.3V level) during SBC Init Mode. The voltage level monitoring is started as soon as VS $>\mathbf{V}_{\text {Por,r }}$ and VCC1 $>$ $\mathbf{V}_{\mathbf{R T 1} 1, \mathrm{r}}$. The SBC Development Mode is set and maintained, if SBC Init Mode is left by sending any SPI command while TEST is High. The bit SBC_DEV_LVL shows the status of the SBC Development Mode.
The Test pin has an integrated pull-down resistor, $\mathrm{R}_{\text {TEST }}$ (switched On only during SBC Init Mode), to prevent an unintentional SBC Development Mode entry (see also Figure 5).

Note: $\quad$ The integrated pull-down resistor is disabled only, if the SBC Development Mode has been entered successfully, i.e. not when the SBC Init Mode is left with an error (watchdog failure, VCC1 undervoltage reset, etc).
During normal user mode, the integrated pull-down resistor is always activated. In this case the TEST pin can be left open or connect to GND

## System Features

Note: In case a VCC2 overtemperature event occurs in SBC Init Mode., after SBC Development Mode is entered, VCC2 is shut down.


Figure 5 Block Diagram of Pin TEST for SBC Development Mode Detection

In case the pin level toggles with a period faster than $t_{\text {TEST }}$ during the monitoring period the SBC Development Mode is not reached.

The SBC remains in this mode for all operating conditions and can only be left by powering down the device (VS < V POR,f $^{\text {f }}$ ).

Note: If the SBC enters SBC Fail-Safe Mode due to VCC1 shorted to GND during the SBC Init Mode, the SBC Development is not entered and can only be activated at the next power-up of the SBC (after the VCC1 short circuit is removed).

Note: $\quad$ The absolute maximum ratings of the pin TEST must be observed. To increase the robustness of this pin during debugging or programming a series resistor between TEST and the connector can be added (see Figure 53).

## System Features

### 5.1.8 Electrical Characteristics for Pin TEST

## Table 9 Electrical Characteristics ${ }^{1)}$

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | $\begin{array}{l}\text { Note or } \\ \text { Test Condition }\end{array}$ | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | Min. | Typ. | Max. |  |  |  |$)$

1) The external capacitance on the TEST pin must be limited to less than 10 nF to ensure proper detection of SBC Development Mode and SBC User Mode operation.
2) Not subject to production test, specified by design.
3) Not subject to production test, tolerance defined by internal oscillator tolerance.

System Features

## $5.2 \quad$ Wake Features

The following wake sources are implemented in the device:

- Static Sense: WK/VSENSE input and/or GPIO WK input are permanently active as a wake source, i.e WK_EN is set and/or FO/GPIO is enabled as wake input (see Chapter 9.2 .2 \& Chapter 11.1.3)
- Cyclic Sense: WK/VSENSE input only active during On-time of Cyclic Sense period. Internal timer is activating GPIO HS during On-time for sensing the WK/VSENSE input (see Chapter 5.2.1)
- Cyclic Wake: wake-up is controlled by internal timer, wake inputs are not used for Cyclic Wake (see Chapter 5.2.2)
- CAN wake: Wake-up via CAN message, i.e. CAN wake-up pattern (WUP, see also Chapter 8) or CAN wakeup frame (WUF, see also Chapter 5.6)


### 5.2.1 Cyclic Sense

The Cyclic Sense feature is intended to reduce the quiescent current of the device and the application. In the Cyclic Sense configuration, the GPIO (configured as high-side driver) is switched On periodically, controlled by TIMER_CTRL. The high-side switch supplies external circuitries e.g. switches and/or resistor arrays, which are connected to the wake input WK (see Figure 6). Any edge change of the WK/VSENSE input signal during the On-time of the Cyclic Sense period causes a wake-up. Depending on the SBC mode, either the INTN is pulled Low (SBC Normal Mode and Stop Mode) or the SBC is woken enabling the VCC1 (after SBC Sleep Mode).


Figure 6 Cyclic Sense Working Principle

System Features

### 5.2.1.1 Configuration and Operation of Cyclic Sense

The correct sequence to configure the Cyclic Sense is shown in Figure 7. All the configurations have to be performed before the On-time is set in the TIMER_CTRL registers.
Cyclic Sense (=Timer) starts as soon as the respective On-time has been selected independently from the assignment of the HS and the filter configuration.

The correct configuration sequence is as follows:

- Configuring GPIO as HS with Cyclic Sense functionality
- Enabling WK/VSENSE as wake source
- Selecting the pull-up/down configuration, all configurations are valid for Cyclic Sense, recommended is the automatic pull-up / down selection
- Configuring the timer period and On-time


Figure 7 Cyclic Sense: Configuration and Sequence

Note: If the sequence is not ensured the Cyclic Sense function might not work properly, e.g. an interrupt could be missed or an unintentional interrupt could be triggered. However, if Cyclic Sense is the only wake source and configured properly (e.g. Timer not yet set), then SBC Restart Mode is entered immediately because no valid wake source was set.

Note: $\quad$ All configurations of period and On-time can be selected. However, recommended On-times for Cyclic Sense are $0.1 \mathrm{~ms}, 0.3 \mathrm{~ms}$ and 1 ms for quiescent current saving reasons. The SPI_FAIL is set ifthe On-time is longer than the period.

Note: $\quad$ A learning cycle is started every time when the timer is started via the On-time and GPIO is configured as HS with Cyclic Sense = '011 (i.e. the Cyclic Sense function is enabled).

System Features

The first sample of the WK/VSENSE input value (High or Low) is used as the reference for the next cycle. If a change of the WK/VSENSE input level is detected during the On-time of the second or later cycle then a wakeup from SBC Sleep Mode or an interrupt during SBC Normal or SBC Stop Mode is triggered.
A filter time of $16 \mu$ s is implemented to avoid a parasitic wake-up due to transients or EMI disturbances. The filter time $\mathbf{t}_{\text {FWK1 }}$ is triggered right at the end of the selected On-time and a wake signal is recognized if:

- there was an input level change (crossing the switching threshold level $\mathbf{V}_{\text {wkth }}$ ) between the current and previous cycle and
- the input level did not change during the filter time

A wake-up event due to Cyclic Sense also sets the bit WK_WU.
During Cyclic Sense, WK_LVL_STAT is updated only with the sampled voltage levels of the WK/VSENSE pin in SBC Normal or SBC Stop Mode.

Note: In SBC Stop Mode the respective bits WK_WU and WK_LVL are only updated if the timer On-time is configured for TIMER_ON = '001'.

The functionality of the sampling and different scenarios are depicted in Figure 8 to Figure 10. The behavior in SBC Stop and SBC Sleep Mode is identical except that in SBC Normal and Stop Mode INTN is triggered to signal a change of WK/VSENSE input level and in SBC Sleep Mode, VCC1 will power-up instead. A wake-up event is triggered regardless if the bit WK_WU is already set.


Figure $8 \quad$ Cyclic Sense Timing

Lite CAN SBC Family
System Features


Figure 9 Cyclic Sense Example Timing for SBC Stop Mode, HS starts Low, GND based WK/VSENSE input


Figure 10 Cyclic Sense Example Timing for SBC Sleep Mode, HS starts with On, GND based WK/VSENSE input

## System Features

The Cyclic Sense function is disabled at the following conditions (WK/VSENSE is automatically switched to Static Sense):

- in case SBC Fail-Safe Mode is entered: The HS GPIO switch is disabled and the wake pin is changed to static sensing. An unintended wake-up event could be triggered when the WK/VSENSE input is changed to static sensing.
- In SBC Normal, Stop, or Sleep Mode in case of an overcurrent or overtemperature (TSD2) event: the HS GPIO switch is disabled

Note: $\quad$ The internal timer for Cyclic Sense is not cleared automatically in case the HS switch is turned Offdue to above mentioned failures. The timer is only cleared during SBC Restart Mode. This must be considered to avoid a loss of wake-up events, especially before entering SBC Sleep Mode, i.e. the software must ensure that at least another wake source is active or re-enable the GPIO HS again.

### 5.2.1.2 Cyclic Sense in Low-Power Mode

If Cyclic Sense is intended for use in SBC Stop or SBC Sleep Mode, it is necessary to activate Cyclic Sense in SBC Normal Mode before going to the low-power mode. A wake-up event due to Cyclic Sense sets the bit WK_WU. In SBC Stop Mode a wake-up event triggers an interrupt, in SBC Sleep Mode the wake-up event moves the device via SBC Restart Mode to SBC Normal Mode.
Before returning to SBC Sleep Mode, the wake status registers WK_STAT_0 and WK_STAT_1 need to be cleared. Trying to go to SBC Sleep Mode with uncleared wake flags leads to a direct wake-up from Sleep Mode by going via Restart Mode to Normal Mode and triggering of RSTN.
The intention of this behavior is to prevent a loss of a wake-up event during the transition.
Note: if an over-current shutdown occurs at the GPIO HS in SBC Sleep Mode, while configured as Cyclic Sense, and Cyclic Sense is the only wake source, then the SBC leaves SBC Sleep Mode immediately because there is no other wake source available .

### 5.2.2 Cyclic Wake

The Cyclic Wake feature is intended to reduce the quiescent current of the device in the application. The internal timer wakes the load, e.g. the microcontroller, periodically while it is in a low-power mode for the most of the time.

For the Cyclic Wake feature the timer is configured as an internal wake-up source and periodically triggers an interrupt on INTN in SBC Normal and SBC Stop Mode. During SBC Sleep Mode, the timer periodically wakes the device (via SBC Restart to SBC Normal Mode).
The correct sequence to configure the Cyclic Wake is shown in Figure 11. The sequence is as follows:

- Enable Timer as a wake-up source in the register WK_CTRL_0,
- Configure the period of the Timer. Also an On-time (any value except ' 000 ' or ' 110 ' or ' 111 ') must be selected to start the Cyclic Wake function.


## Cyclic Wake Configuration



No interrupt will be generated, if the timer is not enabled as a wake source

Periods: $10 \mathrm{~ms}, 20 \mathrm{~ms}, 50 \mathrm{~ms}, 100 \mathrm{~ms}, 200 \mathrm{~ms} 500 \mathrm{~ms}$, $1 \mathrm{~s}, 2 \mathrm{~s}, 5 \mathrm{~s}, 10 \mathrm{~s}, 20 \mathrm{~s}, 50 \mathrm{~ms}, 100 \mathrm{~s}, 200 \mathrm{~s}, 500 \mathrm{~s}, 1000 \mathrm{~s}$

On-times: any except '000' or '110' '111'

A new timer configuration will become active immediately, i.e. as soon as CSN goes high

Figure 11 Cyclic Wake: Configuration and Sequence

As in Cyclic Sense, the Cyclic Wake function starts as soon as the On-time is configured. An interrupt is generated for every start of the On-time except for the very first time when the timer is started.

### 5.2.3 Internal Timer

The integrated timer can be used to control the below features:

- Cyclic Wake, i.e. to wake-up the microcontroller periodically in SBC Normal, Stop and Sleep Mode
- Cyclic Sense, i.e. to perform cyclic sensing using the wake input WK/VSENSE and the GPIO configured as HS by mapping the timer accordingly via the GPIO_CTRL register.

Following periods and On-times can be selected via the register TIMER_CTRL respectively:

- Period: $10 \mathrm{~ms}, 20 \mathrm{~ms}, 50 \mathrm{~ms}, 100 \mathrm{~ms}, 200 \mathrm{~ms}, 500 \mathrm{~ms}, 1 \mathrm{~s}, 2 \mathrm{~s}, 5 \mathrm{~s}, 10 \mathrm{~s}, 20 \mathrm{~s}, 50 \mathrm{~s}, 100 \mathrm{~s}, 200 \mathrm{~s}, 500 \mathrm{~s}, 1000 \mathrm{~s}$
- On-time: $0.1 \mathrm{~ms} / 0.3 \mathrm{~ms} / 1.0 \mathrm{~ms} / 10 \mathrm{~ms} / 20 \mathrm{~ms} / \mathrm{Off}$ at High or Low

Note: $\quad$ It is also possible to activate Cyclic Sense and Cyclic Wake at the same time with the same timer setting

System Features

### 5.3 Charge Pump Output for Reverse Polarity Protection

A gate-driver (charge-pump output) is integrated in the TLE9461-3ES V33 to drive external n-channel logiclevel MOSFETs on-board to provide Reverse Polarity Protection in the application or to control a KL. 30 switch (see Figure 12). The gate voltage is provided at the pin VCP which should be connected as shown in Chapter 14.
The Charge Pump is able to drive up to 3 n -channel MOSFETs with a typ. Ron of $5 \mathrm{~m} \Omega$.

A spread spectrum modulation feature is implemented for improved EMC behavior. Enabling and configuring the spread spectrum modulation frequency is achieved via the SPI bits SS_MOD_FR.


Figure 12 Simplified Charge Pump Block

The charge pump output VCP is disabled in SBC Init Mode and can be configured in SBC Normal Mode via the SPI bit CP_EN. To prevent an unintentional modification of the charge pump state the bit CP_EN can be locked by setting the bit CFG_LOCK_0. In case the charge pump output must be disabled again then it is necessary to clear CFG_LOCK_0 before.
The Charge Pump will also stay enabled in the SBC Stop, Sleep, Restart or Fail-Safe Mode if it was not disabled before entering the respective mode. It does not switch-Off due to overvoltage.
Diagnosis is available by checking the bit CP_EN.

## System Features

### 5.3.1 Electrical Characteristics for Charge Pump

## Table 10 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Charge Pump Output Voltage | $V_{\text {CP_1 }}$ | $V_{S}+4.5$ | - | $V_{\text {S }}+6.5$ | V | $\begin{aligned} & { }^{1)} V_{\mathrm{S}}=5.5 \mathrm{~V} ; \\ & I_{\mathrm{CP}}=-40 \mathrm{uA} ; \\ & C_{\mathrm{L}}=3.3 \mathrm{nF} \end{aligned}$ | P_5.3.1 |
| Charge Pump Output Voltage | $V_{\text {CP_2 }}$ | $V_{S}+9.5$ | - | $V_{s}+14$ | V | $\begin{aligned} & { }^{122)} V_{\mathrm{S}}=10 \mathrm{~V} ; \\ & I_{\mathrm{CP}}=-100 \mathrm{uA} ; \\ & C_{\mathrm{L}}=3.3 \mathrm{nF} \end{aligned}$ | P_5.3.2 |
| Charge Pump Output Voltage | $V_{\text {CP_3 }}$ | $V_{\text {S }}+10$ | - | $v_{\text {s }}+16$ | v | $\begin{aligned} & { }^{1)} V_{S} \geq 13.5 \mathrm{~V} ; \\ & I_{\mathrm{CP}}=-200 \mathrm{uA} ; \\ & C_{\mathrm{L}}=3.3 \mathrm{nF} \end{aligned}$ | P_5.3.3 |
| Maximum Charge Pump Output Current | $I_{\text {CP }}$ | 200 | - | 1200 | $\mu \mathrm{A}$ | $\begin{aligned} & { }^{122)} V_{\mathrm{CP}}=V_{\mathrm{S}}+10 \mathrm{~V} ; \\ & V_{\mathrm{S}} \geq 13.5 \mathrm{~V} ; \\ & C_{\mathrm{L}}=3.3 \mathrm{nF} \end{aligned}$ | P_5.3.4 |
| Charge Pump Leakage Current | ${ }_{\text {CP,LK }}$ | - | 0.5 | 2 | $\mu \mathrm{A}$ | $\begin{aligned} & { }^{2)} V_{\mathrm{CP}}=0 \mathrm{~V}=\mathrm{Off} ; \\ & V_{\mathrm{S}}=13.5 \mathrm{~V} \end{aligned}$ | P_5.3.5 |
| Charge Pump Enabling Time | $t_{\text {CP_ON }}$ | - | 95 | 200 | $\mu \mathrm{s}$ | $\begin{aligned} & { }^{122)} \mathrm{CSN}=\text { High to } \\ & V_{\mathrm{CP}}>V_{\mathrm{S}}+10 \mathrm{~V} ; \\ & V_{\mathrm{S}}=13.5 \mathrm{~V}, \\ & C_{\mathrm{L}}=3.3 \mathrm{nF} \end{aligned}$ | P_5.3.6 |
| Charge Pump Disabling Time | $t_{\text {CP_off }}$ | - | 45 | 65 | $\mu \mathrm{S}$ | $\begin{aligned} & { }^{122)} \mathrm{CSN}=\text { High to } \\ & V_{\mathrm{CP}}<V_{\mathrm{S}}+2 \mathrm{~V} ; \\ & V_{\mathrm{S}}=13.5 \mathrm{~V} ; \\ & C_{\mathrm{L}}=3.3 \mathrm{nF} \end{aligned}$ | P_5.3.7 |

1) Applies for the default frequency setting. See also SPI bits 2MHZ_FREQ
2) Not subject to production test, specified by design.

## System Features

### 5.4 High-Voltage Measurement Interface

### 5.4.1 Block Description

This function provides the possibility to measure a voltage, e.g. the unbuffered battery voltage, with the protected WK/VSENSE HV-input. The measured voltage is routed out at FO/GPIO in case it is not configured as FO.
A simple external voltage divider needs to be placed to provide the appropriate voltage level to the microcontroller A/D converter input. For power-saving reasons, the function is available only in SBC Normal Mode and it is disabled in all other SBC modes.
The benefit of the function is that the signal is measured by a HV-input pin and that there is no current flowing through the resistor divider during low-power modes.
The functionality is shown in a simplified application diagram in Figure 52.

### 5.4.2 Functional Description

This measurement function is by default disabled. In this case, WK/VSENSE and FO/GPIO have their default functionality. The switch S_MEAS is open for this configuration (see Figure 52), i.e. there is no connection between the pins. The measurement function can be enabled via the SPI bit WK_MEAS. If WK_MEAS is set to ' 1 ', then the measurement function is enabled and the switch S_MEAS is closed in SBC Normal Mode. S_MEAS is open in all other SBC modes. In this function the pull-up and pull-down currents of WK/VSENSE and FO/GPIO are disabled and the internal WK/VSENSE and FO/GPIO signals are gated. In addition, the settings for WK/VSENSE and FO/GPIO in the registers WK_PUPD_CTRL, WK_CTRL_1 and GPIO_CTRL are ignored but changing these setting is not prevented. The registers WK_STAT_0, WK_STAT_1 and WK_LVL_STAT are not updated with respect to the inputs WK/VSENSE and FO/GPIO. However, if only WK/VSENSE or GPIO WK are set as wake sources and a SBC Sleep Mode command is set, then the SPI_FAIL flag is set and the SBC changes into SBC Restart Mode (see Chapter 5.1 also for wake capability of WK/VSENSE and GPIO WK).
If WK_MEAS is set then neither the FO (including the FO test via FO_ON) nor the GPIO functionality or wake functionality is available. Trying to change the GPIO_CTRL configurations will set the SPI_FAIL.
If FO/GPIO is configured as FO or any other GPIO configuration, then WK_MEAS cannot be set and SPI_FAIL is triggered, i.e. FO/GPIO must be first set Off initially.

Table 11 Differences between Normal WK Function and Measurement Function

| Affected Settings/Modules <br> for WK/VSENSE and <br> FO/GPIO Inputs | WK_MEAS = 0 | WK_MEAS = 1 |
| :--- | :--- | :--- |
| S_MEAS configuration | 'open' | 'closed' in SBC Normal Mode, <br> 'open' in all other SBC Modes but <br> configuration is kept |
|  <br> FO/GPIO signal processing | Default wake and level signaling <br> function, <br> WK_STAT_0, WK_STAT_1 and <br> WK_LVL_STAT are updated <br> accordingly | WK/VSENSE and FO/GPIO signals are <br> gated internally, WK_STAT_0, <br> WK_STAT_1 and WK_LVL_STAT are <br> not updated |

## System Features

Table 11 Differences between Normal WK Function and Measurement Function (cont'd)

| Affected Settings/Modules <br> for WK/VSENSE and <br> FO/GPIO Inputs | WK_MEAS = 0 | WK_MEAS = 1 |
| :--- | :--- | :--- |
| WK_EN, GPIO configured as <br> WK | Wake-up via WK/VSENSE and GPIO <br> WK possible | Setting the wake enable bits is <br> ignored, i.e. the measurement <br> function has priority but the bits can <br> be set. <br> If only WK_EN and/or GPIO as WK are <br> set while trying to go to SBC Sleep <br> Mode, then the SPI_FAIL flag is set <br> and the SBC changes into SBC Restart <br> Mode |
| SBC Fail-Safe Mode behavior | WK/VSENSE is automatically <br> activated as wake source; <br> see Table 29 for GPIO behavior | Measurement function configuration <br> is kept, switch S_MEAS is open |
| normal configuration is possible | no pull-up or pull-down enabled |  |
| WO_PUPD_CTRL | FO functionality is available if <br> configured accordingly | FO functionality is not available. <br> FO/GPIO must be set to Off before <br> setting WK_MEAS. Otherwise the <br> SPI_FAIL flag is set. |

Note: $\quad$ There is a diode in series to the switch S_MEAS (not shown in the Figure 52), which influences the temperature behavior of the switch. See also Figure 13. Lite CAN SBC Family

## System Features

### 5.4.3 Electrical Characteristics for Measurement Interface

## Table 12 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Input leakage current | $I_{\text {WK_MEAS_LK }}$ | -2 |  | 2 | $\mu \mathrm{A}$ | $\begin{aligned} & 0 V<V_{\text {WK_IN }}< \\ & V S+0.3 V \end{aligned}$ <br> Same parameter as P_10.3.5; | P_5.4.1 |
| Drop Voltage across S_MEAS switch between WK/VSENSE and FO/GPIO when enabled for voltage measurement; | $V_{\text {Drop,__MEAS }}$ | 40 | 160 | 250 | mV | $\begin{aligned} & { }^{11)} 4 \mathrm{~V}<V_{\text {WK_IN }}< \\ & \text { VS }+0.3 \mathrm{~V} ; \\ & I_{\text {WK1 }}=200 \mu \mathrm{~A} ; \\ & T_{\mathrm{j}}=25^{\circ} \mathrm{C} \\ & \text { Refer to Figure } 13 \end{aligned}$ | P_5.4.2 |

1) Not subject to production test; specified by design


Figure 13 Typical Drop Voltage Characteristics of switch S_MEAS (between WK/VSENSE \& FO/GPIO)

System Features

### 5.5 Spread Spectrum Modulation Frequency Function

The spread spectrum modulation frequency function can be used to reduce electromagnetic emissions for the charge pump.
The spread spectrum function can be enabled and configured by the bits SS_MOD_FR.
The spread spectrum function is derived from the internal 2 MHz oscillator ( $\sim 0.5 \mu \mathrm{~s}$ period). The calculations below are applied to the 2.0 MHz setting ( $\mathbf{2 M H Z}$ _FREQ = ' 001 ' (for all the other frequencies the values can be derived).
There is a counter adjusting the oscillator step values up and down. There is a maximum of 32 steps for the counter available. For the frequency range $\mathbf{2 M H Z}$ _FREQ = ' $0 x x$ ' we can choose following modulation frequencies:

Table 13 Deriving the Modulation Frequency Steps

| Setting | Periods $/$ Step Width | Typ. Resulting Period | Typ. Modulation Frequency |
| :--- | :--- | :--- | :--- |
| SS_MOD_FR = ' 11 ' | $0.5 \mathrm{us} / 1$ period of 0.5 us | 16 us | $1 / 16 \mathrm{us}=62.5 \mathrm{kHz}$ |
| SS_MOD_FR = '10' | $1.0 \mathrm{us} / 2$ periods of 0.5 us | 32 us | $1 / 32 \mathrm{us}=31.25 \mathrm{kHz}$ |
| SS_MOD_FR = '01' | $2.0 \mathrm{us} / 4$ periods of 0.5 us | 64 us | $1 / 64 \mathrm{us}=15.625 \mathrm{kHz}$ |

### 5.6 Partial Networking on CAN

### 5.6.1 CAN Partial Networking - Selective Wake Feature

The CAN Partial Networking (= Selective Wake) feature can be activated for SBC Normal Mode, in SBC Sleep Mode and in SBC Stop Mode. In SBC Sleep Mode the Partial Networking has to be activated before sending the SBC to Sleep Mode. For SBC Stop Mode the Partial Networking has to be activated before going to SBC Stop Mode.
There are 2 detection mechanisms available:

- WUP (Wake-Up Pattern) this is a CAN wake, that reacts on the CAN dominant time, with 2 dominant signals as defined in ISO WG11898-2:2016.
- WUF (Wake-Up frame) this is the wake-up on a CAN frame that matches the programmed message filter configured in the SBC via SPI.
The default baudrate is set to 500 kBaud . Besides the commonly used baudrates of 125 kB aud and 250 kBaud , other baudrates up to 1MBaud can be selected (see Chapter 13 for more details).


### 5.6.2 SBC Partial Networking Function

The CAN Partial Networking Modes are shown in this figure.


Figure 14 CAN Selective Wake State Diagram

### 5.6.2.1 Activation of SWK

Below figure shows the principal of the SWK activation.


Figure 15 Flow for activation of SWK

### 5.6.2.2 Wake-up Pattern (WUP)

A WUP is signaled on the bus by two consecutive dominant bus levels for at least $\mathrm{t}_{\text {Wake1 }}$, separated by a recessive bus level.


Figure 16 WUP detection following the definition of ISO 11898-2:2016

### 5.6.2.3 Wake-up Frame (WUF)

The wake-up frame is defined in ISO 11898-2:2016.
Only CAN frames according ISO11989-1 are considered as potential wake-up frames.
A bus wake-up shall be performed, if selective wake-up function is enabled and a "valid WUF" has been received. The transceiver may ignore up to four consecutive CAN data frames that start after switching on the bias.
A received frame is a "valid WUF" in case all of the following conditions are met:

- The ID of the received frame is exactly matching a configured ID in the relevant bit positions. The relevant bit positions are given by an ID mask. The ID and the ID mask might have either 11 bits or 29 bits.
- The DLC of the received frame is exactly matching the configured DLC.
- In case DLC is greater than 0 , the data field of the received frame has at least one bit set in a bit position, where also in the configured data mask in the corresponding bit position the bit is set.
- No error exists according to ISO 11898-1 except errors which are signalled in the ACK field and EOF field.


### 5.6.2.4 CAN Protocol Error Counter

The counter is incremented, when a bit stuffing, CRC or form error according to ISO11898-1 is detected. If a frame has been received that is valid up to the end of the CRC field and the counter is not zero, the counter is decremented.
If the counter has reached a value of 31 , the following actions is performed on the next increment of this counter:

- The selective wake function is disabled,
- The CAN transceiver is woken,
- SYSERR is set and the error counter value $=32$ can be read.

By each increment or decrement of the counter the decoder unit waits for at least 6 and at the most 10 recessive bits before considering a dominant bit as new start of a frame.
The error counter is enabled:

- whenever the CAN is in Normal Mode, Receive Only Mode or in WUF detection state.

The error counter is cleared under the following conditions:

- At the transition from WUF detection to WUP detection 1 (after $\mathbf{t}_{\text {sILENCE }}$ expiration, while SWK is correctly enabled)
- When WUF detection state is entered (in this way the counter starts from 0 when SWK is enabled)
- At CAN rearming (when exiting the woken state)
- When the CAN Mode bits are selected '000', ' 100 ' (CAN Off) or ' 001 ' (Wake Capable without SWK function enabled)
- While CAN_FD_EN = ' 1 ' and DIS_ERR_CNT = ' 1 '
(the counter is cleared and stays cleared when these two bits are set in the SPI registers)
The Error Counter is frozen:
- after a wake-up being in woken state

The counter value can be read out of the bits ECNT.

### 5.6.3 Diagnoses Flags

### 5.6.3.1 PWRON/RESET-FLAG

The power-on reset can be detected and read by the POR bit in the SBC Status register.
The VS power on resets all registers in the SBC to the reset value. SWK is not configured.

### 5.6.3.2 BUSERR-Flag

Bus Dominant Time-out detection is implemented and signaled by CAN_Fail_x in the register BUS_STAT.

### 5.6.3.3 TXD Dominant Time-out flag

TXD Dominant timeout is shown in the SPI bit CAN_FAIL_x in the register BUS_STAT.

### 5.6.3.4 WUP Flag

The WUP bit in the SWK_STAT register shows that a Wake-Up Pattern (WUP) has caused a wake-up of the CAN transceiver. It can also indicate an internal mode change from WUP detection 1 state to WUF detection after a valid WUP.
In the following case the bit is set:

- SWK is activated: due to $t_{\text {SILENCE }}$, the CAN changes into the state WUP detection 1 . If a WUP is detected in this state, then the WUP bit is set
- SWK is deactivated: the WUP bit is set if a WUP wakes up the CAN. In addition, the CAN_WU bit is set.
- in case WUP is detected during WUP detection 2 state (after a SYSERR) the bits WUP and CAN_WU are set The WUP bit is cleared automatically by the SBC at the next rearming of the CAN transceiver.

Note: It is possible that WUF and WUP bits are set at the same time, if a WUF causes a wake-up out of SWK, by setting the interrupt or by restarting out of SBC Sleep Mode. The reason is because the CAN has been in WUP detection 1 state during the time of SWK mode (because of $t_{\text {SILENCE }}$ ). See also Figure 14.

### 5.6.3.5 WUF Flag (WUF)

The WUF bit in the SWK_STAT register shows that a wake-up-Up frame (WUF) has caused a wake-up of the CAN block. In SBC Sleep Mode this wake-up causes a transition to SBC Restart Mode, in SBC Normal Mode and in SBC Stop Mode it causes an interrupt. Also in case of this wake-up the bit CAN_WU in the register WK_STAT_0 is set.

The WUF bit is cleared automatically by the SBC at the next rearming of the CAN SWK function.

### 5.6.3.6 SYSERR Flag (SYSERR)

The bit SYSERR is set in case of a configuration error and in case of an error counter overflow. The bit is only updated (set to ' 1 ') if a CAN mode with SWK is enabled via CAN_x. If INT_ GLOBAL is set, then an interrupt is triggered on INTN every time SYSERR is set.
When programming selective wake via CAN_x, SYSERR = ' 0 ' signals that the SWK function has been enabled. The bit can be cleared via SPI. The bit is ' 0 ' after Power-on Reset of the SBC.

### 5.6.3.7 Configuration Error

A configuration error sets the SYSERR bit to ' 1 '. A configuration check is performed when enabling SWK via the bits CAN_x. If the check is successful SWK is enabled, the bit SYSERR is set to ' 0 '. In SBC Normal Mode it is also possible to detect a Configuration Error while SWK is enabled. This occurs if the CFG_VAL bit is cleared, e.g. by changing the SWK registers (from address 0100001 to address 0110011 ). In SBC Sleep Mode this is not possible as the SWK registers can not be changed. However, in SBC Stop Mode the CFG_VAL bit is also cleared while trying to modify any SWK register.
Configuration Check:
in SBC Restart Mode, the CFG_VAL bit is cleared by the SBC. If the SBC Restart Mode was not triggered by a WUF wake-up from SBC Sleep Mode and the CAN was with SWK enabled, than the SYSERR bit is set.
The SYSERR bit has to be cleared by the microcontroller.
The SYSERR bit cannot be cleared when CAN_2 is ' 1 ' and below conditions occur:

- Data valid bit not set by microcontroller, i.e. CFG_VAL is not set to ' 1 '. The CFG_VAL bit is reset after SWK wake and needs to be set by the microcontroller before activation SWK again.
- CFG_VAL bit reset by the SBC when data are changed via SPI programming. (Only possible in SBC Normal Mode)

Note: $\quad$ The SWK configuration is still valid if only the SWK_CTRL register is modified.

### 5.6.3.8 CAN Bus Timeout-Flag (CANTO)

In CAN WUF detection and CAN WUP detection 2 state the bit CANTO is set to ' 1 ' if the time $\mathrm{t}_{\text {SILENCE }}$ expires. The bit can be cleared by the microcontroller. If the interrupt function for CANTO is enabled then an interrupt is generated in SBC Stop or SBC Normal Mode when the CANTO is set to ' 1 '. The interrupt is enabled by setting the bit CANTO_ MASK to ' 1 '. Each CANTO event triggers an interrupt even if the CANTO bit is not cleared.
There is no wake-up out of SBC Sleep Mode because of CAN time-out.

### 5.6.3.9 CAN Bus Silence-Flag (CANSIL)

In CAN WUF detection and CAN WUP detection 2 state the bit CANSIL is set to ' 1 ' if the time $\mathrm{t}_{\text {SILENCE }}$ expires. The CANSIL bit is set back to ' 0 ' with a WUP. With this bit the microcontroller can monitor if there is activity on the CAN bus while being in SWK Mode. The bit can be read in SBC Stop and SBC Normal Mode.

### 5.6.3.10 SYNC-FLAG (SYNC)

The bit SYNC shows that SWK is working and is synchronous to the CAN bus. To get a SYNC bit set it is required to enable the CAN in CAN Normal or in Receive Only Mode or in WUF detection. It is not required to enable the CAN SWK Mode.
The bit is set to ' 1 ' if a valid CAN frame has been received (no CRC error and no stuffing error). It is set back to ' 0 ' if a CAN protocol error is detected. When switching into SWK mode the SYNC bit indicates to the microcontroller that the frame detection is running and the next CAN frame can be detected as a WUF, CAN wake-up can now be handled by the SBC. It is possible to enter a SBC low-power mode with SWK even if the bit is not set to ' 1 ', as this is necessary in case of a silent bus.

### 5.6.3.11 SWK_SET FLAG (SWK_SET)

The SWK_SET bit is set to signalize the following states (see also Figure 14):

- when SWK was correctly enabled in WUF Detection state,
- when SWK was correctly enabled when in WUP Detection 1 state,
- after a SYSERR before a wake event in WUP Detection 2 state,

The bit is cleared under following conditions:

- after a wake-up (ECNT overflow, WUP in WUP detection 2, WUF in WUF detection)
- if CAN_2 is cleared


### 5.6.4 SBC Modes for Selective Wake (SWK)

The SBC mode is selected via the MODE bits as described in Chapter 5.1.
The mode of the CAN transceiver needs to be selected in SBC Normal Mode. The CAN mode is programed by the bits CAN_0, CAN_1 and CAN_2. In the low-power modes (SBC Stop, SBC Sleep) the CAN mode can not be changed via SPI.
The detailed SBC state machine diagram including the CAN selective wake feature is shown in Figure 3.
The application must now distinguish between the normal CAN operation an the selective wake function:

- WK Mode: This is the normal CAN Wake Capable mode without the selective wake function
- SWK Mode: This is the CAN Wake Capable mode with the selective wake function enabled

Figure 17 shows the possible CAN transceiver modes.


Figure 17 CAN SWK State Diagram

### 5.6.4.1 SBC Normal Mode with SWK

In SBC Normal Mode the CAN Transceiver can be switched into the following CAN Modes

- CAN Off
- CAN WK Mode (without SWK)
- CAN SWK Mode
- CAN Receive Only (No SWK activated)
- CAN Receive Only Mode with SWK
- CAN Normal Mode (No SWK activated)
- CAN Normal Mode with SWK

In the CAN Normal Mode with SWK the CAN Transceiver works as in SBC Normal Mode, so bus data is received through RXD, data is transmitted through TXD and sent to the bus. In addition the SWK block is active. It monitors the data on the CAN bus, updates the error counter and sets the CANSIL flag if there is no communication on the bus.
It generates a CAN Wake interrupt in case a WUF is detected (RXD is not pulled to low in this configuration).
In CAN Receive Only Mode with SWK, CAN data can be received on RXD and SWK is active, no data can be sent to the bus.
The bit SYSERR = ' 0 ' indicates that the SWK function is enabled, and no frame error counter overflow is detected.

Table 14 CAN Modes selected via SPI in SBC Normal Mode

| CAN Mode | CAN_2 | CAN_1 | CAN_0 |
| :--- | :--- | :--- | :--- |
| CAN Off | 0 | 0 | 0 |
| CAN WK Mode (no SWK) | 0 | 0 | 1 |
| CAN Receive Only (no SWK) | 0 | 1 | 0 |
| CAN Normal Mode (no SWK) | 0 | 1 | 1 |
| CAN Off | 1 | 0 | 0 |
| CAN SWK Mode | 1 | 0 | 1 |
| CAN Receive Only with SWK | 1 | 1 | 0 |
| CAN Normal Mode with SWK | 1 | 1 | 1 |

When reading back CAN_x the programmed mode is shown in SBC Normal Mode. To read the real CAN mode the bits SYSERR, SWK_SET and CAN have to be evaluated. A change out of SBC Normal Mode can change the CAN_0 and CAN_1 bits.

### 5.6.4.2 SBC Stop Mode with SWK

In SBC Stop Mode the CAN Transceiver can be operated with the following CAN Modes

- CAN Off
- CAN WK Mode (no SWK)
- CAN SWK Mode
- CAN Receive Only (no SWK)
- CAN Receive Only with SWK
- CAN Normal Mode (no SWK)
- CAN Normal Mode with SWK

To enable CAN SWK Mode the CAN has to be switched to "CAN Normal Mode with SWK", "CAN Receive Only Mode with SWK" or to "CAN SWK Mode" in SBC Normal Mode before sending the SBC to SBC Stop Mode. The bit SYSERR = ' 0 ' indicates that the SWK function is enabled. The table shows the change of CAN Mode when switching from SBC Normal Mode to SBC Stop Mode.

Note: $\quad$ CAN Receive Only Mode in SBC Stop Mode is implemented to also enable pretended networking (Partial networking done in the microcontroller).

Table 15 CAN Modes change when switching from SBC Normal Mode to SBC Stop Mode

| Programmed CAN Mode in SBC <br> Normal Mode | CAN_x <br> bits | SYSERR <br> bit | CAN Mode in SBC Stop Mode | CAN_x <br> bits |
| :--- | :--- | :--- | :--- | :--- |
| CAN Off | 000 | 0 | CAN Off | 000 |
| CAN WK Mode (no SWK) | 001 | 0 | CAN WK Mode (no SWK) | 001 |
| CAN Receive Only (no SWK) | 010 | 0 | CAN Receive Only (no SWK) | 010 |
| CAN Normal Mode (no SWK) | 011 | 0 | CAN Normal Mode (no SWK) | 011 |
| CAN Off | 100 | 0 | CAN Off | 100 |
| CAN SWK Mode | 101 | 0 | CAN SWK Mode | 101 |
| CAN SWK Mode | 101 | 1 | CAN WK Mode (no SWK) | 101 |
| CAN Receive Only with SWK | 110 | 0 | CAN Receive Only with SWK | 110 |
| CAN Receive Only with SWK | 110 | 1 | CAN Receive Only (no SWK) | 110 |
| CAN Normal Mode with SWK | 111 | 0 | CAN Normal Mode with SWK | 111 |
| CAN Normal Mode with SWK | 111 | 1 | CAN Normal Mode (no SWK) | 111 |

Note: $\quad$ When SYSERR is set then WUF frames will not be detected, i.e. the selective wake function is not activated (no SWK), but the MSB of CAN mode is not changed in the register.

### 5.6.4.3 SBC Sleep Mode with SWK

In SBC Sleep Mode the CAN Transceiver can be switched into the following CAN Modes

- CAN Off
- CAN WK Mode (without SWK)
- CAN SWK Mode

To enable "CAN SWK Mode" the CAN has to be switched to "CAN Normal Mode with SWK", "CAN Receive Only Mode with SWK" or to "CAN SWK Mode" in SBC Normal Mode before sending the device to SBC Sleep Mode. The table shows the change of CAN mode when switching from SBC Normal Mode to Sleep Mode.
A wake-up from Sleep Mode with Selective Wake (Valid WUF) leads to Restart Mode. In Restart Mode the CFG_VAL bit is cleared by the SBC, the SYSERR bit is not set. In the register CAN_x the programmed CAN SWK Mode (101) can be read.

To enable the CAN SWK Mode again and to enter SBC Sleep Mode the following sequence can be used: Program a CAN Mode different from CAN SWK Mode (101, 110, 111), set the CFG_VAL, CLEAR SYSERR bit, set CAN_x bits to CAN SWK Mode (101), switch SBC to Sleep Mode.

To enable the CAN WK Mode or CAN SWK Mode again after a wake-up on CAN a rearming is required for the CAN transceiver to be wake capable again. The rearming is done by programming the CAN into a different mode with the CAN_x bit and back into the CAN WK Mode or CAN SWK Mode. To avoid lock-up when switching the SBC into Sleep Mode with an already woken CAN transceiver, the SBC does an automatic rearming of the CAN transceiver when switching into Sleep Mode. So after switching into Sleep Mode the CAN transceiver is either in CAN SWK Mode or CAN WK Mode depending on CAN_x setting and SYSERR bit (If CAN is switched to Off Mode it is also Off in Sleep Mode).

Table 16 CAN Modes change when switching to SBC Sleep Mode

| Programmed CAN Mode in SBC <br> Normal Mode | CAN_x <br> bits | SYSERR <br> bit | CAN Mode in SBC Sleep Mode | CAN_x <br> bits |
| :--- | :--- | :--- | :--- | :--- |
| CAN Off | 000 | 0 | CAN Off | 000 |
| CAN WK Mode (no SWK) | 001 | 0 | CAN WK Mode (no SWK) | 001 |
| CAN Receive Only (no SWK) | 010 | 0 | CAN WK Mode (no SWK) | 001 |
| CAN Normal Mode (no SWK) | 011 | 0 | CAN WK Mode (no SWK) | 001 |
| CAN Off | 100 | 0 | CAN Off | 100 |
| CAN SWK Mode | 101 | 0 | CAN SWK Mode | 101 |
| CAN SWK Mode | 101 | 1 | CAN WK Mode (no SWK) | 101 |
| CAN Receive Only with SWK | 110 | 0 | CAN SWK Mode | 101 |
| CAN Receive Only with SWK | 110 | 1 | CAN WK Mode (no SWK) | 101 |
| CAN Normal Mode with SWK | 111 | 0 | CAN SWK Mode | 101 |
| CAN Normal Mode with SWK | 111 | 1 | CAN WK Mode (no SWK) | 101 |

### 5.6.4.4 SBC Restart Mode with SWK

If SBC Restart Mode is entered the transceiver can change the CAN mode. After a Restart the following modes are possible:

- CAN Off
- CAN WK Mode (either still Wake Cable or already woken up)
- CAN SWK Mode (WUF Wake from Sleep)

Table 17 CAN Modes change in case of Restart out of SBC Normal Mode

| Programmed CAN Mode in SBC <br> Normal Mode | CAN_x <br> bits | SYSERR <br> bit | CAN Mode in and after SBC <br> Restart Mode | CAN_x <br> bits | SYSERR <br> bit |
| :--- | :--- | :--- | :--- | :--- | :--- |
| CAN Off | 000 | 0 | CAN Off | 000 | 0 |
| CAN WK Mode (no SWK) | 001 | 0 | CAN WK Mode (no SWK) | 001 | 0 |
| CAN Receive Only (no SWK) | 010 | 0 | CAN WK Mode (no SWK) | 001 | 0 |
| CAN Normal Mode (no SWK) | 011 | 0 | CAN WK Mode (no SWK) | 001 | 0 |
| CAN Off | 100 | 0 | CAN Off | 100 | 0 |
| CAN SWK Mode | 101 | 0 | CAN WK Mode (no SWK) | 101 | 1 |
| CAN SWK Mode | 101 | 1 | CAN WK Mode (no SWK) | 101 | 1 |
| CAN Receive Only with SWK | 110 | 0 | CAN WK Mode (no SWK) | 101 | 1 |
| CAN Receive Only with SWK | 110 | 1 | CAN WK Mode (no SWK) | 101 | 1 |
| CAN Normal Mode with SWK | 111 | 0 | CAN WK Mode (no SWK) | 101 | 1 |
| CAN Normal Mode with SWK | 111 | 1 | CAN WK Mode (no SWK) | 101 | 1 |

The various reasons for entering SBC Restart Mode and the respective status flag settings are shown in Table 18.

Table 18 CAN Modes change in case of Restart out of SBC Sleep Mode

| CAN Mode in SBC Sleep Mode | CAN Mode in and after SBC Restart Mode | $\begin{aligned} & \mathrm{CAN}_{-} \\ & \mathrm{x} \end{aligned}$ | SYS <br> ERR | CAN <br> WU | WUP | WUF | $\begin{aligned} & \text { ECNT_ } \\ & \mathbf{x} \end{aligned}$ | Reason for Restart |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CAN Off | CAN Off | 000 | 0 | 0 | 0 | 0 | 0 | Wake-up on other wake source |
| CAN WK Mode | CAN woken up | 001 | 0 | 1 | 1 | 0 | 0 | Wake (WUP) on CAN |
| CAN WK Mode | CAN WK Mode | 001 | 0 | 0 | 0 | 0 | 0 | Wake-up on other wake source |
| CAN SWK Mode | CAN woken up | 101 | 0 | 1 | $0 / 1^{1)}$ | 1 | X | Wake (WUF) on CAN |
| CAN SWK Mode, | CAN woken up | 101 | 1 | 1 | $0 / 1^{2)}$ | 0 | 100000 | Wake-up due to error counter overflow |
| CAN SWK selected, CAN WK active | CAN woken up. | 101 | 1 | 1 | 1 | 0 | 0 | Wake (WUP) on CAN, config check was not pass |
| CAN SWK Mode | CAN WK Mode | 101 | 1 | 0 | 0/1 | 0 | x | Wake-up on other wake source |

1) In case there is a WUF detection within $\mathbf{t}_{\text {SILENCE }}$ then the WUP bit is not set. Otherwise it is always set together with the WUF bit.
2) In some cases the WUP bit might stay cleared even after $\boldsymbol{t}_{\text {SILENCE }}$, e.g. when the error counter expires without detecting a wake-up pattern.

### 5.6.4.5 SBC Fail-Safe Mode with SWK

When SBC Fail-Safe Mode is entered the CAN transceiver is automatically set into WK Mode (wake capable) without the selective wake function.

### 5.6.5 Wake-up

A wake-up via CAN leads to a restart out of SBC Sleep Mode and to an interrupt in SBC Normal Mode and in SBC Stop Mode. After the wake-up event the bit CAN_WU is set, and the details about the wake-up can be read out of the bits WUP, WUF, SYSERR, and ECNT.

### 5.6.6 Configuration for SWK

The CAN protocol handler settings can be configured in following registers:

- SWK_BTLO_CTRL defines the number of time quanta in a bit time. This number depends also on the internal clock settings performed in the register SWK_CDR_CTRL2;
- SWK_BTL1_CTRL defines the sampling point position;
- The respective receiver during frame detection mode can be selected via the bit RX_WK_SEL;
- The clock and data recovery (see also Chapter 5.6.8) can be configured in the registers SWK_CDR_CTRL1, SWK_CDR_CTRL2, SWK_CDR_LIMIT_HIGH_CTRL and SWK_CDR_LIMIT_LOW_CTRL;
The actual configuration for selective wake is done via the Selective Wake Control Registers SWK_IDx_CTRL, SWK_MASK_IDx_CTRL, SWK_DLC_CTRL, SWK_DATAx_CTRL.
The oscillator has the option to be trimmed by the microcontroller. To measure the oscillator, the SPI bit OSC_CAL needs to be set to 1 and a defined pulse needs to be given to the TXDCAN pin by the microcontroller (e.g. $1 \mu$ s pulse, CAN needs to be switched Off before). The SBC measures the length of the pulse by counting
the time with the integrated oscillator. The counter value can be read out of the register SWK_OSC_CAL_H_STATE and SWK_OSC_CAL_L_STATE. To change the oscillator the trimming function needs to be enabled by setting the bits TRIM_EN_x = 11 (and OSC_CAL = 1). The oscillator can then be adjusted by writing into the registers SWK_OSC_TRIM_CTRL and SWK_OPT_CTRL. To finish the trimming, the bits TRIM_EN_x must be set back to " 00 ".


### 5.6.7 CAN Flexible Data Rate (CAN FD) Tolerant Mode

The CAN FD tolerant mode can be activated by setting the bit CAN_FD_EN = ' 1 ' in the register SWK_CAN_FD_CTRL.
With this mode the internal CAN frame decoding is stopped for CAN FD frame formats:

- The high baudrate part of a CAN FD frame are ignored,
- No Error Handling (Bit Stuffing, CRC checking, Form Errors) is applied to remaining CAN frame fields (Data Field, CRC Field, ...),
- No wake-up is done on CAN FD frames.

The internal CAN frame decoder is ready for new CAN frame reception when the End of frame (EOF) of a CAN FD frame is detected. The identification for a CAN FD frame is based on the EDL Bit, which is sent in the Control Field of a CAN FD frame:

- EDL Bit = 1 identifies the current frame as a CAN FD frame and stops further decoding it.
- EDL Bit $=0$ identifies the current frame as a CAN 2.0 frame and processing of the frame is continued In this way it is possible to send mixed CAN frame formats without affecting the selective wake functionality by error counter increment and subsequent misleading wake-up. In addition to the CAN_FD_EN bit also a filter setting must be provided for the CAN FD tolerant mode. This filter setting defines the minimum dominant time for a CAN FD dominant bit which is considered as a dominant bit from the CAN FD frame decoder. This value must be aligned with the selected high baudrate of the data field in the CAN network.
To support programming via CAN during CAN FD mode a dedicated SPI bit DIS_ERR_CNT is available to avoid an overflow of the implemented error counter (see also Chapter 5.6.2.4).
The behavior of the error counter depends on the setting of the bits DIS_ERR_CNT and CAN_FD_EN and is show in below table:

Table 19 Error Counter Behavior

| DIS_ERR_CNT setting | CAN_FD_EN setting | Error Counter Behavior |
| :--- | :--- | :--- |
| 0 | 0 | Error Counter counts up when a CAN FD frame or an <br> incorrect/corrupted CAN frame is received; counts down <br> when a CAN frame is received properly <br> (as specified in ISO 11898-2:2016) |
| 1 | 0 | Error Counter counts up when a CAN FD frame or an <br> incorrect/corrupted CAN frame is received; counts down <br> when a CAN frame is received properly <br> (as specified in ISO 11898-2:2016) |
| 0 | 1 | Error Counter counts down when correct CAN (incl. CAN FD) <br> frame is received |
| 1 | 1 | Error Counter is and stays cleared to avoid an overflow <br> during programming via CAN |

The DIS_ERR_CNT bit is automatically cleared at Tsilence ( $\mathbf{t}_{\text {sILENCE }}$ ) expiration.

### 5.6.8 Clock and Data Recovery

In order to compensate possible deviations on the CAN oscillator frequency caused by assembly and lifetime effects, the device features an integrated clock and data recovery (CDR).

It is recommended to always enable the CDR feature during SWK operation.

### 5.6.8.1 Configuring the Clock Data Recovery for SWK

The Clock and Data Recovery can be optionally enabled or disabled with the CDR_EN bit in the SWK_CDR_CTRL1 SPI register. In case the feature is enabled, the CAN bit stream is measured and the internal clock used for the CAN frame decoding is updated accordingly.
Before the Clock and Data Recovery can be used it must be configured properly related to the used baud rate and filtering characteristics (see Chapter 5.6.8.2).
It is strongly recommended not to enable/disable the Clock Recovery during an active CAN Communication.
To ensure this, it is recommended to enable/disable it during CAN Off (BUS_CTRL_0; CAN[2:0] = 000).


Figure 18 Clock and Data Recovery Block Diagram

### 5.6.8.2 Setup of Clock and Data Recovery

It is strongly recommended to enable the clock and data recovery feature only when the setup of the clock and data recovery is finished.
The following sequence should be followed for enabling the clock and data recovery feature:

- Step 1: Switch CAN to Off and CDR_EN to Off

Write SPI Register BUS_CTRL_0 (CAN[2:0] = 000).

- Step 2: Configure CDR Input clock frequency

Write SPI Register SWK_CDR_CTRL2 (SEL_OSC_CLK[1:0]).

- Step 3: Configure Bit timing Logic

Write SPI Register SWK_BTLO_CTRL and adjust SWK_CDR_LIMIT_HIGH_CTRL and SWK_CDR_LIMIT_LOW_CTRL according to Table 36.

- Step 4: Enable Clock and Data Recovery

Choose filter settings for Clock and Data recovery. Write SPI Register SWK_CDR_CTRL1 with CDR_EN = 1

Additional hints for the CDR configuration and operation:

- Even if the CDR is disabled, when the baud rate is changed, the settings of SEL_OSC_CLK in the register SWK_CDR_CTRL1 and SWK_BTLO_CTRL have to be updated accordingly,
- The SWK_CDR_LIMIT_HIGH_CTRL and SWK_CDR_LIMIT_LOW_CTRL registers have to be also updated when the baud rate or clock frequency is changed (the CDR is discarding all the acquisitions and loses all acquired information, if the limits are reached - the SWK_BTLO_CTRL value is reloaded as starting point for the next acquisitions)
- When updating the CDR registers, it is recommended to disable the CDR and to enable it again only after the new settings are updated,
- The SWK_BTL1_CTRL register represents the sampling point position. It is recommended to be used at default value: 110011 (~80\%)


### 5.6.9 Electrical Characteristics

## Table 20 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ; 4.75 \mathrm{~V}<\mathrm{VCAN}<5.25 \mathrm{~V} ; R_{\mathrm{L}}=60 \Omega$; CAN Normal Mode; all voltages with respect to ground, positive current flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| CAN Partial Network Timing |  |  |  |  |  |  |  |
| Timeout for bus inactivity | $t_{\text {SILENCE }}$ | 0.6 | - | 1.2 | S | 1) | P_5.13.1 |
| Bus Bias reaction time | $t_{\text {bias }}$ | - | - | 250 | $\mu \mathrm{s}$ | $\begin{aligned} & \text { 1) } \mathrm{Load} R_{\mathrm{L}}=60 \Omega, \\ & C_{\mathrm{L}}=100 \mathrm{pF}, \\ & C_{\mathrm{GND}}=100 \mathrm{pF} \end{aligned}$ | P_5.13.2 |
| Wake-up reaction time (WUP or WUF) | $t_{\text {WU_WUP/WUF }}$ | - | - | 100 | $\mu \mathrm{s}$ | ${ }^{1 / 2) 3)}$ Wake-up reaction time after a valid WUP or WUF; | P_5.13.3 |
| Min. Bit Time | $t_{\text {Bit_min }}$ | 1 | - | - | $\mu \mathrm{s}$ | 1)4) | P_5.13.4 |
| CAN FD Tolerance ${ }^{5}$ |  |  |  |  |  |  |  |
| Dominant signals which are ignored (up to $2 \mathrm{MBit} / \mathrm{s}$ ) | $t_{\text {FD_Glitch_4 }}$ | 0 | - | 5 | \% | 6)7) of arbitration bit time; to be configured via FD_FILTER; | P_5.13.5 |
| Dominant signals which are ignored (up to 5MBit/s) | $t_{\text {FD_Glitch_10 }}$ | 0 | - | 2.5 | \% | ${ }^{6) 8}$ ) of arbitration bit time; to be configured via FD_FILTER; | P_5.13.6 |
| Signals which are detected as a dominant data bit after the FDF bit and before EOF bit (up to 2MBit/s) | $t_{\text {FD_DOM_4 }}$ | 17.5 | - | - | \% | 6)7) of arbitration bit time; to be configured via FD_FILTER; | P_5.13.7 |
| Signals which are detected as a dominant data bit after the FDF bit and before EOF bit (up to 5MBit/s) | $t_{\text {FD_DOM_10 }}$ | 8.75 | - | - | \% | ${ }^{6) 8}$ ) of arbitration bit time; to be configured via FD_FILTER; | P_5.13.8 |

1) Not subject to production test, tolerance defined by internal oscillator tolerance
2) Wake-up is signalized via INTN pin activation in SBC Stop Mode and via VCC1 ramping up with wake from SBC Sleep Mode;
3) For WUP: time starts with end of last dominant phase of WUP; for WUF: time starts with end of CRC delimiter of the WUF
4) The minimum bit time corresponds to a maximum bit rate of $1 \mathrm{Mbit} / \mathrm{s}$. The lower end of the bit rate depends on the protocol IC or the permanent dominant detection circuitry preventing a permanently dominant clamped bus.
5) Applies for an arbitration rate of up to 500 kbps until the FDF bit is detected and $\mathbf{R X}$ _WK_ SEL = 1 .
6) Not subject to production test; specified by design.
7) A data phase bit rate less or equal to four times of the arbitration bit rate or $2 \mathrm{Mbit} / \mathrm{s}$, whichever is lower.
8) A data phase bit rate less or equal to ten times of the arbitration bit rate or $5 \mathrm{Mbit} / \mathrm{s}$, whichever is lower.

Voltage Regulator 1

## $6 \quad$ Voltage Regulator 1

### 6.1 Block Description



Figure 19 Module Block Diagram

## Functional Features

- 3.3V low-dropout linear voltage regulator
- Undervoltage monitoring with adjustable reset level, VCC1 prewarning and VCC1 short circuit detection $\left(\mathrm{V}_{\mathrm{RT} 1 / 2 / 3 / 4}, \mathrm{~V}_{\mathrm{PW}, \mathrm{f}}\right)$. Please refer to Chapter $\mathbf{1 2 . 5}$ and Chapter $\mathbf{1 2 . 6}$ for more information.
- Short circuit detection and switch Off with undervoltage fail threshold, device enters SBC Fail-Safe Mode
- $\geq 1 \mu \mathrm{~F}$ ceramic capacitor at voltage output for stability, with $\mathrm{ESR}<1 \Omega @ \mathrm{f}=10 \mathrm{kHz}$, to achieve the voltage regulator control loop stability based on the safe phase margin (bode diagram).
- Output current limit $\mathrm{I}_{\mathrm{VCC} 1, \mathrm{lim}}$ configurable via SPI up to $I_{\text {VCC1,lim_11 }}$.


## Voltage Regulator 1

### 6.2 Functional Description

The Voltage Regulator 1 (=VCC1) is always enabled in SBC Normal, Stop and Restart Mode and is disabled in SBC Sleep and in Fail-Safe Mode. VCC1 is the voltage regulator output. VIO is the regulation feedback, supervision input and the supply for the digital in- and outputs. Therefore, the pins VCC1 and VIO must always be connected.

## Current Limitation Configurations:

The regulator can provide an output current up to $\mathrm{I}_{\mathrm{VCC1}, \mathrm{lim}}$. The current limitation threshold can be adjusted with the bits ICC1_LIM_ADJ. A soft-start feature is implemented that limits the current to the lowest value during start-up of VCC1 as long as RSTN is Low. After $\boldsymbol{t}_{\text {RD1 }}$ has expired, the default value is resumed after powerup or the configured value after SBC Sleep- or Fail-Safe Mode.

Table 21 Current Limitation Configurations

| SPI Setting <br> ICC1_LIM_ADJ | Typ. Limitation <br> Current | Note |
| :--- | :--- | :--- |
| '00' | 0.75 A | default value, recommended setting |
| $‘ 01 '$ | 1.0 A | setting for maximum peak load current / large external capacitor values |
| $' 10 '$ | 1.2 A | setting not recommended |
| $' 11 '$ | 1.5 A | setting not recommended |

For low-quiescent current reasons, the output voltage accuracy is decreased in SBC Stop Mode because a less accurate low-power mode regulator is active for very small loads. If the load current on VCC1 exceeds the selected threshold ( $\mathrm{I}_{\mathrm{VCC1,Ipeak1,r}}$ or $\mathrm{I}_{\mathrm{VCC1,Ipeak2,r}}$ ) then the high-power mode regulator is also activated to support an optimum dynamic load behavior. The current consumption increases by typ. 2.9 mA . The SBC Mode stays unchanged.
If the load current on VCC1 falls below the selected threshold ( $\mathrm{I}_{\mathrm{VCC1,lpeak1,f}}$ or $\mathrm{I}_{\mathrm{VCC1,lpeak2,f}}$ ), then the low-quiescent current mode is resumed again by disabling the high-power mode regulator.
Both regulators (low-power mode and high-power mode) are active in SBC Normal Mode.
Two different active peak thresholds can be selected via SPI:

- I_PEAK_TH = ' 0 '(default): the lower VCC1 active peak threshold 1 is selected with lowest quiescent current consumption in SBC Stop Mode ( $\mathbf{I}_{\text {stop_1,25 }}, \mathbf{I}_{\text {stop_1,85 }}$ );
- I_PEAK_TH = ' 1 ': the higher VCC1 active peak threshold 2 is selected with an increased quiescent current consumption in SBC Stop Mode ( $\mathbf{I}_{\text {Stop_2,25 }}, \mathbf{I}_{\text {Stop_2,85 }}$ );


## Voltage Regulator 1

### 6.3 Electrical Characteristics

Table 22 Electrical Characteristics
$\mathrm{V}_{\mathrm{S}}=3.8 \mathrm{~V}$ to $28 \mathrm{~V} ; T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Output Voltage including Line and Load Regulation | $V_{\text {CC1,out } 1}$ | 3.23 | 3.3 | 3.37 | V | ${ }^{1)}$ SBC Normal Mode; $10 \mu \mathrm{~A}<l_{\text {VCC } 1}<150 \mathrm{~mA}$ | P_7.3.4 |
| Output Voltage including Line and Load Regulation (Full Load Current Range) | $V_{\text {CC1,out2 }}$ | 3.23 | 3.3 | 3.37 | V | ${ }^{2)}$ SBC Normal Mode; $\begin{aligned} & 5.5 \mathrm{~V}<V_{\mathrm{S}}<28 \mathrm{~V} ; \\ & 10 \mu \mathrm{~A}<I_{\mathrm{VCC} 1}<250 \mathrm{~mA} \end{aligned}$ | P_7.3.22 |
| Output Voltage including Line and Load Regulation (Higher Accuracy Range) | $V_{\text {CC1,out } 3}$ | 3.27 | 3.3 | 3.34 | V | ${ }^{133)}$ SBC Normal Mode; $\begin{aligned} & 20 \mathrm{~mA}<I_{\text {vcc1 }}<80 \mathrm{~mA} ; \\ & 8 \mathrm{~V}<V_{\mathrm{s}}<18 \mathrm{~V} ; \\ & 25^{\circ} \mathrm{C}<T_{\mathrm{j}}<125^{\circ} \mathrm{C} \\ & \hline \end{aligned}$ | P_7.3.5 |
| Output Voltage including Line and Load Regulation (Low-Power Mode) | $V_{\text {CC1,out } 4}$ | 3.26 | 3.3 | 3.4 | V | SBC Stop Mode; $10 \mu \mathrm{~A}<I_{\mathrm{VCC} 1}<I_{\mathrm{VCC} 1, \text { Ipeak }}$ | P_7.3.6 |
| Drop-Out Voltage | $V_{\text {CC1, dr }}$ | - | - | 500 | mV | $\begin{aligned} & I_{\mathrm{VCC} 1}=200 \mathrm{~mA}, \\ & V_{\mathrm{S}}=3.3 \mathrm{~V} \end{aligned}$ | P_7.3.23 |
| VCC1 Active Peak Threshold 1 (Transition threshold between low-power and highpower mode regulator) | $I_{\text {VCC1,Ipeak1,r }}$ | 1.5 | 3.25 | 5.0 | mA | $\begin{aligned} & { }^{3)} I_{\mathrm{CC} 1} \text { rising; } \\ & V_{\mathrm{S}}=13.5 \mathrm{~V} ; \\ & \text { I_PEAK_TH }=\text { ' } 0 \text { ' }^{\text {I_P }} \end{aligned}$ | P_7.3.9 |
| VCC1 Active Peak Threshold 1 (Transition threshold between high-power and lowpower mode regulator) | $I_{\text {VCC1,Ipeak1,f }}$ | 1.2 | 2.3 | 3.5 | mA | ${ }^{3)} I_{\mathrm{CC} 1}$ falling; $\begin{aligned} & V_{\mathrm{S}}=13.5 \mathrm{~V} ; \\ & \text { I_PEAK_TH = ' } 0 \text { ' } \end{aligned}$ | P_7.3.10 |
| VCC1 Active Peak Threshold 2 (Transition threshold between low-power and highpower mode regulator) | $I_{\text {VCC1,Ipeak2,r }}$ | 2.5 | 6.25 | 10 | mA | $\begin{aligned} & { }^{3)} I_{\mathrm{CC} 1} \text { rising; } \\ & V_{\mathrm{S}}=13.5 \mathrm{~V} ; \\ & \text { I_PEAK_TH = ' } 1 \text { ' }^{\text {I_P }} \end{aligned}$ | P_7.3.11 |
| VCC1 Active Peak Threshold 2 (Transition threshold between high-power and lowpower mode regulator) | $I_{\text {VCC1,Ipeak2,f }}$ | 2.2 | 4.5 | 8 | mA | $\begin{aligned} & { }^{3)} I_{\mathrm{CC} 1} \text { falling; } \\ & V_{\mathrm{S}}=13.5 \mathrm{~V} ; \\ & \text { I_PEAK_TH }=\text { ' } 1 \text { ' }^{\text {I_P }} \end{aligned}$ | P_7.3.12 |
| Overcurrent Limitation (ICC1_LIM_ADJ= ‘00’) | $I_{\text {VCC1,lim_00 }}$ | 0.6 | 0.75 | 0.95 | A | ${ }^{3 / 4)}$ current flowing out of pin, $V_{\mathrm{CC1}}=0 \mathrm{~V}$, $V_{\mathrm{s}}>6 \mathrm{~V}$, default value | P_7.3.13 |

## Voltage Regulator 1

## Table 22 Electrical Characteristics (cont'd)

$\mathrm{V}_{\mathrm{S}}=3.8 \mathrm{~V}$ to $28 \mathrm{~V} ; T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Overcurrent Limitation (ICC1_LIM_ADJ= '01’) | $I_{\text {VCC1, }}$ lim_01 | 0.8 | 1.0 | 1.25 | A | ${ }^{3 / 4)}$ current flowing out of pin, $V_{\mathrm{CC} 1}=0 \mathrm{~V}$, $v_{s}>6 \mathrm{~V}$ | P_7.3.19 |
| Overcurrent Limitation (ICC1_LIM_ADJ= '10') | $I_{\text {VCC1, }}$ lim_10 | 0.96 | 1.25 | 1.60 | A | ${ }^{3 / 4)}$ current flowing out of pin, $V_{\mathrm{CC} 1}=0 \mathrm{~V}$, $V_{\mathrm{s}}>6 \mathrm{~V}$ | P_7.3.20 |
| Overcurrent Limitation (ICC1_LIM_ADJ= '11') | $I_{\text {VCC1, }}$ lim_11 | 1.1 | 1.5 | 1.95 | A | ${ }^{3 / 4)}$ current flowing out of pin, $V_{\mathrm{CC} 1}=0 \mathrm{~V}$, $v_{s}>6 \mathrm{~V}$ | P_7.3.21 |

1) In SBC Stop Mode, the specified output voltage tolerance applies when I Ivcci has exceeded the selected active peak threshold ( $\mathrm{I}_{\mathrm{vcc} 1, \text {,peak } 1, \mathrm{r}}$ or $\mathrm{I}_{\mathrm{vcc} 1, \text { lpeak } 2, \mathrm{r}}$ ) but with increased current consumption.
2) In SBC Stop Mode, the specified output voltage tolerance applies when I IVCC1 has exceeded the selected active peak threshold ( $\mathrm{I}_{\text {vcc } 1, \text { lpeak } 1, \mathrm{r}}$ or $\mathrm{I}_{\mathrm{Vcc} 1, \text { Ipeak } 2, r}$ ) but with increased current consumption.
3) Not subject to production test, specified by design.
4) Current limitation value is max. $20 \%$ higher for $V_{\text {Por,f }}<V_{S}<6 \mathrm{~V}$ to optimize low-drop operation behavior. Lite CAN SBC Family

## Voltage Regulator 2

## $7 \quad$ Voltage Regulator 2

### 7.1 Block Description



Figure 20 Module Block Diagram

## Functional Features

- 5 V low drop-out linear voltage regulator
- Protected against short to battery voltage, e.g. for off-board sensor supply
- Can also be used for CAN supply
- VCC2 undervoltage monitoring. Please refer to Chapter 12.7 for more information
- Can be active in SBC Normal, SBC Stop, and SBC Sleep Mode (not SBC Fail-Safe Mode)
- VCC2 switches Off after entering SBC Restart Mode. Switch Off is latched, LDO must be enabled via SPI after shutdown.
- Overtemperature protection
- $\geq 470 \mathrm{nF}$ ceramic capacitor at output voltage for stability, with $\mathrm{ESR}<1 \Omega @ \mathrm{f}=10 \mathrm{kHz}$, to achieve the voltage regulator control loop stability based on the safe phase margin (bode diagram).
- Output current capability up to $\mathrm{I}_{\mathrm{Vcc} 2, \mathrm{lim}}$.


## Voltage Regulator 2

### 7.2 Functional Description

In SBC Normal Mode VCC2 can be switched On or Off via SPI.
For SBC Stop- or Sleep Mode, the VCC2 has to be switched On or Off in SBC Normal Mode before entering the respective SBC mode. The regulator is automatically switched Off in SBC Restart Mode
The regulator can provide an output current up to $\mathrm{I}_{\mathrm{vcc} 2, \mathrm{lim}}$.
For low-quiescent current reasons, the output voltage accuracy is decreased in SBC Stop and Sleep Mode (if enabled) because a low-power mode regulator with a lower accuracy ( $\mathrm{V}_{\mathrm{CC2}, \text { out4 } 4}$ ) is active for small loads. If the load current on VCC2 exceeds $I_{\mathrm{VCC2}}>I_{\mathrm{VCC2}, \text { lpeak, },}$ then the high-power mode regulator will also be enabled to support an optimum dynamic load behavior. The current consumption increases by typ. 2.9mA. The SBC Mode stays unchanged.
If the load current on VCC2 falls below the threshold ( $\left.\mathrm{I}_{\mathrm{VCC2}}<\mathrm{I}_{\text {VCC2,Ipeak, }}\right)$, then the low-quiescent current mode is resumed by disabling the high-power mode regulator.
Both regulators are active in SBC Normal Mode.
Note: If the VCC2 output voltage is supplying external off-board loads, the application must consider the series resonance circuit built by cable inductance and decoupling capacitor at the load. Sufficient damping must be provided.

Note: To avoid excessive repetitive short-circuit conditions, It is recommended to detect the shutdown reason for VCC2 and keep the regulator Off after multiple over-temperature shutdowns.

### 7.2.1 Short to Battery Protection

The output stage is protected for short to VBAT. No inverse current flows if the voltage on VCC2 is higher than the nominal output voltage.

## Voltage Regulator 2

### 7.3 Electrical Characteristics

## Table 23 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Output Voltage Including Line and Load Regulation (Full Load Current Range) | $V_{\text {cc2,out } 1}$ | 4.9 | 5.0 | 5.1 | V | ${ }^{1)}$ SBC Normal Mode; $10 \mu \mathrm{~A}<I_{\text {VCC2 }}<100 \mathrm{~mA}$ $6 \mathrm{~V}<\mathrm{V}_{\mathrm{S}}<28 \mathrm{~V}$ | P_8.3.1 |
| Output Voltage Including Line and Load Regulation | $V_{\text {CC2,out2 }}$ | 4.9 | 5.0 | 5.1 | V | ${ }^{1)}$ SBC Normal Mode; $10 \mu \mathrm{~A}<I_{\mathrm{vcc} 2}<50 \mathrm{~mA}$ | P_8.3.2 |
| Output Voltage Including Line and Load Regulation (Higher Accuracy Range) | $V_{\text {CC2,out }}$ | 4.95 | 5.0 | 5.05 | V | $\begin{aligned} & { }^{2)} \text { SBC Normal Mode; } \\ & 10 \mu \mathrm{AA}<I_{\text {vcc } 2}<5 \mathrm{~mA} \\ & 8 \mathrm{~V}<V_{\mathrm{S}}<18 \mathrm{~V} \end{aligned}$ | P_8.3.3 |
| Output Voltage Including Line and Load Regulation <br> (Low-Power Mode) | $V_{\text {cc2,out } 4}$ | 4.9 | 5.05 | 5.2 | V | SBC Stop / Sleep Mode; $10 \mu \mathrm{~A}<I_{\mathrm{VCC2}}<\mathrm{I}_{\mathrm{vcc} 2, \text { Ipeak }}$ | P_8.3.4 |
| Drop-Out Voltage | $V_{\text {cC2,dr }}$ | - | - | 500 | mV | $\begin{aligned} & I_{\mathrm{vcc} 2}=30 \mathrm{~mA} \\ & V_{\mathrm{S}}=5 \mathrm{~V} \end{aligned}$ | P_8.3.5 |
| VCC2 Active Peak Threshold (Transition threshold between low-power and highpower mode regulator) | $I_{\text {VCC2, }}$ Ipeak,r | 2.3 | 3.3 | 4.4 | mA | ${ }^{2)}{ }_{\text {cC2 }}$ rising; $v_{\mathrm{s}}=13.5 \mathrm{~V} ;$ | P_8.3.6 |
| VCC2 Active Peak Threshold (Transition threshold between high-power and lowpower mode regulator) | $I_{\text {vCC2, }}$ lpeak, f | 1.4 | 2.2 | 3.2 | mA | ${ }^{2)}{ }_{\text {CC2 }}$ falling; $v_{\mathrm{s}}=13.5 \mathrm{~V}$ | P_8.3.7 |
| Overcurrent limitation | $I_{\text {vcce }, \text { lim }}$ | 100 | - | 450 | mA | ${ }^{2)}$ current flowing out of $\mathrm{pin}, V_{\mathrm{cC2}}=0 \mathrm{~V}$ | P_8.3.8 |

1) In SBC Stop Mode, the specified output voltage tolerance applies when $I_{\mathrm{vCC}}$ has exceeded the selected active peak threshold (livcc,,peak, ) but with increased current consumption.
2) Not subject to production test, specified by design.

## Lite CAN SBC Family

## Voltage Regulator 2



Figure 21 Typical on-resistance of VCC2 pass device during linear ( $\left.\mathrm{R}_{\mathrm{ON}}\right)$ mode for $I_{\mathrm{CC} 2}=30 \mathrm{~mA}$ Lite CAN SBC Family

## Voltage Regulator 2



Figure 22 On-resistance range of VCC2 pass device during linear $\left(R_{O N}\right)$ mode for $I_{C C 2}=50 \mathrm{~mA}$

High-Speed CAN FD Transceiver

## 8 High-Speed CAN FD Transceiver

### 8.1 Block Description



Figure 23 Functional Block Diagram

### 8.2 Functional Description

The Controller Area Network (CAN) transceiver part of the SBC provides High-Speed (HS) differential mode data transmission (up to 2 Mbaud ) and reception in automotive and industrial applications. It works as an interface between the CAN protocol controller and the physical bus lines compatible to ISO 11898-2:2016 and SAE J2284.

The CAN FD transceiver offers low-power modes to reduce current consumption. This supports networks with partially powered down nodes. To support software diagnostic functions, a CAN Receive-only Mode is implemented.
It is designed to provide excellent passive behavior when the transceiver is switched Off (mixed networks, clamp 15/30 applications).
A wake-up from the CAN Wake Capable Mode is possible via a message on the bus. Thus, the microcontroller can be powered down or idled and is woken up by the CAN bus activities.
The CAN transceiver is designed to withstand the severe conditions of automotive applications and to support 12 V applications.
The transceiver can also be configured to Wake Capable in order to save current and to ensure a safe transition from Normal to Sleep Mode (to avoid losing messages).

High-Speed CAN FD Transceiver

Figure 24 shows the possible transceiver mode transition when changing the SBC mode.


Figure 24 CAN Mode Control Diagram

## CAN FD Support

CAN FD stands for 'CAN with Flexible Data Rate'. It is based on the well-established CAN protocol as specified in ISO 11898-1. CAN FD still uses the CAN bus arbitration method. The benefit is that the bit rate can be increased by switching to a shorter bit time at the end of the arbitration process and then to return to the longer bit time at the CRC delimiter, before the receivers transmit their acknowledge bits. See also Figure 25. In addition, the effective data rate is increased by allowing longer data fields. CAN FD allows the transmission of up to 64 data bytes compared to the 8 data bytes from the standard CAN.


Figure 25 Bite Rate Increase with CAN FD vs. Standard CAN

Not only the physical layer must support CAN FD but also the CAN controller. In case the CAN controller is not able to support CAN FD then the respective CAN node must at least tolerate CAN FD communication. This CAN FD tolerant mode is realized in the physical layer.

High-Speed CAN FD Transceiver

### 8.2.1 CAN Off Mode

The CAN Off Mode is the default mode after power-up of the SBC. It is available in all SBC Modes and is intended to completely stop CAN activities or when CAN communication is not needed. In CAN Off Mode, a wake-up event on the bus is ignored.

### 8.2.2 CAN Normal Mode

The CAN Transceiver is enabled via SPI. CAN Normal Mode is designed for normal data transmission/reception within the HS CAN network. The Mode is available in SBC Normal Mode.

## Transmission:

The signal from the microcontroller is applied to the TXDCAN input of the SBC. The bus driver switches the CANH/L output stages to transfer this input signal to the CAN bus lines.

## Enabling sequence:

The CAN transceiver requires an enabling time $\mathbf{t}_{\text {CAN,EN }}$ before a message can be sent on the bus. This means that the TXDCAN signal can only be pulled Low after the enabling time. If this is not ensured, then the TXDCAN needs to be set back to High (=recessive) until the enabling time is completed. Only the next dominant bit is transmitted on the bus. Figure $\mathbf{2 6}$ shows different scenarios and explanations for CAN enabling.


Figure 26 CAN Transceiver Enabling Sequence

## Reduced Electromagnetic Emission:

To reduce electromagnetic emissions (EME), the bus driver controls CANH/L slopes symmetrically.

## Reception:

Analog CAN bus signals are converted into digital signals at RXDCAN via the differential input receiver.

High-Speed CAN FD Transceiver

### 8.2.3 CAN Receive Only Mode

In CAN Receive Only Mode (RX only), the driver stage is de-activated but reception is still operational. This mode is accessible by an SPI command in SBC Normal Mode and in SBC Stop Mode.

Note: $\quad$ The transceiver is still properly working in Receive Only mode even if VCAN is not available because of an independent receiver supply.

### 8.2.4 CAN Wake Capable Mode

This mode can be used in SBC Stop, Sleep, Restart and Normal Mode by programming via SPI and it is used to monitor bus activities. It is automatically accessed in SBC Fail-Safe Mode. A wake-up signal on the bus results in a change of behavior of the SBC, as described in Table 24. As a signalization to the microcontroller, the RXDCAN pin is set Low and stays Low until the CAN transceiver is changed to any other mode. After a wake-up event, the transceiver can be switched to CAN Normal Mode via SPI for bus communication.
As shown in Figure 27, a wake-up pattern (WUP) is signalled on the bus by two consecutive dominant bus levels for at least $\mathbf{t}_{\text {Wake1 }}$ (wake-up time) and less than $\mathbf{t}_{\text {Wake2 }}$, each separated by a recessive bus level of greater than $\mathbf{t}_{\text {Wake1 }}$ and shorter than $\mathbf{t}_{\text {Wake2 }}$.


Figure 27 CAN Wake-up Pattern Detection according to the Definition in ISO 11898-2

## Rearming the Transceiver for Wake Capability:

After a BUS wake-up event, the transceiver is woken. However, the CAN transceiver mode bits will still show Wake Capable (=‘01’) so that the RXDCAN signal is pulled Low. There are two possibilities how the CAN transceiver's Wake Capable mode is enabled again after a wake-up event:

- The CAN transceiver mode must be toggled, i.e. switched from Wake Capable Mode to CAN Normal Mode, CAN Receive Only Mode or CAN Off, before switching to CAN Wake Capable Mode again.

High-Speed CAN FD Transceiver

- Rearming is done automatically when the SBC is changed to SBC Stop, SBC Sleep, or SBC Fail-Safe Mode to ensure wake-up capability.


## Wake-Up in SBC Stop and Normal Mode:

In SBC Stop Mode, if a wake-up is detected, it is always signaled by the INTN output and in the WK_STAT_0 SPI register. It is also signaled by RXDCAN pulled to Low. The same applies for the SBC Normal Mode. The microcontroller needs to set the device from SBC Stop Mode to SBC Normal Mode, there is no automatic transition to Normal Mode.
For functional safety reasons, the watchdog is automatically enabled in SBC Stop Mode after a Bus wake-up event in case it was disabled before (if bit WD_EN_WK_BUS was configured to High before).

## Wake-Up in SBC Sleep Mode:

Wake-up is possible via a CAN message. The wake-up automatically transfers the SBC into the SBC Restart Mode and from there to Normal Mode the corresponding RXDCAN pin is set to Low. The microcontroller is able to detect the Low signal on RXDCAN and to read the wake source out of the WK_STAT_0 register via SPI. No interrupt is generated when coming out of Sleep Mode. The microcontroller can now for example switch the CAN transceiver into CAN Normal Mode via SPI to start communication.

Table 24 Action due to CAN Bus Wake-Up

| SBC Mode | SBC Mode after Wake-up | VCC1 | INTN | RXDCAN |
| :--- | :--- | :--- | :--- | :--- |
| Normal Mode | Normal Mode | On | Low | Low |
| Stop Mode | Stop Mode | On | Low | Low |
| Sleep Mode | Restart Mode | Ramping Up | High | Low |
| Restart Mode | Restart Mode | On | High | Low |
| Fail-Safe Mode | Restart Mode | Ramping Up | High | Low |

### 8.2.5 CAN Bus termination

In accordance with the CAN configuration, four types of bus terminations are allowed:

- CAN Normal Mode: VCAN/2 termination;
- CAN Receive Only Mode: VCAN/2 termination in case that VCAN is nominal supply; when VCAN UV is detected, the termination is 2.5 V ;
- CAN Wake Capable: GND termination: after wake-up, the termination is 2.5V;
- CAN Off: no termination necessary (bus floating).

When entering CAN Wake Capable mode the termination is only connected to GND only after the t_silence time has expired.

### 8.2.6 TXD Time-out Feature

If the TXDCAN signal is dominant for a time $t>\mathbf{t}_{\text {TXDCAN_to }}$, in CAN Normal Mode, the TXDCAN time-out function deactivates the transmission of the signal at the bus setting the TXDCAN pin to recessive. This is implemented to prevent the bus from being blocked permanently due to an error. The transmitter is disabled and thus switched to recessive state. The CAN SPI control bits (CAN on BUS_CTRL_0) remain unchanged and the failure is stored in the SPI flag CAN_FAIL. The CAN transmitter stage is activated again after the dominant time-out condition is removed and the transceiver is automatically switched back to CAN Normal Mode.

High-Speed CAN FD Transceiver

### 8.2.7 Bus Dominant Clamping

If the HS CAN bus signal is dominant for a time $t>\mathbf{t}_{\text {bus_can_to, }}$, in CAN Normal and Receive Only Mode a bus dominant clamping is detected and the SPI bit CAN_FAIL is set. The transceiver configuration stays unchanged. In order to avoid that a bus dominant clamping is detected due to a TXD time-out the bus dominant clamping filter time $\mathbf{t}_{\text {BUS_CAN_TO }}>\mathbf{t}_{\text {TXDCAN_TO }}$.

### 8.2.8 Undervoltage Detection

The voltage at the CAN supply pin is monitored in CAN Normal and Receive Only Mode. In case of VCAN undervoltage a signalization via SPI bit VCAN_UV is triggered and the TLE9461-3ES V33 disables the transmitter stage. If the CAN supply reaches a higher level than the undervoltage detection threshold (VCAN > $\mathbf{V}_{\text {CAN_UV,r }}$ ), the transceiver is automatically switched back to CAN Normal Mode.
The undervoltage detection is enabled if the mode bit CAN_1 = ' 1 ', i.e. in CAN Normal or CAN Receive Only Mode.

High-Speed CAN FD Transceiver

### 8.3 Electrical Characteristics

## Table 25 Electrical Characteristics

$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ; V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; V_{\mathrm{CAN}}=4.75 \mathrm{~V}$ to $5.25 \mathrm{~V} ; R_{\mathrm{L}}=60 \Omega$; CAN Normal Mode; all voltages with respect to ground, positive current flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| CAN Bus Receiver |  |  |  |  |  |  |  |
| Differential Receiver <br> Threshold Voltage, recessive to dominant edge | $V_{\text {diff,rd_N }}$ | - | 0.80 | 0.90 | V | $\begin{aligned} & V_{\text {diff }}=V_{\text {CANH }}-V_{\text {CANL; }} \\ & -12 \mathrm{~V} \leq V_{\text {CM }}(\text { CAN }) \leq 12 \mathrm{~V} ; \\ & 0.9 \mathrm{~V} \leq V_{\text {diff,D_Range }} \leq 8 \mathrm{~V} ; \end{aligned}$ CAN Normal Mode | P_9.3.2 |
| Differential Receiver <br> Threshold Voltage, dominant to recessive edge | $V_{\text {diff,dr_N }}$ | 0.50 | 0.60 | - | V | $\begin{aligned} & V_{\text {diff }}=V_{\text {CANH }}-V_{\text {CANL }} ; \\ & -12 \mathrm{~V} \leq V_{\text {CM }}(\text { CAN }) \leq 12 \mathrm{~V} ; \\ & -3 \mathrm{~V} \leq V_{\text {diff,D_Range }} \leq 0.5 \mathrm{~V} ; \end{aligned}$ CAN Normal Mode | P_9.3.3 |
| Common Mode Range | CMR | -12 | - | 12 | V | 4) | P_9.3.4 |
| CANH, CANL Input Resistance | $R_{\text {in }}$ | 20 | 40 | 50 | $\mathrm{k} \Omega$ | CAN Normal / Wake Capable Mode; Recessive state; $-2 \mathrm{~V} \leq V_{\mathrm{CANL} / \mathrm{H}} \leq+7 \mathrm{~V}$ | P_9.3.5 |
| Differential Input Resistance | $R_{\text {in_diff }}$ | 40 | 80 | 100 | $\mathrm{k} \Omega$ | CAN Normal / Wake Capable Mode; Recessive state; $-2 \mathrm{~V} \leq V_{\text {CANL/H }} \leq+7 \mathrm{~V}$ | P_9.3.6 |
| Input Resistance Deviation between CANH and CANL | $D R_{\text {i }}$ | -3 | - | 3 | \% | ${ }^{4)}$ Recessive state $V_{\text {CANL }}=V_{\text {CANL/H }}=5 \mathrm{~V}$ | P_9.3.7 |
| Input Capacitance CANH, CANL versus GND | $C_{\text {in }}$ | - | 20 | 40 | pF | ${ }^{1)} V_{\text {TXDCAN }}=5 \mathrm{~V}$ | P_9.3.8 |
| Differential Input Capacitance CANH versus CANL | $C_{\text {in_diff }}$ | - | 10 | 20 | pF | ${ }^{1)} V_{\text {TXDCAN }}=5 \mathrm{~V}$ | P_9.3.9 |
| Wake-up Receiver Threshold Voltage, recessive to dominant edge | $V_{\text {diff, rd_w }}$ | - | 0.8 | 1.15 | V | $\begin{aligned} & -12 \mathrm{~V} \leq V_{\mathrm{CM}}(\mathrm{CAN}) \leq 12 \mathrm{~V} ; \\ & 1.15 \mathrm{~V} \leq V_{\text {diff,D_Range }} \leq 8 \mathrm{~V} ; \end{aligned}$ <br> CAN Wake Capable Mode | P_9.3.10 |
| Wake-up Receiver Threshold Voltage, dominant to recessive edge | $V_{\text {diff, dr_w }}$ | 0.4 | 0.7 | - | V | $\begin{aligned} & -12 \mathrm{~V} \leq V_{\text {CM }}(\mathrm{CAN}) \leq 12 \mathrm{~V} ; \\ & -3 \mathrm{~V} \leq V_{\text {diff, D_Range }} \leq 0.4 \mathrm{~V} ; \end{aligned}$ <br> CAN Wake Capable Mode | P_9.3.11 |
| CAN Bus Transmitter |  |  |  |  |  |  |  |
| CANH/CANL Recessive Output Voltage (CAN Normal Mode) | $V_{\text {CANL/H_NM }}$ | 2.0 | - | 3.0 | V | CAN Normal Mode $V_{\text {TXDCAN }}=V_{\mathrm{cC1}} ;$ <br> no load | P_9.3.12 |

High-Speed CAN FD Transceiver

Table 25 Electrical Characteristics (cont'd)
$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ; V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; V_{\mathrm{CAN}}=4.75 \mathrm{~V}$ to $5.25 \mathrm{~V} ; R_{\mathrm{L}}=60 \Omega$; CAN Normal Mode; all voltages with respect to ground, positive current flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| CANH/CANL Recessive <br> Output Voltage (CAN Wake Capable Mode) | $V_{\text {CANL/H_LP }}$ | -0.1 | - | 0.1 | V | CAN Wake Capable <br> Mode; $V_{\text {TXDCAN }}=V_{\text {CC1 }} ;$ <br> no load | P_9.3.13 |
| CANH, CANL Recessive Output Voltage Difference $V_{\text {diff }}=V_{\text {CANH }}-V_{\text {CANL }}$ <br> (CAN Normal Mode) | $V_{\text {diff_r_N }}$ | -500 | - | 50 | mV | CAN Normal Mode; $V_{\text {TXDCAN }}=V_{\text {cC1 }}$; no load | P_9.3.14 |
| CANH, CANL Recessive Output Voltage Difference $V_{\text {diff }}=V_{\text {CANH }}-V_{\text {CANL }}$ <br> (CAN Wake Capable Mode) | $V_{\text {diff_r_w }}$ | -200 | - | 50 | mV | CAN Wake Capable <br> Mode; $V_{\text {TXDCAN }}=V_{\mathrm{cC1}}$ <br> no load | P_9.3.15 |
| CANL Dominant Output Voltage | $V_{\text {CANL }}$ | 0.5 | - | 2.25 | V | CAN Normal Mode; $\begin{aligned} & V_{\text {TXDCAN }}=0 \mathrm{~V} ; \\ & V_{\text {CAN }}=5 \mathrm{~V} ; \\ & 50 \Omega \leq R_{\mathrm{L}} \leq 65 \Omega \end{aligned}$ | P_9.3.16 |
| CANH Dominant Output Voltage | $V_{\text {CANH }}$ | 2.75 | - | 4.5 | V | CAN Normal Mode; $\begin{aligned} & V_{\text {TXDCAN }}=0 \mathrm{~V} ; \\ & \mathrm{V}_{\text {CAN }}=5 \mathrm{~V} ; \\ & 50 \Omega \leq R_{\mathrm{L}} \leq 65 \Omega \end{aligned}$ | P_9.3.17 |
| CANH, CANL Dominant Output Voltage Difference $V_{\text {diff }}=V_{\text {CANH }}-V_{\text {CANL }}$ | $V_{\text {diff_d_N }}$ | 1.5 | 2.0 | 2.5 | V | CAN Normal Mode; $\begin{aligned} & V_{\text {TXDCAN }}=0 \mathrm{~V} ; \\ & \mathrm{V}_{\text {CAN }}=5 \mathrm{~V} ; \\ & 50 \Omega \leq R_{\mathrm{L}} \leq 65 \Omega \end{aligned}$ | P_9.3.18 |
| CANH, CANL Dominant Output Voltage Difference (resistance during arbitration) $V_{\text {diff }}=V_{\text {CANH }}-V_{\text {CANL }}$ | $V_{\text {diff_d_N }}$ | 1.5 | - | 5.0 | V | ${ }^{4)}$ CAN Normal Mode; $\begin{aligned} & V_{\text {TXDCAN }}=0 \mathrm{~V} ; \\ & V_{\text {CAN }}=5 \mathrm{~V} ; \\ & R_{\mathrm{L}}=2240 \Omega \end{aligned}$ | P_9.3.51 |
| CANH, CANL Dominant Output Voltage Difference (extended bus load range) $V_{\text {diff }}=V_{\text {CANH }}-V_{\text {CANL }}$ | $V_{\text {diff_d_N }}$ | 1.4 | - | 3.3 | V | ${ }^{4}$ CAN Normal Mode; $\begin{aligned} & V_{\text {TXDCAN }}=0 \mathrm{~V} ; \\ & V_{\text {CAN }}=5 \mathrm{~V} ; \\ & 45 \Omega \leq R_{\mathrm{L}} \leq 70 \Omega \end{aligned}$ | P_9.3.52 |
| CANH, CANL output voltage difference slope, recessive to dominant | $V_{\text {diff_slope_rd }}$ | - | - | 70 | V/us | ${ }^{4)} 30 \%$ to $70 \%$ of measured differential bus voltage, $C_{\mathrm{L}}=100 \mathrm{pF}, R_{\mathrm{L}}=60 \Omega$ | P_9.3.55 |

High-Speed CAN FD Transceiver

Table 25 Electrical Characteristics (cont'd)
$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ; V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; V_{\mathrm{CAN}}=4.75 \mathrm{~V}$ to $5.25 \mathrm{~V} ; R_{\mathrm{L}}=60 \Omega$; CAN Normal Mode; all voltages with respect to ground, positive current flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| CANH, CANL output voltage difference slope, dominant to recessive | $V_{\text {diff_slope_dr }}$ | - | - | 70 | V/us | ${ }^{4)} 70 \%$ to $30 \%$ of measured differential bus voltage, $C_{\mathrm{L}}=100 \mathrm{pF}, R_{\mathrm{L}}=60 \Omega$ | P_9.3.56 |
| Driver Symmetry $V_{\text {SYM }}=V_{\text {CANH }}+V_{\text {CANL }}$ | $V_{\text {SYM }}$ | 4.5 | - | 5.5 | V | ${ }^{2}$ CAN Normal Mode; $\begin{aligned} & V_{\text {TXDCAN }}=0 \mathrm{~V} / 5 \mathrm{~V} ; \\ & V_{\text {CAN }}=5 \mathrm{~V} ; \\ & C_{\text {SPLIT }}=4.7 \mathrm{nF} ; \\ & 50 \Omega \leq R_{\mathrm{L}} \leq 60 \Omega ; \end{aligned}$ | P_9.3.19 |
| CANH Short Circuit Current (New ISO requirement) | $I_{\text {CanHsc }}$ | -100 | -80 | -50 | mA | CAN Normal Mode; $\begin{aligned} & V_{\text {CANHshort }}=-3 \mathrm{~V} ; \\ & V_{\text {CAN }}=5 \mathrm{~V} \end{aligned}$ | P_9.3.20 |
| CANL Short Circuit Current (New ISO requirement) | $I_{\text {CANLsc }}$ | 50 | 80 | 100 | mA | CAN Normal Mode; $\begin{aligned} & V_{\text {CANLshort }}=18 \mathrm{~V} ; \\ & V_{\text {CAN }}=5 \mathrm{~V} \end{aligned}$ | P_9.3.21 |
| Leakage Current | $I_{\text {CANH,lk }}$ <br> $I_{\text {CANL, Ik }}$ | - | 2 | 5 | $\mu \mathrm{A}$ | $\begin{aligned} & V_{\mathrm{S}}=V_{\mathrm{CAN}}=0 \mathrm{~V} ; \\ & 0 \mathrm{~V} \leq V_{\mathrm{CANH}, \mathrm{~L}} \leq 5 \mathrm{~V} ; \\ & { }^{3)} R_{\text {test }}=0 / 47 \mathrm{k} \Omega \end{aligned}$ | P_9.3.22 |

## Receiver Output RXDCAN

| High-level Output Voltage | $V_{\text {RXDCAN,H }}$ | $0.8 \times$ <br> $V_{\mathrm{CC1}}$ | - | - | V | CAN Normal Mode; <br> $I_{\text {RXDCAN }}=-2 \mathrm{~mA}$ | $P_{-} 9.3 .23$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Low-level Output Voltage | $V_{\text {RXDCAN,L }}$ | - | - | $0.2 \times$ <br> $V_{\mathrm{CC1}}$ | V | CAN Normal Mode; <br> $I_{\text {RXDCAN }}=2 \mathrm{~mA}$ | $P_{-} 9.3 .24$ |

## Transmission Input TXDCAN

| High-level Input Voltage Threshold | $V_{\text {TXDCAN,H }}$ | - | - | $\begin{aligned} & 0.7 \times \\ & V_{\mathrm{cc} 1} \end{aligned}$ | V | CAN Normal Mode; recessive state | P_9.3.25 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Low-level Input Voltage Threshold | $V_{\text {TXDCAN,L }}$ | $\begin{aligned} & 0.3 \times \\ & V_{\mathrm{cc} 1} \\ & \hline \end{aligned}$ | - | - | V | CAN Normal Mode; dominant state | P_9.3.26 |
| TXDCAN Input Hysteresis | $V_{\text {TXDCAN,hys }}$ | $\begin{aligned} & 0.08 \times \\ & V_{c c 1} \end{aligned}$ | $\begin{aligned} & 0.12 \times \\ & V_{c c 1} \end{aligned}$ | $\begin{aligned} & 0.4 \times \\ & V_{\mathrm{cc} 1} \end{aligned}$ | mV | 4) | P_9.3.27 |
| TXDCAN Pull-up Resistance | $R_{\text {TXDCAN }}$ | 25 | 40 | 75 | $k \Omega$ | - | P_9.3.28 |
| CAN Transceiver Enabling Time | $t_{\text {CAN,EN }}$ | 8 | 12 | 18 | $\mu \mathrm{s}$ | ${ }^{8)}$ CSN = High to first valid transmitted TXDCAN dominant | P_9.3.29 |

## Dynamic CAN-Transceiver Characteristics

| Min. Dominant Time for Bus <br> Wake-up | $t_{\text {Wake1 }}$ | 0.5 | 1.2 | 1.8 | $\mu \mathrm{~S}$ | $-12 \mathrm{~V} \leq V_{C M}(C A N) \leq 12 \mathrm{~V} ;$ <br> CAN Wake Capable <br> Mode | P_9.3.53 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

High-Speed CAN FD Transceiver

Table 25 Electrical Characteristics (cont'd)
$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ; V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; V_{\mathrm{CAN}}=4.75 \mathrm{~V}$ to $5.25 \mathrm{~V} ; R_{\mathrm{L}}=60 \Omega$; CAN Normal Mode; all voltages with respect to ground, positive current flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Wake-up Time-out, Recessive Bus | $t_{\text {Wake2 }}$ | 0.8 | - | 10 | ms | ${ }^{8)}$ CAN Wake Capable Mode | P_9.3.31 |
| Wake-up reaction time (WUP or WUF) | $t_{\text {wu_WUP/WUF }}$ | - | - | 100 | $\mu \mathrm{S}$ | ${ }^{8 / 5) 6)}$ Wake-up reaction time after a valid WUP or WUF; | P_9.3.54 |
| Loop delay (recessive to dominant) | $t_{\text {LOOP, }}$ | - | 190 | 255 | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & \mathrm{V}_{\mathrm{CAN}}=5 \mathrm{~V} ; \\ & C_{\text {RXDCAN }}=15 \mathrm{pF} \end{aligned}$ | P_9.3.32 |
| Loop delay <br> (dominant to recessive) | $t_{\text {LOOP, }}$ | - | 200 | 255 | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & \mathrm{V}_{\mathrm{CAN}}=5 \mathrm{~V} ; \\ & C_{\mathrm{RXDCAN}}=15 \mathrm{pF} \end{aligned}$ | P_9.3.33 |
| Propagation Delay TXDCAN Low to bus dominant | $t_{\mathrm{d}(\mathrm{L}, \mathrm{T}}$ | - | 90 | 140 | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & \mathrm{V}_{\mathrm{CAN}}=5 \mathrm{~V} \end{aligned}$ | P_9.3.34 |
| Propagation Delay TXDCAN High to bus recessive | $t_{\mathrm{d}(\mathrm{H}), \mathrm{T}}$ | - | 100 | 140 | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & \mathrm{V}_{\text {CAN }}=5 \mathrm{~V} \end{aligned}$ | P_9.3.35 |
| Propagation Delay bus dominant to RXDCAN Low | $t_{\mathrm{d}(\mathrm{L}, \mathrm{R}}$ | - | 100 | - | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & \mathrm{V}_{\mathrm{CAN}}=5 \mathrm{~V} ; \\ & C_{\text {RXDCAN }}=15 \mathrm{pF} \end{aligned}$ | P_9.3.36 |
| Propagation Delay bus recessive to RXDCAN High | $t_{\mathrm{d}(\mathrm{H}), \mathrm{R}}$ | - | 100 | - | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & \mathrm{V}_{\mathrm{CAN}}=5 \mathrm{~V} ; \\ & C_{\mathrm{RXDCAN}}=15 \mathrm{pF} \end{aligned}$ | P_9.3.37 |

High-Speed CAN FD Transceiver

Table 25 Electrical Characteristics (cont'd)
$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ; V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; V_{\mathrm{CAN}}=4.75 \mathrm{~V}$ to $5.25 \mathrm{~V} ; R_{\mathrm{L}}=60 \Omega$; CAN Normal Mode; all voltages with respect to ground, positive current flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Received Recessive bit <br> width <br> (CAN FD up to 2Mbps) | $t_{\text {bit(RXD) }}$ | Min. | Typ. | Max. |  |  |  |

High-Speed CAN FD Transceiver

Table 25 Electrical Characteristics (cont'd)
$T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C} ; V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; V_{\mathrm{CAN}}=4.75 \mathrm{~V}$ to $5.25 \mathrm{~V} ; R_{\mathrm{L}}=60 \Omega$; CAN Normal Mode; all voltages with respect to ground, positive current flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| Transmitted Recessive bit width (CAN FD up to 5Mbps) | $t_{\text {bit(BUS) }}$ | 155 | - | 210 | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & V_{\mathrm{CAN}}=5 \mathrm{~V} ; \\ & C_{\mathrm{RXD}}=15 \mathrm{pF} ; \\ & t_{\mathrm{bit}(\mathrm{TXD})}=200 \mathrm{~ns} ; \end{aligned}$ <br> Parameter definition in according to Figure 29. | P_9.3.46 |
| Receiver timing symmetry (CAN FD up to 5Mbps) | $\Delta t_{\text {Rec }}$ | -45 | - | 15 | ns | CAN Normal Mode; $\begin{aligned} & C_{\mathrm{L}}=100 \mathrm{pF} ; \\ & R_{\mathrm{L}}=60 \Omega ; \\ & V_{\mathrm{CAN}}=5 \mathrm{~V} ; \\ & C_{\mathrm{RXD}}=15 \mathrm{pF} ; \\ & t_{\text {bit(TXD) }}=200 \mathrm{~ns} ; \end{aligned}$ <br> Parameter definition in according to Figure 29. | P_9.3.47 |
| TXDCAN Permanent Dominant Time-out | $t_{\text {TXDCAN_TO }}$ | 1.6 | 2.0 | 2.4 | ms | ${ }^{8)}$ CAN Normal Mode | P_9.3.39 |
| BUS Permanent Dominant Time-out | $t_{\text {Bus_CAN_TO }}$ | 2.0 | 2.5 | 3.0 | ms | ${ }^{8)}$ CAN Normal Mode | P_9.3.40 |
| Timeout for bus inactivity | $t_{\text {SILENCE }}$ | 0.6 | - | 1.2 | S | 8) | P_9.3.48 |
| Bus Bias reaction time | $t_{\text {Bias }}$ | - | - | 250 | $\mu \mathrm{S}$ | 8) | P_9.3.49 |

1) Not subject to production test, specified by design, S2P - Method; $f=10 \mathrm{MHz}$.
2) $\mathbf{V}_{\text {sYM }}$ shall be observed during dominant and recessive state and also during the transition dominant to recessive and vice versa while TXD is simulated by a square signal ( $50 \%$ duty cycle) with a frequency of up to $1 \mathrm{MHz}(2 \mathrm{MBit} / \mathrm{s})$;
3) $R_{\text {test }}$ between (Vs /VCAN) and OV (GND).
4) Not subject to production test, specified by design.
5) Wake-up is signalized via INTN pin activation in SBC Stop Mode and via VCC1 ramping up with wake from SBC Sleep Mode.
6) For WUP: time starts with end of last dominant phase of WUP; for WUF: time starts with end of CRC delimiter of the WUF.
7) $\Delta t_{\text {Rec }}=t_{\text {bit(RXD) }}-\mathbf{t}_{\text {bit(BUS) }}$.
8) Not subject to production test, tolerance defined by internal oscillator tolerance.

## Lite CAN SBC Family

High-Speed CAN FD Transceiver


Figure 28 Timing Diagrams for Dynamic Characteristics


Figure 29 From ISO 11898-2: tloop, tbit(TXD), tbit(Bus), tbit(RXD) definitions

High-Voltage Wake and Voltage Monitoring Input

## $9 \quad$ High-Voltage Wake and Voltage Monitoring Input

### 9.1 Block Description



Figure 30 Wake Input Block Diagram

## Features

- High-Voltage input with a 3V (typ.) threshold voltage
- Alternate measurement feature for high-voltage sensing via pins WK/SENSE and FO/GPIO
- Wake-up capability for power saving modes
- Edge sensitive wake-up feature Low to High and High to Low
- Pull-up and Pull-down current sources, configurable via SPI
- Selectable configuration for Static Sense or cyclic sense working with TIMER
- In SBC Normal and SBC Stop Mode the level of the WK pin can be read via SPI


### 9.2 High-Voltage Wake Function

### 9.2.1 Functional Description

The wake input pin is edge-sensitive inputs with a switching threshold of typically 3V. Both transitions, High to Low and Low to High, result in a signalization by the SBC. The signalization occurs either by triggering the interrupt in SBC Normal Mode and SBC Stop Mode or by a wake-up of the device in SBC Sleep and SBC FailSafe Mode.

Two different wake-up detection modes can be selected via SPI:

- Static Sense: WK inputs are always active
- Cyclic Sense: WK inputs are only active for a certain time period (see Chapter 5.2.1)

A filter time of $16 \mu \mathrm{~s}$ is implemented to avoid an unintentional wake-up due to transients or EMI disturbances in Static Sense configuration.
The filter time ( $\mathrm{t}_{\mathrm{FWK} 1}$ ) is triggered by a level change crossing the switching threshold and a wake signal is recognized if the input level does not cross again the threshold during the selected filter time.
Figure 31 shows a typical wake-up timing and filtering of transient pulses.


Figure 31 Wake-up Filter Timing for Static Sense

The wake-up capability of the WK pin can be enabled or disabled via SPI command in the WK_CTRL_1 register. A wake-up event via the WK pin can always be read in the register WK_STAT_0 at the bit WK_WU.
The actual voltage level of the WK pin (Low or High) can always be read in SBC Normal and SBC Stop-, and Init Mode in the register WK_LVL_STAT. During Cyclic Sense, the register shows the sampled levels of the respective WK pin.

If FO/GPIO is configured as WK input in its alternative function ( $16 \mu \mathrm{~s}$ static filter time), then the wake-up events are signalled in the register WK_STAT_1.

High-Voltage Wake and Voltage Monitoring Input

### 9.2.2 Wake Input Configuration

To ensure a defined and stable voltage levels at the internal comparator input it is possible to configure integrated current sources via the SPI register WK_PUPD_CTRL. An example illustration for the automatic switching configuration is shown in Figure 32.

Table 26 Pull-Up / Pull-Down Resistor

| WKx_PUPD_ <br> $\mathbf{1}$ | WKx_PUPD_ <br> $\mathbf{0}$ | Current Sources | Note |
| :--- | :--- | :--- | :--- |
| 0 | 0 | no current <br> source | WK input is floating if left open (default setting) |
| 0 | 0 | pull-down | WK input internally pulled to GND |
| 1 | 1 | pull-up | WK input internally pulled to internal 5V supply |
| 1 | Automatic <br> switching | If a High level is detected at the WK input the pull-up source <br> is activated, if Low level is detected the pull down is <br> activated. |  |

Note: If there is no pull-up or pull-down configured on the WK input, then the respective input should be tied to GND or VS on board to avoid unintended floating of the pin and subsequent wake-up events.


Figure 32 Illustration for Pull-Up / Down Current Sources with Automatic Switching Configuration

High-Voltage Wake and Voltage Monitoring Input

### 9.2.3 Wake configuration for Cyclic Sense

The wake input pin can also be used for cyclical sensing of monitoring signals during low-power modes. For this function the WK input performs a cyclic sensing of the voltage level during the On-time of the GPIO HS. A transition of the voltage level triggers a wake-up event.
In order to enable this functionality the GPIO must be configured as HS to be controlled by the Timer. See also Chapter 5.2.1 and Chapter 11.1.2 for more details.

### 9.2.4 High-Voltage Sensing as Alternate Function

This function provides the possibility to measure a voltage, e.g. the unbuffered battery voltage, with the protected WK HV-input pin. The measured voltage is routed out at FO/GPIO.
If this function is enabled with the WK_MEAS then neither the FO (including the FO test via FO_ON), nor the GPIO functionality nor the WK functionality are available.

## If the measurement function is enabled then following items should be noted:

- The internal pull-up / pull-down structures are disabled and the internal WK signal is gated (blocked)
- The settings for WK in the registers WK_PUPD_CTRL and WK_CTRL_1 are ignored (but changing the settings is not prevented)
- The wake capability and voltage monitoring of the WK pin is disabled, i.e. WK_STAT_0 and WK_LVL_STAT are not updated, i.e. the bits in WK_LVL_STAT are cleared
- If WK is the only valid wake source then the SPI_FAIL flag is set when trying to enter SBC Sleep Mode (see also Chapter 5.1) and SBC Restart Mode is entered

Please refer to Chapter 5.4 for more details on the functionality of the measurement unit.

High-Voltage Wake and Voltage Monitoring Input

### 9.3 Electrical Characteristics

## Table 27 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | Min. | Typ. | Max. |  |  |

## WK Input Pin Characteristics

| Wake-up/monitoring threshold voltage | $V_{\text {wKth }}$ | 2 | 3 | 4 | V | without external serial resistor $R_{\mathrm{S}}$ (with $R_{\mathrm{S}}$ : <br> DeltaV $\left.=I_{\mathrm{PD} / \mathrm{PU}} \times R_{\mathrm{S}}\right)$; hysteresis included | P_10.3.1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Threshold hysteresis | $V_{\text {WKNth,hys }}$ | 0.1 | - | 0.7 | V | without external serial resistor $R_{\mathrm{S}}$ (with $R_{\mathrm{S}}:$ DeltaV $\left.=I_{\mathrm{PD} / \mathrm{PU}} \times R_{\mathrm{S}}\right)$ | P_10.3.2 |
| WK pin Pull-up Current | $I_{\text {PU_WK }}$ | -20 | -10 | -3 | $\mu \mathrm{A}$ | $V_{\text {WK_IN }}=4 \mathrm{~V}$ | P_10.3.3 |
| WK pin Pull-down Current | $I_{\text {PD_WK }}$ | 3 | 10 | 20 | $\mu \mathrm{A}$ | $V_{\text {WK_IN }}=2 \mathrm{~V}$ | P_10.3.4 |
| Input leakage current | $I_{\text {LK, }}$ | -2 |  | 2 | $\mu \mathrm{A}$ | $0 \mathrm{~V}<V_{\text {WK_IN }}<40 \mathrm{~V}$ | P_10.3.5 |

## Timing

| Wake-up filter time 1 | $t_{\text {FWK1 }}$ | 13 | 16 | 20 | $\mu \mathrm{~S}$ | ${ }^{1)}$ | $P_{-} 10.3 .6$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

1) Not subject to production test, tolerance defined by internal oscillator tolerance

## Interrupt Function

## 10 Interrupt Function

### 10.1 Block and Functional Description



Figure 33 Interrupt Block Diagram

The interrupt is used to signalize special events in real time to the microcontroller. The interrupt block is designed as a push/pull output stage as shown in Figure 33. An interrupt is triggered and the INTN pin is pulled Low (active Low) for $\mathrm{t}_{\text {INTN }}$ in SBC Normal and Stop Mode and it is released once $\mathrm{t}_{\text {INTN }}$ is expired. The minimum High-time of INTN between two consecutive interrupts is $\mathrm{t}_{\text {INTND }}$. An interrupt does not cause a SBC mode change.
Two different interrupt classes could be selected via the SPI bit INT_ GLOBAL:

- Class 1 (wake interrupt - INT_ GLOBAL=0): all wake-up events stored in the wake status SPI registers (WK_STAT_0 and WK_STAT_1 if GPIO is configured as WK) cause an interrupt. The wake sources are listed below.
An interrupt is only triggered if the respective function is also enabled as a wake source (including GPIOx if configured as a wake input). The CAN time out signalization CANTO is also considered as a wake source. Therefore, the interrupt mask bit CANTO_MASK has higher priority than the bit INT_GLOBAL, i.e. the bit is not taken into account for CANTO.
- via CAN (wake-up or CAN Bus time out)
- via the WK pin
- via TIMER
- via GPIO (if configured as WK input)
- Class 2 (global interrupt - INT_ GLOBAL=1): in addition to the wake-up events, all signalled failures stored in the other status registers trigger an interrupt (the registers WK_LVL_STAT and FAM_PROD_STAT are not generating interrupts, neither will the selective wake registers SWK_STAT, SWK_OSC_CAL_H_STAT, SWK_OSC_CAL_L_STAT, SWK_ECNT_STAT, SWK_CDR_CTRL1, SWK_CDR_CTRL2)

Note: The errors that cause SBC Restart or SBC Fail-Safe Mode (VCC1_UV, WD_FAIL, VCC1_SC, TSD2_SAFE, TSD2, FAILURE) are the exceptions of an INTN generation on status bits. Also the bits POR and DEV_STAT_[1:0] will not generate interrupts.

Note: $\quad$ During SBC Restart Mode the SPI is blocked and the microcontroller is in reset. Therefore the INTN is not activated in SBC Restart Mode, which is the same behavior in SBC-Fail-Safe or Sleep Mode.

## TLE9461-3ES V33

## Lite CAN SBC Family

## Interrupt Function

In addition to this behavior, INTN is triggered when SBC Stop Mode is entered and not all wake source bits were cleared in the WK_STAT_Oand WK_STAT_1 register.
The SPI status registers are updated at every falling edge of the INTN pulse. All interrupt events are stored in the respective register (except the register WK_LVL_STAT) until the register is read and cleared via SPI command. A second SPI read after reading out the respective status register is optional but recommended to verify that the interrupt event is not present anymore. The interrupt behavior is shown in Figure $\mathbf{3 4}$ for class 1 interrupts. The behavior for class 2 is identical.
The INTN pin is also used during SBC Init Mode to select the hardware configuration of the device. See Chapter 5.1.1 for further information.


Figure 34 Interrupt Signalization Behavior

## Interrupt Function

### 10.2 Electrical Characteristics

## Table 28 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |

## Interrupt Output; Pin INTN

| INTN High Output Voltage | $V_{\text {INTN,H }}$ | $\begin{aligned} & 0.8 \times \\ & V_{\mathrm{CC} 1} \end{aligned}$ | - | - | V | $\begin{aligned} & \left.{ }^{11}\right)_{\text {INTN }}=-1 \mathrm{~mA} ; \\ & \text { INTN }=\text { Off } \end{aligned}$ | P_11.2.1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| INTN Low Output Voltage | $V_{\text {INTN,L }}$ | - | - | $\begin{aligned} & 0.2 \times \\ & V_{\mathrm{CC1}} \end{aligned}$ | V | $\begin{aligned} & { }^{1)} I_{\text {INTN }}=1 \mathrm{~mA} ; \\ & \text { INTN }=\text { On } \end{aligned}$ | P_11.2.2 |
| INTN Pulse Width | $t_{\text {INTN }}$ | 80 | 100 | 120 | $\mu \mathrm{s}$ | 2) | P_11.2.3 |
| INTN Pulse Minimum Delay Time | $t_{\text {INTND }}$ | 80 | 100 | 120 | $\mu \mathrm{s}$ | ${ }^{2)}$ between consecutive pulses | P_11.2.4 |

## Configuration Select; Pin INTN

| Config Pull-down <br> Resistance | $R_{\text {CFG }}$ | 150 | 250 | 320 | $\mathrm{k} \Omega$ | $V_{\text {INTN }}=3.3 \mathrm{~V}$ | P_11.2.5 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Config Select Filter Time | $t_{\text {CFG_F }}$ | 5 | 10 | 14 | $\mu \mathrm{~S}$ | ${ }^{2)}$ | P_11.2.6 |

1) Output Voltage Value also determines device configuration during SBC Init Mode
2) Not subject to production test, tolerance defined by internal oscillator tolerance.

## Lite CAN SBC Family

Fail Output (FO) and General Purpose I/O (GPIO)

## 11 Fail Output (FO) and General Purpose I/O (GPIO)

### 11.1 Block and Functional Description



Figure 35 Simplified Fail Output and GPIO Block Diagram

## Features

- Fail-Output Function to signalize fail-safe events (FO function)
- General Purpose I/O functionality in case the fail-output function is not needed (GPIO function)
- Output of HV Measurement function in case WK/SENSE is selected accordingly (WK_MEAS)

Fail Output (FO) and General Purpose I/O (GPIO)

### 11.1.1 Fail-Output Function

The fail output consists of a failure logic and an open-drain output (FO) with active-low signalization. It is the default configuration after device power-up to support fail-safe functions.
The fail output is activated due to following failure conditions:

- Watchdog trigger failure (For config $3 \& 4$ only after the 2 nd watchdog trigger failure and for config $1 \& 2$ after 1st watchdog trigger failure)
- Thermal shutdown TSD2
- VCC1 short to GND
- VCC1 over voltage (only if the SPI bit VCC1_OV_RST is set)

If FO is triggered, the SBC Fail-Safe Mode is entered (exceptions are watchdog trigger failures depending on selected configurations - see Chapter 5.1.1). The fail output activation is signalled in the SPI bit FAILURE of the register DEV_STAT.
The entry of SBC Fail-Safe Mode due to a watchdog failure can be configured as described in Chapter 5.1.1. If the FO was activated due to a failure then it stays activated (pulled Low) in all SBC Modes.
In order to deactivate the fail output in SBC Normal Mode the failure conditions must not be present anymore (e.g. TSD2, VCC1 short circuit, VCC1 over voltage - independent of the VCC1_OV_RST, etc) and the bit FAILURE must be cleared via SPI command. In case of a FAILURE bit is set due to a watchdog fail, a successful WD trigger is needed in addition, i.e. WD_FAIL must be cleared. WD_FAIL is also cleared when going to SBC Sleep or SBC Fail-Safe Mode due to another failure (not a WD failure) or if the watchdog is disabled in SBC Stop Mode.

For testing purposes only the Fail Output can be activated via SPI by setting the bit FO_ON. This bit is independent of the FO failure bits. In case there is no failure condition, the FO output can also be turned Off again via SPI, i.e. no successful watchdog trigger is needed.
In case FO was activated via the SPI bit FO_ON it is disabled when entering SBC Restart Mode and stays Off in SBC Normal Mode.

Note: $\quad$ The Fail output pin is triggered for any of the above described failures.
Note: $\quad$ The bit FO_ON can be written in any GPIO configuration. However, the fail-output pin FO/GPIO is only activated if GPIO is configured as FO, i.e. the bit is ignored for any other GPIO configuration.

Fail Output (FO) and General Purpose I/O (GPIO)

### 11.1.2 General Purpose I/O Function as Alternative Function

In case the FO functionality is not used, the pin can be configured with an alternative function as high-voltage (VS related) General Purpose I/O pin via the SPI bits GPIO.

To avoid unintentional changes of the respective GPIO function during operation the configuration can be locked via the SPI bit CFG_LOCK_0

## FO/GPIO can be reconfigured in SBC Normal Mode for the following functions:

- FO functionality (default state) when configured as GPIO ='000'...'010':
- Overcurrent shutdown and open load detection is disabled
- Off (also disabled in case FO1 is activated) when configured as GPIO ='100'
- Wake Input when configured as GPIO='101':
- There is a blanking time $\mathrm{t}_{\text {GPIO,WK,blank }}$ when FO/GPIO is configured as wake input. Only then the level detection becomes valid, i.e. the filter time $\mathrm{t}_{\mathrm{FWK} 1}$ is started.
- The pin can be used as a wake source. A level change is detected at the threshold $\mathrm{V}_{\text {GPIOI,th }}$. The wake capability can be enabled and disabled by setting the GPIO bits. Once configured as wake input it is automatically wake capable.
- wake-up events are stored and reported in WK_STAT_1; the bit GPIO_WK_WU is cleared when SBC Fail-Safe Mode is entered.
- Internal pull-up or pull-down structures are implemented and can be configured with the SPI bits GPIO_WK_PUPD.
- SBC Normal, Stop-, Init and Restart Mode: The input level is shown in the WK_LVL_STAT register
- SBC Normal and Stop Mode: INTN is triggered in case of a qualified edge change.
- SBC Restart Mode: The SPI is blocked and cannot be read; INTN is not triggered but GPIO_WK_WU is set.
- SBC Sleep Mode: The device is woken in case of a qualified edge change, i.e. VCC1 is enabled. WK_LVL_STAT is updated during SBC Sleep and Fail-Safe Mode but it can only be read when entering SBC Normal Mode again.
- Low-Side incl. PWM control when configured as GPIO ='110':
- The switch is controlled by the PWM generator: $0 \%$ DC = Off and $100 \%$ DC $=0 n$; any other duty cycle can be configured in PWM_CTRL.

The PWM frequency can be selected in PWM_FREQ_CTRL

- The respective level at the pin is shown in WK_LVL_STAT in SBC Normal, Stop-, Init and Restart Mode and can serve as a feedback about the respective switch state ${ }^{1)}$
- On-state overcurrent shutdown is implemented. In PWM operation the diagnosis is active only during the LS On-time.
The bit GPIO_OC shows an over current shutdown respectively and the switch is disabled.
Depending on the duty cycle the diagnosis might not be activated considering the respective filter timing.
- High-Side incl. PWM control when configured as GPIO ='111':

[^0]Fail Output (FO) and General Purpose I/O (GPIO)

- The switch is controlled by the PWM generator: $0 \%$ DC = Off and $100 \%$ DC = On; any other duty cycle can be configured in PWM_CTRL.

The PWM frequency can be selected in PWM_FREQ_CTRL

- The respective level at the pin is shown in WK_LVL_STAT in SBC Normal, Stop-, Init and Restart Mode and can serve as a feedback about the respective switch state ${ }^{1)}$
- On-state open load detection and overcurrent shutdown is implemented. During PWM operation the diagnosis is active only during the HS On-time. In case of open load detection the bit GPIO_OL is set.
In case of over current detection the bit GPIO_OC is set and the switch is shut down.
Depending on the duty cycle the diagnosis might not be activated considering the respective filter time
- High-Side with Cyclic Sense functionality when configured as GPIO = '011':
- The HS is used in combination with the WK pin and is controlled by the Timer. Cyclic Sense does not work if the GPIO is not configured accordingly.
- The configuration for Cyclic Sense, e.g. the period and On-time of the Cyclic Sense function is done via the registers TIMER_CTRL, WK_CTRL_1, WK_PUPD_CTRL
- A learning cycle is always started if the timer is started via the On-time and GPIO is configured as HS with Cyclic Sense = '011'
- Overcurrent shutdown is active only during the HS On-time: In case of over current detection the bit GPIO_OC is set and the switch is shut down. The timer keeps running, i.e. Cyclic Wake is still available. The open load detection is not available in this configuration.
- WK_LVL_STAT is not updated
- See Chapter 5.2.1 and Chapter 9.2 for more information about Cyclic Sense

Note: It must be ensured that the correct GPIO configuration is selected after device power-up to ensure proper functionality.
It is recommended to use the CFG_LOCK_O bit to avoid unintentional configuration changes. It is not recommended to change the GPIO configuration during the operation to avoid misleading SPI status bit settings (e.g. wake-up event, over current, open load) or unexpected timings due to shared PWM generator.

Note: $\quad$ Before GPIO is be configured as HS or LS with PWM Control the PWM_CTRL register must be set .
Note: $\quad$ The internally stored default value used for the wake-input configuration is 'Low'. A level change is signalized via the bit GPIO_WK_WU in case the externally connected signal on FO/GPIO is 'High'. If there is a level change at the FO/GPIO pin while configuring the wake function then a wake-up event can occur as there is no internal learning cycle and the last filtered value is used as a reference.

## Shutdown behavior in case of low-side or high-side configuration (incl. Cyclic Sense \& PWM):

- The switch is disabled in case of over current detection with low- or high-side configuration, SBC Restart or Fail-Safe Mode entry
- The SPI bits are set to GPIO = Off = ' 100 '
- The switch stays Off until it is enabled again via the GPIO bits,
- In case CFG_LOCK_0 is set, then the bit must first be cleared before the configuration can be enabled again. Then the lock bit should be set again
- The switch can be enabled even if GPIO_OL or GPIO_OC bit is set.

Fail Output (FO) and General Purpose I/O (GPIO)

- A VS_UV condition is not affecting the behavior of the GPIO.

Note: $\quad$ After a short-circuit event for either low-side or high-side configuration a minimum recovery time of 25 us must be ensured before enabling the respective function again!

Note: If FO is not enabled then FO/GPIO is also not activated in case of failures. Also the FAILURE bit is set but it can be cleared. In addition, it is not possible to activate FO/GPIO via FO_ON in this case.

## Restart and Soft-Reset Behavior:

The behavior during SBC Restart and Fail-Safe Mode as well as the transition to SBC Normal Mode is as follows:

- if configured as Wake Input: it will stay wake capable during SBC Restart Mode and is an automatic wake source in SBC Fail-Safe Mode. WK_LVL_STAT is updated but it can only be read when entering again SBC Normal Mode.
- if configured as Low-Side or High-Side: The switch is disabled during SBC Restart and Fail-Safe Mode. They stay Off when returning to SBC Normal Mode and can be enabled again via SPI (Restart value is 'Off').
- if configured as FO and activated due to a failure: FO stays activated during SBC Restart Mode and when entering SBC Normal Mode (SPI register is not modified).
- In case of a SBC Soft Reset command the GPIO configuration remains unchanged if CFG_LOCK_0 is set but the settings for Timer and PWM register are reset.

The detailed behavior for the respective configurations and SBC modes is listed in below table:

| FO Configuration | SBC Normal Mode | SBC Stop Mode | SBC Sleep Mode | SBC Restart <br> Mode | SBC Fail-Safe Mode |
| :---: | :---: | :---: | :---: | :---: | :---: |
| FO (default) | configurable | fixed | fixed | active / fixed | active |
| Off |  | Off | Off | Off | Off |
| Wake Input |  | wake capable | wake capable | wake capable | wake capable |
| Low-Side |  | fixed | fixed | Off | Off |
| High-Side |  | fixed | fixed | Off | Off |

Note: $\quad$ Above mentioned behavior also applies to the PWM operation for LS and HS and for HS Cyclic Sense function.

## Explanation of GPIO states:

- configurable: settings can be changed in this SBC mode
- fixed: settings stay as configured in SBC Normal Mode
- active: FO is activated due to a failure leading to SBC Restart or Fail-Safe Mode.

Fail Output (FO) and General Purpose I/O (GPIO)

### 11.1.3 WK and FO/GPIO HV-Sensing Function as Alternative Function

This function provides the possibility to measure a voltage, e.g. the unbuffered battery voltage, with the protected WK HV-input. The measured voltage is routed out at FO/GPIO.
If this function is enabled with the WK_MEAS then neither the FO (including the FO test via FO_ON) nor the GPIO functionality is available. Trying to enable the FO/GPIO functionality sets the SPI_FAIL flag.

## If the measurement function is enabled the following items must be noted:

- The internal pull-up / pull-down structures are disabled and the internal WK signal is gated (blocked)
- The register WK_PUPD_CTRL can be modified but functionality changes are ignored. The GPIO_CTRL cannot be modified while WK_MEAS = ' 1 '. WK_MEAS cannot be set if FO is configured. In this case SPI_FAIL is set.
FO must be set to Off first.
- The wake capability and voltage monitoring of the WK pin is disabled, i.e. WK_STAT_1 and WK_LVL_STAT are not updated
- If GPIO WK is the only valid wake source then the SPI_FAIL flag is set when trying to enter SBC Sleep Mode (see also Chapter 5.1) and SBC Restart Mode is entered

Please refer to Chapter 5.4 for more details on the functionality of the measurement unit.

Fail Output (FO) and General Purpose I/O (GPIO)

### 11.2 Electrical Characteristics

Table 30 Electrical Characteristics
$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| FO and Alternative Function GPIO |  |  |  |  |  |  |  |
| FO Low-Side output voltage (active) | $V_{\text {FO,L1 }}$ | - | - | 1 | V | If configured as FailOutput; $I_{\mathrm{FO}}=4.0 \mathrm{~mA}$ | P_12.2.1 |
| GPIO Low-Side output voltage (active) | $V_{\text {GPIoL,LI }}$ | - | - | 1 | V | If configured as LowSide Switch $\mathrm{I}_{\mathrm{GPIO}}=30 \mathrm{~mA}$ | P_12.2.3 |
| GPIO Low-Side output voltage (active) | $V_{\text {GPIOL,L2 }}$ | - | - | 5 | mV | ${ }^{1)}$ If configured as Low-Side Switch; $I_{\mathrm{GPIO}}=100 \mu \mathrm{~A}$ | P_12.2.4 |
| GPIO High-Side output voltage (active) | $V_{\text {GPIOH,H1 }}$ | VS-1 | - | - | V | If configured as HighSide Switch; $I_{\mathrm{GPO}}=-30 \mathrm{~mA}$ | P_12.2.5 |
| GPIO High-Side output voltage (active) | $V_{\text {GPIOH,H2 }}$ | VS-5 | - | - | mV | ${ }^{1)}$ If configured as High-Side Switch; $I_{\text {GPO }}=-100 \mu \mathrm{~A}$ | P_12.2.6 |
| GPIO input threshold voltage (WK config) | $V_{\text {GPIOI,th }}$ | 1.5 | 2.5 | 3.5 | V | hysteresis included; pull-up / pull-down sources disabled | P_12.2.7 |
| GPIO input threshold hysteresis (WK config) | $V_{\text {GPIOI,hys }}$ | 0.6 | 0.9 | 1.3 | V | ${ }^{1)}$ pull-up / pull-down sources disabled | P_12.2.8 |
| GPIO input filter time (WK config) | $t_{\text {F_GPIO_WK }}$ | 13 | 16 | 20 | $\mu \mathrm{s}$ | 2) | P_12.2.19 |
| FO/GPIO input leakage current (all inactive) | $I_{\text {GPIO,LK }}$ | -2 | - | 2 | $\mu \mathrm{A}$ | $\mathrm{OV}<\mathrm{V}_{\text {GPIO }}<\mathrm{VS}$ | P_12.2.9 |
| GPIO wake input activation blanking time | $t_{\text {GPIO,WK,blank }}$ | 24 | 30 | 40 | $\mu \mathrm{s}$ | ${ }^{2)}$ after enabling as wake input | P_12.2.10 |
| GPIO LS overcurrent Shutdown Threshold | $I_{\text {GPIOL,SD }}$ | 30 | - | 65 | mA | $V_{\text {GPIO }}=\mathrm{VS}$, hysteresis included | P_12.2.11 |
| GPIO HS overcurrent Shutdown Threshold | $I_{\text {GPIOH,SD }}$ | -65 | - | -30 | mA | $V_{\text {GPIO }}=0 \mathrm{~V}$, hysteresis included | P_12.2.12 |
| GPIO overcurrent shutdown filter time | $t_{\text {GPIO,OC }}$ | 20 | 26 | 32 | $\mu \mathrm{s}$ | ${ }^{2)}$ applies for HS and LS configuration | P_12.2.13 |
| GPIO HS open load detection | $I_{\text {GPIOH,OL }}$ | -3.0 | - | -0.5 | mA | in On-state, hysteresis included | P_12.2.15 |

Fail Output (FO) and General Purpose I/O (GPIO)
Table 30 Electrical Characteristics (cont'd)
$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V} ; T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | Min. | Typ. | Max. |  | $2)$ | $P_{-} 12.2 .16$ |
| GPIO open load <br> detection filter time |  | 51 | 64 | 80 | $\mu \mathrm{~S}$ | $2)$ | $P_{-} 12.3 .17$ |
| GPIO WK pin Pull-up <br> Current | $I_{\text {PU_GPIO,WK }}$ | -20 | -10 | -3 | $\mu \mathrm{~A}$ | $V_{\text {GPIO,WK_IN }}=3.5 \mathrm{~V}$ |  |
| GPIO WK pin Pull-down <br> Current | $I_{\text {PD_GPIO,WK }}$ | 3 | 10 | 20 | $\mu \mathrm{~A}$ | $V_{\text {GPIO,WK_IN }}=1.5 \mathrm{~V}$ | $P_{-12.3 .18}$ |

1) Not subject to production test, specified by design.
2) Not subject to production test, tolerance defined by internal oscillator tolerance

Supervision Functions

## 12 Supervision Functions

### 12.1 Reset Function



Figure 36 Reset Block Diagram

### 12.1.1 Reset Output Description

The reset output pin RSTN provides a reset information to the microcontroller, e.g. in the event that the output voltage has fallen below the undervoltage threshold $V_{\mathrm{RT} 1 / 2 / 3 / 4}$. In case of a reset event, the reset output RSTN is pulled to Low after the filter time $\mathrm{t}_{\mathrm{RF}}$ and stays Low as long as the reset event is present and the configurable reset delay time has not expired. The reset delay time can be configured. The default value is the extended reset delay time $\mathbf{t}_{\text {RD1 }}$ and the reduced reset delay time $\mathbf{t}_{\text {RD2 }}$ can be selected by setting RSTN_DEL. When connecting the SBC to battery voltage, the reset signal remains Low initially. When the output voltage $V_{\text {cc1 }}$ has reached the reset default threshold $V_{\text {RT1,r }}$, the reset output RSTN is released to High after the reset delay time $t_{R D 1}$. A reset can also occur due to a watchdog trigger failure. The reset threshold can be adjusted via SPI, the default reset threshold is $\mathrm{V}_{\text {RT1,f: }}$. The RSTN pin has an integrated pull-up resistor. In case reset is triggered, it is pulled Low for $\mathbf{V}_{\mathbf{c c 1}} \geq 1 \mathrm{~V}$ and for $\mathrm{VS} \geq \mathbf{V}_{\text {PoR,f }}$ (see also Chapter 12.3).
The timings for the RSTN triggering regarding VCC1 undervoltage and watchdog trigger is shown in Figure 37.

Supervision Functions


Figure 37 Reset Timing Diagram

### 12.1.2 Soft Reset Description

In SBC Normal and SBC Stop Mode, it is also possible to trigger a device internal reset via a SPI command in order to bring the SBC into a defined state in case of failures. In this case the microcontroller must send a SPI command and set the MODE bits to ' 11 ' in the M_S_CTRL register. As soon as this command becomes valid, the SBC is set back to SBC INIT Mode and all SPI registers are set to their default values (see SPI Chapter 13.5 and Chapter 13.6).
Two different soft reset configurations are possible via the SPI bit SOFT_RESET_RST:

- SOFT_RESET_RST = ' 0 ': The reset output (RSTN) is triggered when the soft reset is executed (default setting, the same reset delay time $\mathbf{t}_{\text {RD1 }}$ applies)
- SOFT_RESET_RST = ' 1 ': The reset output (RSTN) is not triggered when the soft reset is executed

Note: $\quad$ The device must be in SBC Normal Mode or SBC Stop Mode when sending this command. Otherwise, the command is ignored.

## Supervision Functions

### 12.2 Watchdog Function

The watchdog is used to monitor the software execution of the microcontroller and to trigger a reset if the microcontroller stops serving the watchdog due to a lock up in the software.
Two different types of watchdog functions are implemented and can be selected via the bit WD_WIN:

- Time-Out Watchdog (default value)
- Window Watchdog

The respective watchdog functions can be selected and programmed in SBC Normal Mode. The configuration stays unchanged in SBC Stop Mode.
Please refer to Table 31 to match the SBC Modes with the respective watchdog modes.

Table 31 Watchdog Functionality by SBC Modes

| SBC Mode | Watchdog Mode | Remarks |
| :--- | :--- | :--- |
| INIT Mode | Starts with Long Open <br> Window | Watchdog starts with Long Open Window after RSTN <br> is released |
| Normal Mode | WD Programmable | Window Watchdog, Time-Out watchdog or switched <br> Off for SBC Stop Mode |
| Stop Mode | Watchdog is fixed or Off | Off |
| Sleep Mode | Off | SBC starts with Long Open Window when entering <br> SBC Normal Mode. |
| Restart Mode | SBC starts with Long Open Window when entering <br> SBC Normal Mode. |  |

The watchdog timing is programmed via SPI command in the register WD_CTRL. As soon as the watchdog is programmed, the timer starts with the new setting and the watchdog must be served. The watchdog is triggered by sending a valid SPI-write command to the watchdog configuration register. The watchdog trigger command is executed when the SPI command is interpreted, i.e. 3 clock cycles (typ. $3 \mu \mathrm{~s}$ ) after the transition of Chip Select input (CSN) from Low to High.
When coming from SBC Init, SBC Restart Mode or in certain cases from SBC Stop Mode, the watchdog timer is always started with a long open window. The long open window ( $\mathrm{t}_{\mathrm{Lw}}=200 \mathrm{~ms}$ ) allows the microcontroller to run its initialization sequences and then to trigger the watchdog via SPI.
The watchdog timer period can be selected via the watchdog timing bit field (WD_TIMER) and is in the range of 10 ms to 10000 ms . This setting is valid for both watchdog types.
The following watchdog timer periods are available:

- WD Setting 1: 10 ms
- WD Setting 2: 20ms
- WD Setting 3: 50 ms
- WD Setting 4: 100 ms
- WD Setting 5: 200ms
- WD Setting 6: 500ms
- WD Setting 7: 1000 ms
- WD Setting 8: 10000 ms

In case of a watchdog reset, SBC Restart or SBC Fail-Safe Mode is entered according to the configuration and the SPI bits WD_FAIL are set. Once the RSTN goes High again the watchdog immediately starts with a long open window the SBC enters automatically SBC Normal Mode.

## Supervision Functions

In SBC Development Mode the watchdog is Off and therefore no reset is generated due to a watchdog failure.

Depending on the configuration, the WD_FAIL bits are set after a watchdog trigger failure as follows:

- In case an incorrect WD trigger is received (triggering in the closed watchdog window or when the watchdog counter expires without a valid trigger) then the WD_FAIL bits are incremented (showing the number of incorrect WD triggers)
- For config 2: the bits can have the maximum value of ' 01 '
- For config 1, 3 and 4 : the bits can have the maximum value of ' 10 '

The WD_FAIL bits are cleared automatically if following conditions apply:

- After a successful watchdog trigger
- When the watchdog is Off: in SBC Stop Mode after successfully disabling the watchdog, in SBC Sleep Mode, or in SBC Fail-Safe Mode (except for a watchdog failure)


### 12.2.1 Time-Out Watchdog

The time-out watchdog is an easier but less secure watchdog than a window watchdog because the watchdog trigger can be set at any time within the configured watchdog timer period.
A correct watchdog service immediately results in starting a new watchdog timer period. Taking the tolerances of the internal oscillator into account the safe trigger area is defined in Figure 38.
If the time-out watchdog period elapses, a watchdog reset is created by setting the reset output RSTN Low and the SBC switches to SBC Restart or SBC Fail-Safe Mode.


Figure 38 Time-out Watchdog Definitions

### 12.2.2 Window Watchdog

Compared to the time-out watchdog the characteristic of the window watchdog is that the watchdog timer period is divided into a closed and an open window. The watchdog must be triggered within the open window. A correct watchdog trigger results in starting the window watchdog period with a closed window followed by an open window.

## Supervision Functions

The watchdog timer period is also the typical trigger time and defines the middle of the open window. Taking the oscillator tolerances into account leads to a safe trigger area of:
$\mathrm{t}_{\text {wD }} \times 0.72$ < safe trigger area $<\mathrm{t}_{\text {wD }} \times 1.20$.
The typical closed window is defined to a width of $60 \%$ of the selected window watchdog timer period. Taking the tolerances of the internal oscillator into account leads to the timings as defined in Figure 39.
A correct watchdog service immediately results in starting the next closed window.
If the trigger signal meets the closed window or the watchdog timer period elapses, then a watchdog reset is created by setting the reset output RSTN Low and the SBC switches to SBC Restart or SBC Fail-Safe Mode.


Figure 39 Window Watchdog Definitions

### 12.2.3 Watchdog Setting Check Sum

A check sum bit is part of the SPI command to trigger the watchdog and to set the watchdog setting.
The sum of the 8 data bits in the register WD_CTRL needs to have even parity (see Equation (12.1)). This is realized by either setting the bit CHECKSUM to 0 or 1 . If the check sum is wrong, then the SPI command is ignored, i.e. the watchdog is not triggered or the settings are not changed and the bit SPI_FAIL is set.
The checksum is calculated by taking all 8 data bits into account. The written value of the reserved bit 3 of the WD_CTRL register is considered (even if read as ' 0 ' in the SPI output) for checksum calculation, i.e. if a ' 1 ' is written on the reserved bit position, then a ' 1 ' is used in the checksum calculation.

$$
\mathrm{CHKSUM}=\mathrm{Bit} 15 \oplus \ldots \oplus \text { Bit } 8
$$

### 12.2.4 Watchdog during SBC Stop Mode

The watchdog can be disabled for SBC Stop Mode in SBC Normal Mode. For safety reasons a special sequence must be followed in order to disable the watchdog as described in Figure 40. Two different SPI bits (WD_STM_ EN_O, WD_STM_EN_1) in the registers WK_CTRL_0 and WD_CTRL need to be set.

Supervision Functions


Figure 40 Watchdog disabling sequence in SBC Stop Mode

If a sequence error occurs, then the bit WD_STM_EN_1 is cleared and the sequence has to be started again.
The watchdog can be enabled by triggering the watchdog in SBC Stop Mode or by switching back to SBC Normal Mode via SPI command. In both cases the watchdog starts with a long open window and the bits WD_STM_EN_1 and WD_STM_EN_0 are cleared. After the long open window the watchdog has to be served as configured in the WD_CTRL register.

Note: $\quad$ The bit WD_STM_EN_O is cleared automatically when the sequence is started and it was ' 1 ' before. WD_STM_EN_0 can also not be set if WD_STM_EN_1 isn't yet set.

### 12.2.5 Watchdog Start in SBC Stop Mode due to Bus Wake

In SBC Stop Mode the Watchdog can be disabled. In addition a feature is available that starts the watchdog with any Bus wake (CAN) during SBC Stop Mode. This feature is enabled by setting the bit WD_EN_WK_BUS=1 (= default value after POR). The bit can only be changed in SBC Normal Mode and needs to be programmed before starting the watchdog disabling sequence.
A wake on CAN generates an interrupt and the RXD pin for CAN is pulled to Low. By these signals the microcontroller is informed that the watchdog is startedwith a long open window. After the long open window the watchdog has to be served as configured in the WD_CTRL register.
To disable the watchdog again, the SBC has to be switched to Normal Mode and the sequence has to be sent again.

## Supervision Functions

### 12.3 VS Power-On Reset

At power up of the device, the VS Power-on Reset is detected when VS $>\mathbf{V}_{\text {POR,r }}$ and the SPI bit POR is set to indicate that all SPI registers are set to POR default settings. VCC1 is starting up and the reset output RSTN is kept Low. It will only be released once VCC1 has crossed $V_{R T 1, r}$ and $\mathbf{t}_{\text {RD1 }}$ has elapsed.
In case VS $<\mathbf{V}_{\text {POR,f }}$, a device internal reset is generated and the SBC is switched Off and restarts in INIT mode with the next VS rising. This is shown in Figure 41.


Figure 41 Ramp up / down example of Supply Voltage

Supervision Functions

### 12.4 VS Under- and Overvoltage

### 12.4.1 VS Undervoltage

The VS under-voltage monitoring is always active in SBC Init-, Restart- and Normal Mode (see below conditions for SBC Stop Mode). If the supply voltage VS reaches the undervoltage threshold $\mathbf{V}_{\mathbf{s}, \mathrm{uv}}$ then the SBC triggers the following actions:

- SPI bit VS_UV is set. No other error bits are set. The bit can be cleared once the VS undervoltage condition is not present anymore
- The VCC1 short circuit protection becomes inactive (see Chapter 12.6). However, the thermal protection of the device remains active. If the undervoltage threshold is exceeded (VS rising) then the function is automatically enabled again

Note: $\quad$ VS under-voltage monitoring is not available in SBC Stop Mode due to current consumption saving requirements except if the VCC1 load current is above the active peak threshold (I_PEAK_TH) or if VCC1 is below the VCC1 prewarning threshold.

### 12.4.2 VS Overvoltage

The VS over-voltage monitoring is always active SBC Init-, Restart- and Normal Mode (see below note for conditions in SBC Stop Mode) or when the charge pump is enabled. If the supply voltage VS reaches the overvoltage threshold $\mathbf{V}_{\mathbf{s}, \mathbf{o v}}$ then the SBC does the following measures:

- SPI bit VS_OV is set. This bit is intended for diagnosis only, i.e. or other error bits are set. The bit can be cleared once the VS over-voltage condition is not present anymore
If the charge pump is disabled after the bit $\mathbf{V}_{\mathbf{s}, \mathrm{ov}}$ was set then the bit will stay set until it is cleared via SPI.
Note: $\quad$ VS over-voltage monitoring is not available in SBC Stop Mode due to current consumption saving requirements except if the VCC1 load current is above the active peak threshold (I_PEAK_TH) or if VCC1 is below the VCC1 prewarning threshold.


### 12.5 VCC1 Over-/ Undervoltage and Undervoltage Prewarning

### 12.5.1 VCC1 Undervoltage and Undervoltage Prewarning

This function is always active when the VCC1 voltage regulator is enabled. The supervision is implemented at the pin VIO (VIO must be connected to VCC1).
A first-level voltage detection threshold is implemented as a prewarning for the microcontroller. The prewarning event is signaled with the bit VCC1_ WARN. No other actions are taken.
As described in Chapter 12.1 and Figure 42, a reset is triggered (RSTN pulled Low) when the $V_{\text {CC1 }}$ output voltage falls below the selected undervoltage threshold ( $\mathrm{V}_{\mathrm{RTx}}$ ). The SBC enters SBC Restart Mode and the bit VCC1_UV is set when RSTN is released again.

The hysteresis of the VCC1 undervoltage threshold can be increased by setting the bit RSTN_HYS. In this case always the highest rising threshold (Vrt1,r) is used for the release of the undervoltage reset. The falling reset threshold remains as configured.

Note: $\quad$ The VCC1_ WARN or VCC1_UV bits are not set in Sleep Mode as $V_{C C 1}=0 V$ in this case


Figure 42 VCC1 Undervoltage Timing Diagram

Note: It is recommended to clear the VCC1_ WARN and VCC1_UV bit once it is detected by the microcontroller software to verify whether the undervoltage is still present.

### 12.5.2 VCC1 Overvoltage

For fail-safe reasons a configurable VCC1 over voltage detection feature is implemented. It is active when the VCC1 voltage regulator is enabled. The supervision is implemented at the pin VIO (VIO must be connected to VCC1).
In case the $\mathrm{V}_{\mathrm{CC1}, \mathrm{OV}, \mathrm{r}}$ threshold is crossed, the SBC triggers following measures (depending on the configuration):

- The bit VCC1_OV is always set;
- If the bit VCC1_OV_RST is set and CFGO_STATE = ' 1 ', then SBC Restart Mode is entered. The FO output is activated. After the reset delay time ( $\mathbf{t}_{\text {RDI }}$ ), the SBC Restart Mode is left and SBC Normal Mode is resumed even if the VCC1 over voltage event is still present (see also Figure 43). The VCC1_OV_RST bit is cleared automatically;
- If the bit VCC1_OV_RST is set and CFGO_STATE = ' 0 ', then SBC Fail-Safe Mode is entered and FO output is activated.

Note: External noise could be coupled into the VCC1 supply line. Especially, in case the VCC1 output current in SBC STOP Mode is below the active peak threshold (I IVC1,Ipeak $)$ the bit VCC1_OV_RST must be set to '0'before entering SBC Stop Mode to avoid unintentional SBC Restart or Fail-Safe Mode entry and to ignore the VCC1_ OV bit due to external noise.


Figure 43 VCC1 Over Voltage Timing Diagram

### 12.6 VCC1 Short Circuit Diagnostics

The supervision is implemented at the pin VIO (VIO must be connected to VCC1).
The short circuit protection feature for $V_{\text {CC1 }}$ is implemented as follows:

- The short circuit detection is only enabled if $\mathrm{VS}>\mathbf{V}_{\mathbf{s}, \mathrm{uv}}$.
- If VCC1 is not above the $\mathrm{V}_{\mathrm{RTx}}$ within $\mathrm{t}_{\mathrm{vCc} 1, \mathrm{sc}}$ after device power up or after waking from SBC Sleep or FailSafe Mode (i.e. after VCC1 is enabled) then the SPI bit VCC1_SC bit is set, VCC1 is turned Off, the FO pin is enabled, FAILURE is set and SBC Fail-Safe Mode is entered. The SBC can be activated again via a wake-up on CAN and WK or GPIO if configured as wake input.
- The same behavior applies, if $V_{\mathrm{CC1}}$ falls below $\mathrm{V}_{\mathrm{RTx}}$ for longer than $\mathbf{t}_{\mathrm{vCC1}, \mathrm{sc}}$.


### 12.7 VCC2 Undervoltage and VCAN Undervoltage

An undervoltage warning is implemented for VCC2 and VCAN as follows:

- $V_{\mathrm{CC} 2}$ undervoltage detection: In case $V_{\mathrm{CC} 2}$ is enabled and drops below the $\mathrm{V}_{\mathrm{CC} 2, \mathrm{UV}, \mathrm{f}}$ threshold, then the SPI bit VCC2_UV is set and can be only cleared via SPI. During power-up the blanking time $\mathbf{t}_{\text {vcc2,Blank }}$ applies, i.e. no undervoltage warning bit is set during this time.
- $\quad V_{\text {CAN }}$ undervoltage detection: In case the CAN module is enabled and the voltage on $V_{\text {CAN }}$ drops below the $\mathrm{V}_{\text {CAN_UV,f }}$ threshold, then the SPI bit VCAN_UV is set and can be only cleared via SPI.

Note: $\quad$ The VCC2_UV flag is not set during turn-On or turn-Off of $V_{C C 2}$.

## Supervision Functions

### 12.8 Thermal Protection

Three independent and different thermal protection features are implemented in the SBC according to the system impact:

- Individual thermal shutdown of specific blocks
- Temperature prewarning of main microcontroller supply VCC1
- SBC thermal shutdown due to VCC1 overtemperature


### 12.8.1 Individual Thermal Shutdown

As a first-level protection measure the output stages VCC2 and CAN are independently switched Off if the respective block reaches the temperature threshold $T_{j T S D 1 \_1} / T_{j T S D 1 \_2}$. Then the TSD1 bit is set. This bit can only be cleared via SPI once the overtemperature is not present anymore. Independent of the SBC Mode the thermal shutdown protection is only active if the respective block is On.
The respective modules behave as follows:

- VCC2: Is switched to Off and the control bits VCC2_ON are cleared. The status bit VCC2_OT is set. Once the overtemperature condition is not present anymore, then VCC2 has to be configured again by SPI.
- CAN: The transmitter is disabled and stays in CAN Normal Mode acting like CAN Receive only mode. The status bits CAN_FAIL = ' 01 ' are set. Once the overtemperature condition is not present anymore, then the CAN transmitter is automatically switched On.

Note: $\quad$ The diagnosis bits are not cleared automatically and have to be cleared via SPI once the overtemperature condition is not present anymore.

### 12.8.2 Temperature Prewarning

As a next level of thermal protection a temperature prewarning is implemented. If the main supply VCC1 exceeds the thermal prewarning temperature threshold $T_{j P W}$. Then the status bit TPW is set. This bit can only be cleared via SPI once the overtemperature is not present anymore.

### 12.8.3 SBC Thermal Shutdown

As the highest level of thermal protection a temperature shutdown of the SBC is implemented if the main supply VCC1 reaches the thermal shutdown temperature threshold $T_{j T S D 1 \_1} / T_{j T S D 1 \_2}$. Once a TSD2 event is detected SBC Fail-Safe Mode is entered. Only when device temperature falls below the TSD2 threshold then the device remains in SBC Fail-Safe Mode for $\mathrm{t}_{\mathrm{TSD2}}$ to allow the device to cool down. After this time has expired, the SBC automatically changes via SBC Restart Mode to SBC Normal Mode (see also Chapter 5.1.6).
When a TSD2 event is detected, then the status bit TSD2 is set. This bit can only be cleared via SPI in SBC Normal Mode once the overtemperature is not present anymore.
For increased robustness it is possible to extend the TSD2 waiting time by $64 x$ of $t_{\text {TSD2 }}$ after 16 consecutive TSD2 events by setting the SPI bit TSD2_DEL. The counter is incremented with each TSD2 event even if the bit TSD2 is not cleared. Once the counter has reached the value 16, then the bit TSD2_SAFE is set and the extended TSD2 waiting time is active. The extended waiting time is kept until TSD2_SAFE is cleared. The TSD counter is cleared when TSD2 or TSD2_DEL is cleared.

Note: In case a TSD2 overtemperature occurs while entering SBC Sleep Mode then SBC Fail-Safe mode is entered.

Note: $\quad$ To enable higher ambient temperatures the thermal shutdown thresholds can be increased by 10K for TSD1 and TSD2 by setting the bit TSD_THR.

## Supervision Functions

### 12.9 Electrical Characteristics

## Table 32 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| VCC1 Monitoring; |  |  |  |  |  |  |  |
| VCC1 UV Prewarning Detection Filter Time | $t_{\text {VCC1,PW_F }}$ | 5 | 10 | 14 | us | ${ }^{3)}$ rising and falling | P_13.9.4 |
| Undervoltage Prewarning Threshold Voltage PW,f | $V_{\text {PW,f }}$ | 3.0 | 3.1 | 3.2 | V | VCC1 falling, SPI bit is set | P_13.9.14 |
| Undervoltage Prewarning Threshold Voltage PW,r | $V_{\text {PW,r }}$ | 3.04 | 3.14 | 3.24 | V | VCC1 rising | P_13.9.15 |
| Undervoltage Prewarning Threshold Voltage hysteresis | $V_{\text {PW, hys }}$ | 15 | 40 | 55 | mV | 5) | P_13.9.16 |
| Reset Threshold Voltage RT1,f | $V_{\text {RT1, }}$ | 2.95 | 3.05 | 3.15 | V | default setting; VCC1 falling | P_13.9.17 |
| Reset Threshold Voltage RT1,r | $V_{\text {RT1, }}$ | 3.04 | 3.13 | 3.23 | V | default setting; VCC1 rising | P_13.9.18 |
| Reset Threshold Voltage RT2,f | $V_{\text {RT2,f }}$ | 2.45 | 2.55 | 2.65 | V | VCC1 falling | P_13.9.19 |
| Reset Threshold Voltage RT2,r | $V_{\text {RT2,r }}$ | 2.55 | 2.65 | 2.75 | V | VCC1 rising | P_13.9.20 |
| Reset Threshold Voltage RT3,f | $V_{\text {RT3,f }}$ | 2.14 | 2.25 | 2.35 | V | SPI option; VS $\geq 4 \mathrm{~V}$; VCC1 falling | P_13.9.21 |
| Reset Threshold Voltage RT3,r | $V_{\text {RT3,r }}$ | 2.24 | 2.35 | 2.45 | V | $V S \geq 4 V$ <br> VCC1 rising | P_13.9.22 |
| Reset Threshold Voltage RT4,f | $V_{\text {RT4,f }}$ | 1.65 | 1.75 | 1.85 | V | $V S \geq 4 V$ <br> VCC1 falling | P_13.9.23 |
| Reset Threshold Voltage RT4,r | $V_{\text {RT4, }}$ | 1.75 | 1.85 | 1.95 | V | VS $\geq 4 \mathrm{~V}$; VCC1 rising, | P_13.9.24 |
| Reset Threshold Hysteresis | $V_{\text {RT, hys }}$ | 45 | 90 | 140 | mV | 5) | P_13.9.25 |

## Supervision Functions

Table 32 Electrical Characteristics (cont'd)
$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| VCC1 Over Voltage Detection Threshold Voltage | $V_{\text {CC1, OV, } \mathrm{r}}$ | 3.7 | 3.85 | 4.0 | V | ${ }^{155)}$ rising VCC1 | P_13.9.28 |
| VCC1 Over Voltage Detection Threshold Voltage | $V_{\text {CC1, OV,f }}$ | 3.6 | 3.75 | 3.9 | V | ${ }^{5}$ falling VCC1 | P_13.9.29 |
| VCC1 Over Voltage Detection hysteresis | $V_{\text {CC1,0v, hys }}$ | 50 | 100 | 200 | mV | 5) | P_13.9.30 |
| VCC1 OV Detection Filter Time | $t_{\text {vcCl, ov_F }}$ | 51 | 64 | 80 | us | 3) | P_13.9.31 |
| VCC1 Short to GND Filter Time | $t_{\mathrm{VCC1}, \mathrm{SC}}$ | 1.6 | 2 | 2.4 | ms | ${ }^{3)}$ blanking time during power-up, short circuit detection for VS $\geq$ VS,UV | P_13.9.32 |


| Reset Generator; Pin RSTN |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reset Low Output Voltage | $V_{\text {RSTN,L }}$ | - | 0.2 | 0.4 | V | $\begin{aligned} & I_{\mathrm{RSTN}}=1 \mathrm{~mA} \text { for } \\ & V_{\mathrm{CC1}} \geq 1 \mathrm{~V} \& \\ & V_{\mathrm{S}} \geq \mathrm{V}_{\mathrm{POR}, \mathrm{f}} \end{aligned}$ | P_13.9.33 |
| Reset High Output Voltage | $V_{\text {RSTN,H }}$ | $\begin{aligned} & 0.8 \mathrm{x} \\ & V_{\mathrm{CC} 1} \end{aligned}$ | - | $\begin{aligned} & V_{\mathrm{CC1}}+ \\ & 0.3 \mathrm{~V} \end{aligned}$ | V | $I_{\text {RSTN }}=-20 \mu \mathrm{~A}$ | P_13.9.34 |
| Reset Pull-up Resistor | $R_{\text {RSTN }}$ | 10 | 20 | 40 | $\mathrm{k} \Omega$ | $V_{\text {RSTN }}=0 \mathrm{~V}$ | P_13.9.35 |
| Reset Filter Time | $t_{\text {RF }}$ | 4 | 10 | 26 | $\mu \mathrm{s}$ | $\begin{aligned} & { }^{3)} V_{\mathrm{CC1}}<V_{\mathrm{RT1x}} \\ & \text { to RSTN = L see } \\ & \text { also Chapter } \mathbf{1 2 . 3} \end{aligned}$ | P_13.9.36 |
| Reset Delay Time (long) | $t_{\text {RD1 }}$ | 8 | 10 | 12 | ms | ${ }^{2)}{ }^{3}$ ) RSTN_DEL = '0' <br> (default value) | P_13.9.37 |
| Reset Delay Time (reduced) | $t_{\text {RD2 }}$ | 1.6 | 2 | 2.4 | ms | ${ }^{2)}{ }^{3}$ RSTN_DEL = '1' | P_13.9.70 |

VCC2 Monitoring

| VCC2 Undervoltage <br> Threshold Voltage (falling) | $V_{\text {CC2, UV,f }}$ | 4.5 | - | 4.75 | V | VCC2 falling | P_13.9.38 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| VCC2 Undervoltage <br> Threshold Voltage (rising) | $V_{\text {cCl } 2, \mathrm{UV}, \mathrm{r}}$ | 4.6 | - | 4.85 | V | VCC2 rising | P_13.9.39 |
| $V_{\mathrm{CC} 2}$ Undervoltage detection hysteresis | $V_{\text {CC2,uv, hys }}$ | 70 | 150 | 250 | mV | 5) | P_13.9.40 |
| VCC2 Undervoltage Detection Filter Time | $t_{\text {vcca,uv_F }}$ | 5 | 10 | 14 | us | ${ }^{3)}$ rising and falling | P_13.9.41 |

## Supervision Functions

Table 32 Electrical Characteristics (cont'd)
$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin
(unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or Test Condition | Number |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min. | Typ. | Max. |  |  |  |
| VCC2 UV Blanking Time | $t_{\text {vCC2,Blank }}$ | 3.2 | 4 | 4.8 | ms | ${ }^{3)}$ after switching On | P_13.9.42 |
| VCAN Monitoring |  |  |  |  |  |  |  |
| CAN Supply undervoltage detection threshold (falling) | $V_{\text {CAN_UV,f }}$ | 4.5 | - | 4.75 | V | VCAN falling | P_13.9.43 |
| CAN Supply undervoltage detection threshold (rising) | $V_{\text {CAN_UV,r }}$ | 4.6 | - | 4.85 | V | VCAN rising | P_13.9.44 |
| $V_{\text {CAN }}$ Undervoltage detection hysteresis | $V_{\text {CAN,UV, hys }}$ | 70 | 150 | 250 | mV | 5) | P_13.9.45 |
| VCAN UV detection Filter Time | $t_{\text {VCAN,UV_F }}$ | 4.2 | 10 | 14 | $\mu \mathrm{s}$ | ${ }^{3)}$ VCAN rising and falling | P_13.9.46 |
| Watchdog Generator / Internal Oscillator |  |  |  |  |  |  |  |
| Long Open Window | $t_{\text {Lw }}$ | 160 | 200 | 240 | ms | 3) | P_13.9.47 |
| Internal Clock Generator Frequency | $f_{\text {CLKSBC, } 1}$ | 0.8 | 1.0 | 1.2 | MHz | - | P_13.9.48 |
| Internal Oscillator 2MHz for Charge Pump | $f_{\text {CLKSBC, } 2}$ | 1.8 | 2.0 | 2.2 | MHz | 2MHZ_FREQ ='001'; | P_13.9.65 |

Minimum Waiting time during SBC Fail-Safe Mode

| Min. waiting time Fail-Safe | $t_{\text {FS, min }}$ | 80 | 100 | 120 | ms | ${ }^{3 / 4)}$ | P_13.9.49 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

Power-On Reset, Over / Undervoltage Protection

| VS Power-on reset rising | $V_{\text {POR, }, ~}$ | - |  | 4.5 | V | VS increasing | P_13.9.50 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| VS Power-on reset falling | $V_{\text {POR,f }}$ | - |  | 3 | V | VS decreasing | P_13.9.51 |
| VS Undervoltage Detection Threshold | $V_{\mathrm{S}, \mathrm{UV}}$ | 3.7 | - | 4.4 | V | Supply UV threshold forVCC1 SC detection; hysteresis included; includes rising and falling threshold | P_13.9.53 |
| VS Undervoltage Detection Hysteresis | $V_{\mathrm{S}, \mathrm{uv}, \text { hys }}$ | 50 | 90 | 130 | mV | 5) | P_13.9.68 |
| VS Undervoltage Detection Filter Time | $t_{\text {vs,uv }}$ | 5 | 10 | 14 | us | ${ }^{3)}$ rising and falling | P_13.9.62 |

## Supervision Functions

Table 32 Electrical Characteristics (cont'd)
$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to 28 V ; $T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$; SBC Normal Mode; all voltages with respect to ground; positive current defined flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| VS Over voltage Detection <br> Threshold |  | Min. | Typ. | Max. |  |  |  |

$\left.\begin{array}{l|l|l|l|l|l|l|l}\hline \text { Overtemperature Shutdown }{ }^{\text {5 }} \\ \hline \begin{array}{l}\text { Thermal Prewarning } \\ \text { Temperature }\end{array} & T_{\text {jPW }} & 125 & 145 & 165 & { }^{\circ} \mathrm{C} & T_{\mathrm{j}} \text { rising }\end{array}\right]$ P_13.9.54

1) It is ensured that the threshold $V_{C C 1, O V, r}$ in SBC Normal Mode is always higher than the highest regulated $V_{\mathrm{CC1}}$ output voltage $\mathrm{V}_{\mathrm{CC} 1, \text { out4 } 4}$.
2) The reset delay time starts when VCC1 crosses above the selected Vrtx threshold
3) Not subject to production test, tolerance defined by internal oscillator tolerance.
4) This time applies for all failure entries except a device thermal shutdown (TSD2 has a typ. 1 s waiting time $\mathbf{t}_{\text {TSD2 }}$ )
5) Not subject to production test, specified by design.

## Serial Peripheral Interface

## 13 Serial Peripheral Interface

The Serial Peripheral Interface is the communication link between the SBC and the microcontroller.
The TLE9461-3ES V33 is supporting multi-slave operation in full-duplex mode with 16 -bit and 32-bit data access (see also Figure 46).
The SPI behavior for the different SBC Modes is as follows:

- The SPI is enabled in SBC Init, Normal and Stop Mode
- The SPI is disabled in SBC Sleep, Restart and Fail-Safe Mode


### 13.1 SPI Block Description

The Control Input Word is read via the data input SDI, which is synchronized with the clock input CLK provided by the microcontroller. The output word appears synchronously at the data output SDO (see Figure 44 with a 16-bit data access example).
The transmission cycle begins when the chip is selected by the input CSN (Chip Select Not), Low active. After the CSN input returns from Low to High, the word that has been read is interpreted according to the content. The SDO output switches to tristate status (high impedance) at this point, thereby releasing the SDO bus for other use. The state of SDI is shifted into the input register with every falling edge on CLK. The state of SDO is shifted out of the output register after every rising edge on CLK. The SPI of the SBC is not daisy chain capable.


Figure 44 SPI Data Transfer Timing (note the reversed order of LSB and MSB shown in this figure compared to the register description)

## Serial Peripheral Interface

### 13.2 Failure Signalization in the SPI Data Output

If the microcontroller sends a wrong SPI command to the SBC, the SBC ignores the information. Wrong SPI commands are either invalid SBC mode commands or commands which are prohibited by the state machine to avoid undesired device or system states (see below). In this case the diagnosis bit 'SPI_FAIL' is set and the SPI Write command is ignored (mostly no partial interpretation). This bit can be only reset by actively clearing it via a SPI command.

## Invalid SPI commands leading to SPI_FAIL are listed below (in this case the SPI command is ignored):

- Illegal state transitions:
- Going from SBC Stop to SBC Sleep Mode. In this case the SBC enters SBC Restart Mode;
- Trying to go to SBC Stop or SBC Sleep Mode from SBC Init Mode. In this case SBC Normal Mode is entered
- Uneven parity in the data bit of the WD_CTRL register. In this case the watchdog trigger is ignored and/or the new watchdog settings are ignored respectively
- In SBC Stop Mode: attempting to change any SPI settings, e.g. changing the watchdog configuration, PWM settings and HS configuration settings during SBC Stop Mode, etc.;
the SPI command is ignored in this case;
only WD trigger, returning to Normal Mode, triggering a SBC Soft Reset, and Read \& Clear status registers commands are valid SPI commands in SBC Stop Mode;
Note: No failure handling is done for the attempt to go to SBC STOP Mode when all bits in the registers BUS_CTRL_0 and WK_CTRL_1 are cleared because the microcontroller can leave this mode via SPI
- When entering SBC Stop Mode and WK_STAT_0 and WK_STAT_1 are not cleared; SPI_FAIL is not set but the INTN pin is triggered
- Changing from SBC Stop to Normal Mode and changing the other bits of the M_S_CTRL register. The other modifications are ignored
- SBC Sleep Mode: attempt to go to Sleep Mode without any wake source set, i.e. when all bits in the BUS_CTRL_0, WK_CTRL_0, WK_CTRL_1 and GPIO_CTRL registers are cleared. In this case the SPI_FAIL bit is set and the device enters SBC Restart Mode.
Even though the Sleep Mode command is not entered in this case, the rest of the command (e.g. modifying VCC2) is executed but restart values apply during SBC Restart Mode;
Note: At least one wake source must be activated in order to avoid a deadlock situation in SBC Sleep Mode, i.e. the SBC would not be able to wake-up anymore.

If the only wake source is a timer and the timer is Off then the SBC will wake-up immediately from Sleep Mode and enter Restart Mode;

- Trying to set WK_MEAS when FO/GPIO is not Off, i.e. FO is activated/configured or any GPIO configuration is selected
- Trying to change the GPIO_CTRL settings in case WK_MEAS is set
- Setting a longer or equal On-time than the timer period of the respective timer
- SDI stuck at High or Low, e.g. SDI received all '0' or all '1'

Note: $\quad$ There is no SPI fail information for unused addresses.

## Signalization of the ERR Flag (high active) in the SPI Data Output (see Figure 44):

The ERR flag presents an additional diagnosis possibility for the SPI communication. The ERR flag is being set for following conditions:

- in case the number of received SPI clocks is not 0 or 16 or 32
- in case RSTN is Low and SPI frames are being sent at the same time.


## Serial Peripheral Interface

Note: In order to read the SPI ERR flag properly, CLK must be Low when CSN is triggered, i.e. the ERR bit is not valid if the CLK is High on a falling edge of CSN

## The number of received SPI clocks is not $\mathbf{0}$ or $\mathbf{1 6}$ or 32:

The number of received input clocks is supervised to be 0 or 16 or 32 clock cycles and the input word is discarded in case of a mismatch ( 0 clock cycle to enable ERR signalization). The error logic also recognizes if CLK was High during CSN edges. Both errors - 0 or 16 or 32 bit CLK mismatch or CLK High during CSN edges are flagged in the following SPI output by a "High" at the data output (SDO pin, bit ERR) before the first rising edge of the clock is received. The complete SPI command is ignored in this case.

## RSTN is Low and SPI frames are being sent at the same time:

The ERR flag is set when the RSTN pin is triggered (during SBC Restart) and SPI frames are being sent to the SBC at the same time. The behavior of the ERR flag is signalized at the next SPI command for below conditions:

- if the command begins when RSTN is High and it ends when RSTN is Low,
- if a SPI command is sent while RSTN is Low,
- If a SPI command begins when RSTN is Low and it ends when RSTN is High.
and the SDO output behaves as follows:
- always when RSTN is Low then SDO is High,
- when a SPI command begins with RSTN is Low and ends when RSTN is High, then the SDO should be ignored because wrong data is sent.

Note: It is possible to quickly check for the ERR flag without sending any data bits. i.e. only the CSN is pulled Low and SDO is observed - no SPI Clocks are sent in this case

Note: $\quad$ The ERR flag could also be set after the SBC has entered SBC Fail-Safe Mode because the SPI communication is stopped immediately.

### 13.3 SPI Programming

For the TLE9461-3ESV33, 7 bits are used or the address selection (BIT6...0). Bit 7 is used to decide between Read Only and Read \& Clear for the status bits, and between Write and Read Only for configuration bits. For the actual configuration and status information, 8 data bits (BIT15...8) are used.
Writing, clearing and reading is done byte wise. The SPI status bits are not cleared automatically and must be cleared by the microcontroller, e.g. if the TSD2 was set due to over temperature. Some of the configuration bits will automatically be cleared by the SBC - please refer to the respective register descriptions for detailed information. In SBC Restart Mode, the device ignores all SPI communication, i.e. it does not interpreted it.

There are two types of SPI registers:

- Control registers: These registers are used to configure the SBC, e.g. SBC mode, watchdog trigger, etc.
- Status registers: These registers indicate the status of the SBC, e.g. wake-up events, warnings, failures, etc.

For the status registers, the requested information is given in the same SPI command in the data out (SDO).
For the control registers, the status of each byte is shown in the same SPI command as well. However, configuration changes of the same register are only shown in the next SPI command (configuration changes inside the SBC become valid only after CSN changes from Low to High).
Writing of control registers is possible in SBC Init and Normal Mode. During SBC Stop Mode only the change to SBC Normal Mode and triggering the watchdog is allowed as well as reading and clearing the status registers.

## Serial Peripheral Interface

Certain SPI control bits used to configure device functionality can be locked to avoid unintentional bit modification. The respective bit type is 'rwl'. There are two levels of configuration locks:

- CFG_LOCK_0 in the HW_CTRL_1 is the level 0 lock mechanism: The bits CP_EN and GPIO can be locked. In case the configuration must be changed then CFG_LOCK_0 must be cleared first
- CFG_LOCK_1 in the HW_CTRL_2 is the level 1 lock mechanism: All other lockable bits with the type 'rwl' are locked and can only be modified at the next device power up

No status information can be lost, even if a bit changes right after the first 7 SPI clock cycles before the SPI frame ends. In this case the status information field is updated with the next SPI command. However, the flag is already set in the relevant status register.
The SBC status information from the SPI status registers is transmitted in a compressed format with each SPI response on SDO in the so-called Status Information Field register (see also Figure 45). The purpose of this register is to quickly signal changes in the SPI status registers to the microcontroller. This means that the microcontroller only needs to read registers which have changed.
Each bit in the Status Information Field represents a SPI status register (see Table 33). As soon as one bit is set in one of the status registers, the corresponding bit in the Status Information Field register is set. Only the most important registers are represented in the Status Information Field, e.g. the register WK_LVL_STAT is not included.
For example if bit 0 in the Status Information Field is set to ' 1 ', one or more bits of the register 1000001 (SUP_STAT_0) are set to 1 . Then this register needs to be read with a second SPI command. The bit in the Status Information Field is set to 0 when all bits in the register 1000001 have been reset to ' 0 '.

Table 33 Status Information Field

| Bit in Status <br> Information Field | Corresponding <br> Address Bit | Status Register Description |
| :--- | :--- | :--- |
| 0 | 1000001 | SUP_STAT_0 - Supply Status: POR, VCC2 fail, VCC1 fail |
| 1 | 1000010 | THERM_STAT - Thermal Protection Status |
| 2 | 1000011 | DEV_STAT- Device Status: Mode before wake-up- <br> up/failure, WD Fail, SPI Fail, Failure |
| 3 | 1000100 | BUS_STAT - Bus Failure Status: CAN; |
| 4 | 1000110 | WK_STAT_0, WK_STAT_1 - Wake Source Status; <br> Status bit is a combinational OR of both registers |
| 5 | 1000111 | SUP_STAT_1: VS_UV, VCC1_WARN/OV |
| 6 | 1000000 | GPIO_OC_STAT: GPIO over current |
| 7 | 1010101 | GPIO_OL_STAT: GPIO open load |

## Serial Peripheral Interface



Figure 45 SPI Operation Mode

## 32-bit Register Access for SWK Control Registers

The operation of the 16-bit and 32-bit SPI data access is shown in Figure 46.
The 32-bit SPI data access is only available for the Selective Wake register addresses 0100000 to 0111111 . The registers SWK_OSC_CAL_H_STAT and SWK_OSC_CAL_L_STAT are excluded from the 32-bit SPI access.

The TLE9461-3ES V33 tolerates reserved register access, i.e. registers that do not exist. In this case the next existing register address is accessed. If the available address space is exceeded during a SPI command, e.g. higher than address ' 0111111 ', then the higher addresses are ignored and the return value is ' $0 \times 00$ ' for those addresses.


Figure 46 Data access for 16- and 32-bit SPI commands

### 13.4 SPI Bit Mapping

The following figures show the mapping of the registers and the SPI bits of the respective registers.
The Control Registers '000 0000' to '001 1110' are Read/Write Register. The registers '010 0000' to '011 1111' are dedicated control registers for CAN Partial Networking (=Selective Wake). Depending on bit 7 the bits are only read (setting bit 7 to ' 0 ') or also written (setting bit 7 to ' 1 '). The new setting of the bit after a write can be seen with a new read / write command.
The registers ' 1000000 ' to ' 1111110 ' are Status Registers and can be read or read with clearing the bit (if possible) depending on bit 7. To clear a Data Byte of one of the Status Registers bit 7 must be set to ' 1 '. The registers WK_LVL_STAT, and FAM_PROD_STAT, SWK_OSC_CAL_H_STAT, SWK_OSC_CAL_L_STAT, SWK_STAT, SWK_ECNT_STAT, SWK_CDR_STAT1, SWK_CDR_STAT2 are an exception as they show the actual voltage level at the respective WK pin (Low/High), or a fixed family/ product ID respectively and can thus not be cleared. It is recommended for proper diagnosis to clear respective status bits for wake-up events or failure. However, in general it is possible to enable drivers without clearing the respective failure flags.
When changing to a different SBC Mode, certain configurations bits is cleared automatically or modified:

- The SBC Mode bits are updated to the actual status, e.g. when returning to Normal Mode
- When changing to a low-power mode (Stop/Sleep), the diagnosis bits of the switches and transceivers are not cleared. FO will stay activated if it was triggered before.
- When changing to SBC Stop Mode, the CAN control bits will not be modified.
- When changing to SBC Sleep Mode, the CAN control bits is modified if they were not Off or Wake Capable before.
- VCC2 will stay On when going to Sleep-/Stop Mode (configuration can only be done in Normal Mode). Diagnosis is active. In case of a failure the regulator is turned Off and no wake-up is issued.
- The configuration bits for VCC2 in stand-alone configuration are cleared in SBC Restart Mode. FO will stay activated if it was triggered before. Depending on the respective configuration, CAN transceivers is either Off, woken or still Wake Capable.

Note: $\quad$ The detailed behavior of the respective SPI bits and control functions is described in Chapter 13.5, Chapter 13.6. and in the respective module chapter. The bit type be marked as 'rwh' in case the SBC will modify respective control bits.


Figure 47 SPI Register Mapping Structure
The detailed register mappings for control registers and status registers are shown in Table 34 and Table 37 respectively.
The detailed SPI bit mapping overview is shown in Figure 48.

Serial Peripheral Interface


Figure 48 Detailed TLE9461-3ES V33 SPI Bit Mapping

### 13.5 SPI Control Registers

READ/WRITE Operation (see also Chapter 13.3):

- The 'POR / Soft Reset Value' defines the register content after POR or SBC Reset.
- The 'Restart Value' defines the register content after SBC Restart, where ' $x$ ' means the bit is unchanged.
- One 16 -bit SPI command consist of two bytes:
- the 7-bit address and one additional bit for the register access mode and
- following the data byte

The numbering of following bit definitions refers to the data byte and correspond to the bits D0...D7 and to the SPI bits 8 ...15. In case of 32-bit SPI commands, the data bytes from the next valid address are accessed (see also Figure 46).

- There are four different bit types:
- 'r' = READ: read only bits (or reserved bits)
- 'rw' = READ/WRITE: readable and writable bits
- 'rwh' = READ/WRITE/Hardware: readable/writable bits, which can also be modified by the SBC hardware
- 'rwl' = READ/WRITE/LOCKED: readable/writable bits, which are locked and cannot be modified anymore once the bit CFG_LOCK_0 in the HW_CTRL_1 or CFG_LOCK_1 in the HW_CTRL_2 register are set. The locking mechanism will remain active for all conditions (incl. Soft Reset) unless the bit CFG_LOCK_0 (for CP_EN or GPIO only) is cleared again; for bits relating to CFG_LOCK_1 the locking mechanism will remain active until the device is powered down (VS < $\mathbf{V}_{\text {PoR,f }}$ ) and can only be changed at the next device power-up.
After a soft reset command: If the respective lock bit is not set then the POR values are resumed; if the respective lock bit is set then the respective configurations stay unchanged, i.e. the soft reset has no effect on those configurations.
- Reserved bits are marked as "Reserved" and always read as " 0 ". The respective bits shall also be programmed as " 0 ".
- Reading a register is done byte wise by setting the SPI bit 7 to " 0 " (= Read Only).
- Writing to a register is done byte wise by setting the SPI bit 7 to " 1 ".
- SPI control bits are in general not cleared or changed automatically. This must be done by the microcontroller via SPI programming. Exceptions to this behavior are stated at the respective register description and the respective bit type is marked with a 'h' meaning that the SBC is able to change the register content.
The registers are addressed wordwise.


## Serial Peripheral Interface

Table 34 Register Overview: SPI Control Register

| Register Short Name | Register Long Name | Offset Address | Reset Value |
| :---: | :---: | :---: | :---: |
| General Control Registers |  |  |  |
| M_S_CTRL | Mode- and Supply Control | $0000001_{B}$ | Page 126 |
| HW_CTRL_0 | Hardware Control 0 | $0000010_{\text {B }}$ | Page 127 |
| WD_CTRL | Watchdog Control | $0000011_{B}$ | Page 128 |
| BUS_CTRL_0 | Bus Control 0 | $0000100_{B}$ | Page 129 |
| WK_CTRL_0 | Internal Wake Input Control | $0000110_{\text {B }}$ | Page 130 |
| WK_CTRL_1 | External Wake Source Control | $0000111_{B}$ | Page 130 |
| WK_PUPD_CTRL | Wake Input Level Control | $0001000{ }_{\text {B }}$ | Page 131 |
| BUS_CTRL_3 | Bus Control 3 | $0001011_{B}$ | Page 131 |
| TIMER_CTRL | Timer Control and Selection | $0001100_{B}$ | Page 132 |
| HW_CTRL_1 | Hardware Control 1 | $0001110_{\text {B }}$ | Page 133 |
| HW_CTRL_2 | Hardware Control 2 | $0001111_{B}$ | Page 135 |
| GPIO_CTRL | GPIO Configuration Control | $0010111_{B}$ | Page 136 |
| PWM_CTRL | PWM Configuration Control | $0011000_{\text {B }}$ | Page 136 |
| PWM_FREQ_CTRL | PWM Frequency Configuration Control | $0011100_{B}$ | Page 137 |
| HW_CTRL_3 | Hardware Control 3 | $0011101_{B}$ | Page 137 |
| SYS_STATUS_CTRL_0 | System Status Control Low Byte | $0011110_{B}$ | Page 138 |
| SYS_STATUS_CTRL_1 | System Status Control High Byte | $0011111_{B}$ | Page 138 |

Selective Wake Control Registers

| SWK_CTRL | CAN Selective Wake Control | $0100000_{\mathrm{B}}$ | Page 139 |
| :--- | :--- | :--- | :--- |
| SWK_BTLO_CTRL | SWK Bit Timing Logic Control1 | $0100001_{\mathrm{B}}$ | Page 140 |
| SWK_BTL1_CTRL | SWK Bit Timing Logic Control2 | $0100010_{\mathrm{B}}$ | Page 140 |
| SWK_ID3_CTRL | SWK WUF Identifier bits 28...21 | $0100011_{\mathrm{B}}$ | Page 140 |
| SWK_ID2_CTRL | SWK WUF Identifier bits 20...13 | $0100100_{\mathrm{B}}$ | Page 141 |
| SWK_ID1_CTRL | SWK WUF Identifier bits 12...5 | $0100101_{\mathrm{B}}$ | Page 141 |
| SWK_ID0_CTRL | SWK WUF Identifier bits 4...0 | $0100110_{\mathrm{B}}$ | Page 141 |
| SWK_MASK_ID3_CTRL | SWK WUF Identifier Mask bits 28...21 | $0100111_{\mathrm{B}}$ | Page 142 |
| SWK_MASK_ID2_CTRL | SWK WUF Identifier Mask bits 20..13 | $0101000_{\mathrm{B}}$ | Page 142 |
| SWK_MASK_ID1_CTRL | SWK WUF Identifier Mask bits 12...5 | $0101001_{\mathrm{B}}$ | Page 142 |
| SWK_MASK_ID0_CTRL | SWK WUF Identifier Mask bits 4...0 | $0101010_{\mathrm{B}}$ | Page 143 |
| SWK_DLC_CTRL | SWK Frame Data Length Code Control | $0101011_{\mathrm{B}}$ | Page 143 |
| SWK_DATA7_CTRL | SWK Data7 Register | $0101100_{\mathrm{B}}$ | Page $\mathbf{1 4 4}$ |
| SWK_DATA6_CTRL | SWK Data6 Register | $0101101_{\mathrm{B}}$ | Page 144 |
| SWK_DATA5_CTRL | SWK Data5 Register | $0101110_{\mathrm{B}}$ | Page 144 |
| SWK_DATA4_CTRL | SWK Data4 Register | $0101111_{\mathrm{B}}$ | Page 144 |
| SWK_DATA3_CTRL | SWK Data3 Register | $0110000_{\mathrm{B}}$ | Page 145 |
| SWK_DATA2_CTRL | SWK Data2 Register | $0110001_{\mathrm{B}}$ | Page 145 |

Serial Peripheral Interface

Table 34 Register Overview: SPI Control Register (cont'd)

| Register Short Name | Register Long Name | Offset Address | Reset Value |
| :---: | :---: | :---: | :---: |
| SWK_DATA1_CTRL | SWK Datal Register | 011 0010 ${ }_{\text {B }}$ | Page 145 |
| SWK_DATAO_CTRL | SWK Data0 Register | $0110011_{B}$ | Page 145 |
| SWK_CAN_FD_CTRL | CAN FD Configuration Control Register | $0110100_{B}$ | Page 146 |
| SWK_OSC_TRIM_CTRL | SWK Oscillator Trimming Register | $0111000^{\text {B }}$ | Page 147 |
| SWK_OPT_CTRL | Selective Wake Options Register | $0111001^{\text {B }}$ | Page 147 |
| SWK_OSC_CAL_H_STAT | SWK Oscillator Calibration High Register | $0111010^{\text {B }}$ | Page 147 |
| SWK_OSC_CAL_L_STAT | SWK Oscillator Calibration Low Register | $0111011_{B}$ | Page 148 |
| SWK_CDR_CTRL1 | CDR Control 1 Register | $0111100_{B}$ | Page 148 |
| SWK_CDR_CTRL2 | CDR Control 2 Register | $0111101_{B}$ | Page 149 |
| SWK_CDR_LIMIT_HIGH _CTRL | SWK CDR Upper Limit Control | 011 1110 ${ }_{\text {B }}$ | Page 150 |
| SWK_CDR_LIMIT_LOW_ CTRL | SWK CDR Lower Limit Control | $0111111_{\text {B }}$ | Page 150 |

Serial Peripheral Interface

### 13.5.1 General Control Registers

```
M_S_CTRL
Mode- and Supply Control (Address 000 0001 B
POR / Soft Reset Value: 0000 0000 ; ; Restart Value: 0000 00xx 
```



| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| MODE | 7:6 | rwh | SBC Mode Control <br> $00_{B}$, SBC Normal Mode <br> $01_{B}$, SBC Sleep Mode <br> $10_{B}$, SBC Stop Mode <br> $11_{B}$, SBC Reset: Soft Reset is executed (configuration of RSTN triggering in bit SOFT_RESET_RST) |
| Reserved | 5 | r | Reserved, always reads as 0 |
| VCC2_ON | 4:3 | rwh | VCC2 Mode Control <br> $00_{B}$, VCC2 Off <br> $01_{B}$, VCC2 On in Normal Mode <br> $10_{B}$, VCC2 On in Normal and Stop Mode <br> $11_{B} \quad$, VCC2 always On (except in SBC Init - if not in SBC Development Mode, SBC Restart and Fail-Safe Mode) |
| $\begin{aligned} & \text { VCC1_OV_R } \\ & \text { ST } \end{aligned}$ | 2 | rwh | VCC1 Over Voltage leading to Restart / Fail-Safe Mode enable $0_{B} \quad, \mathbf{V C C 1} 1 \mathbf{O V}$ is set in case of VCC1_OV; no SBC Restart or FailSafe is entered for VCC1_OV <br> $1_{B} \quad, \mathbf{V C C 1} \mathbf{O V}$ is set in case of VCC1_OV; depending on the device configuration SBC Restart or SBC Fail-Safe Mode is entered (see Chapter 5.1.1); |
| VCC1_RT | 1:0 | rw | VCC1 Reset Threshold Control <br> $00_{B}$,Vrt1 selected (highest threshold) <br> $01_{B}$, Vrt2 selected <br> $10_{B} \quad$, Vrt3 selected <br> $11_{B}$,Vrt4 selected |

## Notes

1. It is not possible to change from Stop to Sleep Mode via SPI Command. See also the State Machine Chapter
2. In a transition from SBC Stop to SBC Normal Mode a change of the bits [4:0] is ignored and the SPI_FAIL bit is set. The transition to SBC Normal Mode is executed.
3. After entering SBC Restart Mode, the MODE bits is automatically set to SBC Normal Mode. The VCC2_ON bits is automatically set to Off after entering SBC Restart Mode and after over temperature (OT).
4. The SPI output will always show the previously written state with a Write Command (what has been programmed before)
5. When in SBC Development Mode the POR/Soft Reset value of VCC2_ON = '11', i.e. VCC2 is On in SBC Init Mode but is switched Off with a Soft Reset command

Serial Peripheral Interface

## HW_CTRL_0

Hardware Control 0 (Address $\mathbf{0 0 0} \mathbf{0 0 1 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $0 \mathrm{y} 00 \mathrm{OyOO}_{\mathrm{B}}$; Restart Value: $0 \times 000 \times 0 x_{B}$


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| Reserved | 7 | r | Reserved, always reads as 0 |
| SOFT_RESE <br> T_RST | 6 | rwl | Soft Reset Configuration <br> $0_{B} \quad$, RST is triggered (pulled Low) during a Soft Reset $1_{B} \quad$, no RST trigger during a Soft Reset |
| FO_ON | 5 | rwh | Failure Output Activation <br> $0_{B} \quad$, FO not activated by software, FO is activated by specified failures (see Chapter 11.1.1) <br> $1_{B} \quad$, FO activated by software (via SPI), only if configured as FO |
| Reserved | 4:3 | r | Reserved, always reads as 0 |
| CP_EN | 2 | rwl | Charge Pump Output Enable <br> $0_{B} \quad$, Charge Pump is Off <br> $1_{B} \quad$, Charge Pump Output is enabled (see Chapter 5) |
| Reserved | 1 | r | Reserved, always reads as 0 |
| CFG1 | 0 | rw | Configuration Select 1 (see also Table 5) <br> $0_{B} \quad$, Depending on hardware configuration, SBC Restart or FailSafe Mode is reached after the 2 . watchdog trigger failure (=default) - Config 3/4 <br> $1_{B}$, Depending on hardware configuration, SBC Restart or FailSafe Mode is reached after the 1 . watchdog trigger failure Config 1/2 |

## Notes

1. Clearing the FO_ON bit will not disable the FO output in case a failure occurred which triggered the FO output. In this case the FO output have to be disabled by clearing the FAILURE bit.
If the FO_ON bit is set by the software then it is cleared by the SBC after SBC Restart Mode was entered and the FO output is disabled (if no failures occurred which triggered the fail outputs). See also Chapter 11 for FO activation and deactivation.
2. In case the CFG_LOCK_1 bit is set, then the soft reset value for SOFT_RESET_RST will stay unchanged, i.e. ' $x$ '; the same applies if CFG_LOCK_O is set: then the soft reset value of the bit CP_EN will stay unchanged, i.e. ' $x$ '. Therefore, the respective soft reset values are marked as ' $y$ '.

Serial Peripheral Interface

## WD_CTRL

Watchdog Control (Address $000 \mathbf{0 0 1 1}_{\mathrm{B}}$ )
POR / Soft Reset Value: $0001 \mathbf{0 1 0 0}_{B}$; Restart Value: x0xx 0100 ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CHECKSUM | WD_STM_EN_ <br> 0 | WD_WIN | WD_EN_WK_B <br> US | Reserved |  | WD_TIMER |


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| CHECKSUM | 7 | rw | Watchdog Setting Check Sum Bit <br> The sum of bits 7:0 needs to have even parity (see Chapter 12.2.3) <br> $0_{B} \quad$, Counts as 0 for checksum calculation <br> $1_{B} \quad$, Counts as 1 for checksum calculation |
| $\begin{aligned} & \text { WD_STM_ } \\ & \text { EN_0 } \end{aligned}$ | 6 | rwh | Watchdog Deactivation during Stop Mode, bit 0 (Chapter 12.2.4) <br> $0_{B} \quad$, Watchdog is active in Stop Mode <br> $1_{B} \quad$,Watchdog is deactivated in Stop Mode |
| WD_WIN | 5 | rw | Watchdog Type Selection <br> $0_{B} \quad$, Watchdog works as a Time-Out watchdog <br> $1_{B} \quad$, Watchdog works as a Window watchdog |
| WD_EN_ WK_BUS | 4 | rw | Watchdog Enable after Bus (CAN) Wake-up in SBC Stop Mode <br> $0_{B} \quad$, Watchdog will not start after a CAN wake-up <br> $1_{B} \quad$, Watchdog starts with a long open window after CAN Wake |
| Reserved | 3 | r | Reserved, always reads as 0 |
| WD_TIMER | 2:0 | rwh | $\begin{aligned} & \text { Watchdog Timer Period } \\ & 000_{\mathrm{B}}, 10 \mathrm{~ms} \\ & 001_{\mathrm{B}}, 20 \mathrm{~ms} \\ & 010_{\mathrm{B}}, 50 \mathrm{~ms} \\ & 011_{\mathrm{B}}, 100 \mathrm{~ms} \\ & 100_{\mathrm{B}}, 200 \mathrm{~ms} \\ & 101_{\mathrm{B}}, 500 \mathrm{~ms} \\ & 110_{\mathrm{B}}, 1000 \mathrm{~ms} \\ & 111_{\mathrm{B}}, 10000 \mathrm{~ms} \end{aligned}$ |

## Notes

1. See also Chapter $\mathbf{1 2 . 2 . 4}$ for more information on disabling the watchdog in SBC Stop Mode.
2. See Chapter 12.2.5 for more information on the effect of the bit WD_EN_WK_BUS.
3. See Chapter 12.2.3 for calculation of checksum.


## Notes

1. The reset values for the CAN transceivers are marked with ' $y$ ' because they will vary depending on the cause of change - see below.
2. see Figure $\mathbf{2 4}$ for detailed state changes of CAN Transceiver for different SBC modes.
3. The bit CAN_2 is not modified by the SBC but can only be changed by the user. Therefore, the bit type is 'rw' compared to bits CAN_0 and CAN_1.
4. In case SYSERR $=0$ and the CAN transceiver is configured to ' $x 11$ ' while going to SBC Sleep Mode, it is automatically set to Wake Capable ('x01'). The SPI bits are changed to Wake Capable. If configured to 'x10' and SBC Sleep Mode is entered, then the transceiver is set to Wake Capable, while it will stay in Receive Only Mode when it had been configured to 'x10' when going to SBC Stop Mode. If it had been configured to Wake Capable or Off then the mode will remain unchanged. The Receive Only Mode has to be selected by the user before entering SBC Stop Mode. Please refer to Chapter 5.6.4 for detailed information on the Selective Wake mode changes.
5. Failure Handling Mechanism: When the device enters Fail-Safe Mode due to a failure (TSD2, WD-Failure,...), then BUS_CTRL_0 is modified by the SBC to '0000 0x01' to ensure that the device can be woken again. See also the description in Chapter 5.6.4.5 and for WK_CTRL_1 for other wake sources when entering SBC FailSafe Mode.
6. When in SBC Development Mode the POR/Soft Reset value of $C A N=$ ' 011 '

## Lite CAN SBC Family

Serial Peripheral Interface

```
WK_CTRL_0
Internal Wake Input Control (Address 000 0110}\mp@subsup{\textrm{B}}{\textrm{B}}{}\mathrm{ )
POR / Soft Reset Value: 0000 0000 B; Restart Value: 0x00 0000)
```



| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | r | Reserved, always reads as 0 |
| TIMER_WK_ | 6 | rw | Timer Wake Source Control (for Cyclic Wake) <br> $0_{\mathrm{B}} \quad$, Timer wake-up disabled <br> $1_{\mathrm{B}} \quad$, Timer is enabled as a wake source |
| Reserved | $5: 3$ | r | Reserved, always reads as 0 |
| WD_STM_ <br> EN_1 | 2 | rwh | Watchdog Deactivation during Stop Mode, bit 1 <br> (Chapter 12.2.4) <br> $0_{\mathrm{B}} \quad$, Watchdog is active in Stop Mode <br> $1_{\mathrm{B}} \quad$, Watchdog is deactivated in Stop Mode |
| Reserved | $1: 0$ | r | Reserved, always reads as 0 |

Note: $\quad W D \_S T M \_E N \_1$ will also be cleared when changing from SBC Stop to Normal Mode

## WK_CTRL_1

External Wake Source Control (Address $000 \mathbf{0 1 1 1}_{\text {B }}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 1}_{B} ; \quad$ Restart Value: $x 0 \times 00_{001}$ B


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| INT_ | 7 | rw | Global Interrupt Configuration (see also Chapter 10.1) <br> $0_{\mathrm{B}} \quad$, Only wake sources trigger INTN (default) <br> GLOBAL |
|  |  |  | $1_{\mathrm{B}} \quad$, All status information register bits will trigger INTN <br> (including all wake sources) |
| Reserved | 6 | r | Reserved, always reads as 0 |
| WK_MEAS | 5 | rw | Wake / Voltage Sensing Selection (see also Chapter 9.2.4) <br> $0_{\mathrm{B}} \quad$, Wake-up functionality enabled for WK <br> $1_{\mathrm{B}} \quad$, Voltage sensing functionality enabled, no wake-up events <br> are generated |
| Reserved | $4: 1$ | r | Reserved, always reads as 0 |

Serial Peripheral Interface

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| WK_EN | 0 | rw | WK Wake Source Control |
|  |  |  | $0_{B} \quad$, WK wake-up disabled |
|  |  |  | $1_{B} \quad$, WK is enabled as a wake source |

## Notes

1. WK_MEAS is by default configured for standard WK functionality (Static Sense on WK). If WK_MEAS is set and FO is not activated then the bits WK_EN and GPIO_CTRL are ignored. If FO is activated then WK_MEAS cannot be set to ' 1 ' and SPI_Fail is set. If the bit is set to ' 1 ' then the measurement function is enabled during Normal Mode \& the bits WK_EN are ignored. The bits WK_LVL and GPIO_LVL bits are not updated and are reset.
2. The wake source CAN is selected in the register BUS_CTRL_O by setting the respective bits to 'Wake Capable'
3. Failure Handling Mechanism: When the device enters SBC Fail-Safe Mode due to a failure (TSD2, WD-

Failure,...) and WK_MEAS = '0', the WK_CTRL_1 is modified by the SBC to 'x0x0 0001' in order to ensure that the device can be woken again. In case WK_MEAS is ' 1 ' then WK will not be available as an automatic wake source in SBC Fail-Safe Mode.

## WK_PUPD_CTRL

Wake Input Level Control (Address $000 \mathbf{1 0 0 0}_{B}$ )
POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: xx00 00xx

| 7 | 5 | 4 | 3 | 2 | 1 |
| :---: | :---: | :---: | :---: | :---: | :---: |
| GPIO_WK_PUPD |  | Reserved |  | WK_PUPD |  |
| rW |  |  | rw |  |  |


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| $\begin{aligned} & \text { GPIO_WK_P } \\ & \text { UPD } \end{aligned}$ | 7:6 | rw | GPIO WK Pull-Up / Pull-Down Configuration (only if GPIO configured as WK) <br> $00_{B}$, No pull-up / pull-down selected <br> $01_{B}$, Pull-down resistor selected <br> $10_{B}$, Pull-up resistor selected <br> $11_{B}$, Automatic switching to pull-up or pull-down |
| Reserved | 5:2 | r | Reserved, always reads as 0 |
| WK_PUPD | 1:0 | rw | WK Pull-Up / Pull-Down Configuration <br> $00_{B}$, No pull-up / pull-down selected <br> $01_{B}$, Pull-down resistor selected <br> $10_{B}$, Pull-up resistor selected <br> $11_{B}$, Automatic switching to pull-up or pull-down |

BUS_CTRL_3
Bus Control 3 (Address 000 1011 $_{\text {B }}$ )
POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{B}$; Restart Value: 000x 0000 ${ }_{B}$


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 5$ | r | Reserved, always reads as 0 |
| CAN_Flash | 4 | rw | HS-CAN Flash Mode Activation <br> $0_{B} \quad$, Flash Mode disabled: CAN communication up to 5MBaud <br> 1 |
| Reserved | $3: 0$ | r Flash Mode enabled: CAN communication for higher than |  |
| 5MBaud (higher emission on CAN bus - no slew rate control) |  |  |  |

Note: $\quad$ The electrical parameters for the CAN FD communication are ensured up to 5MBaud for the default setting (CAN_Flash is cleared). In case higher communication rates are required then CAN_Flash can be set.

## TIMER_CTRL

Timer Control and Selection (Address $000 \mathbf{1 1 0 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathrm{B}}$


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | r | Reserved, always reads as 0 |
| TIMER_ | $6: 4$ | rwh | Timer On-Time Configuration |
| ON |  |  | $000_{\mathrm{B}}$, Off $/$ Low (timer not running, HSx output is Low) |
|  |  |  | $001_{\mathrm{B}}, 0.1 \mathrm{~ms}$ On-time |
|  |  | $010_{\mathrm{B}}, 0.3 \mathrm{~ms}$ On-time |  |
|  |  | $011_{\mathrm{B}}, 1.0 \mathrm{~ms}$ On-time |  |
|  |  |  | $100_{\mathrm{B}}, 10 \mathrm{~ms}$ On-time |
|  |  | $101_{\mathrm{B}}, 20 \mathrm{~ms}$ On-time |  |
|  |  |  | $110_{\mathrm{B}}$, Off $/$ High (timer not running, HSx output is High) |
|  |  |  |  |
|  |  |  |  |

Serial Peripheral Interface

| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| TIMER_ PER | 3:0 | rwh | Timer Period Configuration $0000_{\mathrm{B}}, 10 \mathrm{~ms}$ $0001_{\mathrm{B}}, 20 \mathrm{~ms}$ $0010_{\mathrm{B}}, 50 \mathrm{~ms}$ $0011_{\mathrm{B}}, 100 \mathrm{~ms}$ $0100_{\mathrm{B}}, 200 \mathrm{~ms}$ $0101_{\mathrm{B}}, 500 \mathrm{~ms}$ $0110_{\mathrm{B}}$, 1s $0111_{B}$, 2 s $1000_{B}$, 5 s $1001_{B}, 10$ s $1010_{B}$, 20s $1011_{B}$, 50s $1100_{\mathrm{B}}, 100 \mathrm{~s}$ $1101_{\mathrm{B}}, 200 \mathrm{~S}$ $1111_{\mathrm{B}}, 500 \mathrm{~s}$ $1111_{\mathrm{B}}, 1000 \mathrm{~s}$ |

## Notes

1. The timer must be first assigned and is then automatically activated as soon as the On-time is configured.
2. If Cyclic Sense is selected and the GPIO HS switch is cleared during SBC Restart Mode then also the timer settings (period and On-time) are cleared to avoid incorrect switch detection. However, the timer settings are not cleared in case of failure not leading to SBC Restart Mode. This must be considered by the application.
3. in case the timer is set as wake sources and Cyclic Sense is running, then both Cyclic Sense and Cyclic Wake are active at the same time.
4. A new timer configuration will become active immediately, i.e. as soon as CSN goes High.

## HW_CTRL_1

Hardware Control 1 (Address 000 1110 $_{B}$ )
POR / Soft Reset Value: y0yy $\mathrm{yOOO}_{\mathrm{B}}$; Restart Value: $\mathrm{x} 0 \mathrm{xx} x 00 \mathrm{o}_{\mathrm{B}}$


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| RSTN_HYS | 7 | rwl | VCC1 Undervoltage Reset Hysteresis Selection (see also <br> Chapter 12.5.1 for more information) |
|  |  | $0_{\mathrm{B}} \quad$, default hysteresis applies as specified in the electrical <br> characteristics table <br> ,the highest rising threshold (Vrt1,r) is always used for the <br> release of the undervoltage reset |  |
| Reserved | 6 | r | Reserved, always reads as 0 |


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| TSD2_DEL | 5 | rwl | TSD2 Minimum Waiting Time Selection <br> $\mathrm{O}_{\mathrm{B}} \quad$, Minimum waiting time until TSD2 is released again is always 1s <br> $1_{B}$, Minimum waiting time until TSD2 is released again is 1 s , after $>16$ consecutive TSD2 events, it is extended to $\times 64$ |
| RSTN_DEL | 4 | rwl | Reset Delay Time Selection <br> $0_{B} \quad$, The extended reset delay time $\mathbf{t}_{\text {RD1 }}$ is selected (default) <br> $1_{B} \quad$, The reduced t $_{\text {RD2 }}$ reset delay time is selected |
| $\begin{aligned} & \text { CFG_LOCK_ } \\ & 0 \end{aligned}$ | 3 | rw | ```Configuration Lock Bit - Level O 0}\mp@subsup{B}{B}{}\quad,CP_EN and GPIO can be modifie 1 B ,CP_EN and GPIO is locked and cannot be modified``` |
| Reserved | 2:0 | r | Reserved, always reads as 0 |

## Notes

1. See also Chapter $\mathbf{1 2 . 5}$ for selection of VCC1 undervoltage hysteresis
2. See also Chapter $\mathbf{1 2 . 8}$ for minimum waiting time in case of an TSD2 event
3. The bit CFG_LOCK_O is used to prevent an unintentional modification of the charge pump activation bit CP_EN and the GPIO configuration bits GPIO. In case the charge pump output state or the GPIO configuration must be changed then it is necessary to clear CFG_LOCK_0. The other lockable bits are controlled by the lock bit CFG_LOCK_1. In case either lock bit is set then the respective locked bits cannot be changed by a soft reset. Therefore, the respective soft reset values are marked as ' $y$ '.
4. In case CFG_LOCK_1 bit are set, then the respective soft reset value is like the Restart value.

Serial Peripheral Interface


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| 2MHZ_FREQ | 7:5 | rwl | Charge Pump Switching Frequency Setting $\begin{aligned} & 000_{\mathrm{B}}, 1.8 \mathrm{MHz} \\ & 001_{\mathrm{B}}, 2.0 \mathrm{MHz} \\ & 010_{\mathrm{B}}, 2.2 \mathrm{MHz} \text { (default value) } \\ & 011_{\mathrm{B}}, 2.4 \mathrm{MHz} \\ & 100_{\mathrm{B}}, \text { Reserved } \\ & 101_{\mathrm{B}}, \text { Reserved } \\ & 110_{\mathrm{B}}, \text { Reserved } \\ & 111_{\mathrm{B}}, \text { Reserved } \end{aligned}$ |
| I_PEAK_TH | 4 | rwl | VCC1 Active Peak Threshold Selection <br> $0_{B} \quad$, low VCC1 active peak threshold selected (ICC1,peak_1) <br> $1_{B} \quad$, high VCC1 active peak threshold selected (ICC1,peak_2). |
| SS_MOD_FR | 3:2 | rwl | Spread Spectrum Modulation Frequency Setting of integrated <br> 2 MHz oscillator for charge pump <br> $00_{B}$, Spread Spectrum disabled <br> $01_{\mathrm{B}}, 15.625 \mathrm{kHz}$ Modulation Frequency <br> $10_{\mathrm{B}}, 31.250 \mathrm{kHz}$ Modulation Frequency <br> $11_{\mathrm{B}}, 62.500 \mathrm{kHz}$ Modulation Frequency |
| Reserved | 1 | r | Reserved, always reads as 0 |
| $\begin{aligned} & \text { CFG_LOCK_ } \\ & 1 \end{aligned}$ | 0 | rwl | Configuration Lock Bit - Level 1 <br> $0_{B} \quad$, Bits with bit type 'rwl' (except CP_EN and GPIO) can be modified <br> $1_{B} \quad$, Bits with bit type 'rwl' (except CP_EN and GPIO) are locked and cannot be modified anymore until next device power-up. |

## Notes

1. The configuration locking becomes effective after CSN changes from Low to High once the CFG_LOCK_1 bit was set. The locking is active until the next device power-up (VS < $\boldsymbol{V}_{\text {Por,f, }}$ ), i.e. also CFG_LOCK_1 is locked in this case. The CFG_LOCK_1 will stay unchanged by a soft reset.
2. After $t_{\text {RDI }}$ has expired, the default value is resumed after power-up or the configured value after SBC Sleep- or Fail-Safe Mode. In case the CFG_LOCK_1 bit is set, then the soft reset value is like the Restart value.

Serial Peripheral Interface

## GPIO_CTRL

GPIO Configuration Control (Address 001 0111 $_{\mathrm{B}}$ )
POR Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value/Soft Reset Value: $00000^{0 y y} y_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Reserved |  |  |  | GPIO |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 3$ | r | Reserved, always reads as 0 |
| GPIO | $2: 0$ | rwhl | GPIO Configuration |
|  |  |  | $000_{\mathrm{B}}$, FO selected (default) |
|  |  | $001_{\mathrm{B}}$, FO selected |  |
|  |  | $010_{\mathrm{B}}$, FO selected |  |
|  |  | $011_{\mathrm{B}}$, High-Side controlled by TIMER (Cyclic Sense) |  |
|  |  | $100_{\mathrm{B}}$, Off |  |
|  |  |  | $101_{\mathrm{B}}$, Wake input enabled (16us static filter) |
|  |  |  | $110_{\mathrm{B}}$, Low-Side Switch controlled by PWM |
|  |  |  |  |
|  |  |  |  |

## Notes

1. The Restart and Soft Reset Value depends on the respective GPIO configuration. Therefore the bit type is also 'rwhl' and the restart value is ' $y$ '. See also Table 29 in Chapter 11.1.2 for more information on the GPIO behavior for the different SBC modes and Restart behavior.
2. In case the CFG_LOCK_O bit is set, then the soft reset value is like the Restart value.
3. If GPIO is configured as a wake input, then it is a default wake source in SBC Fail-Safe Mode .

## PWM_CTRL

PWM Configuration Control (Address $001 \mathbf{1 0 0 0}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{x x x x} \mathbf{x x x x}{ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PWM_DC |  |  |  |  |  |  |  |

rw

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| PWM_DC | $7: 0$ | rw | PWM Duty Cycle Setting (bit0 $=$ LSB; bit7 $=$ MSB $)$ <br> $00000000_{B}, 100 \%$ Off, i.e. HS/LS $=$ Off <br> $x x x x x x x x_{B}$, On with duty cycle fraction of 255 <br> $11111111_{B}, 100 \%$ On, i.e. HS/LS always On |

## Notes

1. $0 \%$ and $100 \%$ duty cycle settings are used to have the switch turned On or Off respectively.
2. A new duty cycle configuration will become effective after the previous period is completed.
3. The desired duty cycle should be set first before GPIO is enabled as PWM HS or PWM LS.

Serial Peripheral Interface

## PWM_FREQ_CTRL

PWM Frequency Configuration Control (Address $001 \mathbf{1 1 0 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{B}$; Restart Value: 0000 00xx B

|  | Reserved |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 2$ | r | Reserved, always reads as 0 |
| PWM_FREQ | $1: 0$ | rw | Spread Spectrum Modulation Frequency Setting |
|  |  |  | $00_{B}, 100 \mathrm{~Hz}$ configuration |
|  |  |  | $01_{B}, 200 \mathrm{~Hz}$ configuration |
|  |  | $10_{\mathrm{B}}, 325 \mathrm{~Hz}$ configuration |  |
|  |  |  | $11_{\mathrm{B}}, 400 \mathrm{~Hz}$ configuration |

Note: $\quad$ frequency change will become effective after the previous period is completed

HW_CTRL_3
Hardware Control 3 (Address $001 \mathbf{1 1 0 1}_{B}$ )
POR Value: $0000 \mathbf{0 0 0 1}_{B} ; \quad$ Restart Value/Soft Reset Value: 0000 0xxx $_{B}$


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| Reserved | 7:3 | $r$ | Reserved, always reads as 0 |
| TSD_THR | 2 | rwl | Thermal Shutdown Threshold (TSD1 \& TSD2) Configuration <br> $0_{B} \quad$, Default shutdown threshold selected <br> $1_{B} \quad$, higher shutdown threshold selected |
| $\begin{aligned} & \text { ICC1_LIM_A } \\ & \text { DJ } \end{aligned}$ | 1:0 | rwl | Configuration of ICC1 current limitation <br> $00_{B}, 1$ step down from default value (-25\% of typ. default) <br> $01_{B}$, default value (typ. 1000 mA ) <br> $10_{B}$, 1 step up form default value (+20\% of default), setting not recommended <br> $11_{B}$, 2 steps up from default value ( $+50 \%$ of default), setting not recommended |

## Notes

1. In case the CFG_LOCK_1 bit is set, then the soft reset value is like the Restart value., i.e. the configuration stays unchanged.

SYS_STATUS_CTRL_0
System Status Control Low Byte (Address $001 \mathbf{1 1 1 0}_{\mathrm{B}}$ )
POR Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value/Soft Reset Value: xxxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SYS_STAT_L |  |  |  |  |  |  |  |

rW

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| SYS_STAT_L | $7: 0$ | rw | System Status Control Low Byte (bit0=LSB; bit7=MSB) <br> Dedicated byte for system configuration, access only by <br> microcontroller. Cleared after power up |

## Notes

1. The SYS_STATUS_CTRL_O register is an exception for the default values, i.e. it will keep its configured value also after a Soft Reset.
2. This byte is intended for storing system configurations of the ECU by the microcontroller and is only writable in SBC Normal Mode and readable in SBC Stop Mode. The byte is not accessible by the SBC and contents are kept also after SBC Fail-Safe, Restart Mode or after Soft Reset. It allows the microcontroller to store system configuration without loosing the data as long as the SBC supply voltage is above $V_{\text {POR,f }}$
```
SYS_STATUS_CTRL_1
System Status Control High Byte (Address 001 11111)
POR Value: 0000 00000; ; Restart Value/Soft Reset Value: xxxx xxxx B
```

| 7 | 6 | 5 | 4 | 2 | 1 | 0 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  |  |  |  |  |  |

rw

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| SYS_STAT_ | $7: 0$ | rw | System Status Control High Byte (bit8=LSB; bit15=MSB) <br> Dedicated byte for system configuration, access only by <br> microcontroller. Cleared after power up |

## Notes

1. The SYS_STATUS_CTRL_1 register has the same functionality and behavior as SYS_STATUS_CTRL_0.

Serial Peripheral Interface

### 13.5.2 Selective Wake Control Registers

## SWK_CTRL

CAN Selective Wake Control (Address $010 \mathbf{0 0 0 0}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{x x x x} \mathbf{0 0 0 0}_{B}$

| 7 |  | 4 | 2 | 0 |
| :---: | :---: | :---: | :---: | :---: |
| OSC_CAL | TRIM_EN | CANTO_MASK | Reserved | CFG_VAL |
| rW | rw | rw | $r$ | rwh |


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| OSC_CAL | 7 | rw | Oscillator Calibration Mode <br> $0_{B} \quad$, Oscillator Calibration is disabled <br> $1_{B} \quad$, Oscillator Calibration is enabled |
| TRIM_EN | 6:5 | rw | (Un)locking mechanism of oscillator recalibration <br> $00_{B}$, locked <br> $01_{\mathrm{B}}$, locked <br> $10_{\mathrm{B}}$, locked <br> $11_{\mathrm{B}}$, unlocked |
| CANTO_ MASK | 4 | rw | CAN Time Out Masking <br> $0_{B} \quad$, CAN time-out is masked - no interrupt (on pin INTN) is triggered <br> $1_{B} \quad$, CAN time-ut is signaled on INTN |
| Reserved | 3:1 | r | Reserved, always reads as 0 |
| CFG_VAL | 0 | rwh | SWK Configuration valid <br> $0_{B} \quad$, Configuration is not valid (SWK not possible) <br> $1_{B} \quad$, SWK configuration valid, needs to be set to enable SWK |

## Notes

1. TRIM_EN unlocks the oscillation calibration mode. Only the bit combination ' 11 ' is the valid unlock. The pin TXDCAN is used for oscillator synchronisation (trimming).
2. The microcontroller needs to validate the SWK configuration and set 'CFG_VAL'to '1'. The SBC will only enable SWK if CFG_VAL' to '1'. The bit is cleared automatically by the SBC after a wake-up or POR or if a SWK configuration data is changed by the microcontroller.
3. CANTO bit will only be updated inside BUS_STAT while CAN_2 is set. Therefore, an interrupt is only signalled upon occurrence of CANTO while CAN_2 (SWK is enabled) is set in SBC Normal and Stop Mode.
4. TRIM_EN also unlocks the writing to the SWK_OPT_CTRL register in order to enable the alternative low-power Receiver for Selective wake to optimize the quiescent current consumption. Only the bit combination '11' unlocks the calibrations / configurations.

SWK_BTLO_CTRL
SWK Bit Timing Logic Control1 (Address $010 \mathbf{0 0 0 1}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{1 0 1 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $x_{x x x}$ xxxx $_{B}$

| 7 | 6 | 5 | 3 | 2 | 1 | 0 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

rW

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| TBIT | $7: 0$ | rw | Number of Time Quanta in a Bit Time <br> Represents the number of time quanta in a bit time. <br> Quanta is depending on SEL_OSC_CLK $<1: 0>$ from the <br> SWK_CDR_CTRL2 register. |

## SWK_BTL1_CTRL

SWK Bit Timing Control2 (Address $010 \mathbf{0 0 1 0}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 1 1} \mathbf{0 0 1 1}_{\text {B }}$; Restart Value: $x_{x x x ~ x x x x ~}^{B}$

| 7 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved | SP |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 6$ | r | Reserved, always reads as 0 |
| SP | $5: 0$ | rw | Sampling Point Position <br> Represents the sampling point position (fractional number < 1). <br> Example: $00110011=0.796875(\sim 80 \%)$ |

SWK_ID3_CTRL
SWK WUF Identifier bits $28 . . .21$ (Address $0100011_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $x_{x x x} x_{x x x}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ID28_21 |  |  |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| ID28_21 | 7:0 | rw | WUF Identifier Bits 28...21 |

Note: Please note the configuration of the standard identifier and extended identifier. The standard identifier is configured to the bits ID18...ID28

Serial Peripheral Interface

## SWK_ID2_CTRL

SWK WUF Identifier bits 20... 13 (Address $0100100_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: xxxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

rW

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| ID20_13 | $7: 0$ | rw | WUF Identifier Bits 20...13 |

## SWK_ID1_CTRL

SWK WUF Identifier bits 12... 5 (Address $010 \mathbf{0 1 0 1}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathbf{B}}$; Restart Value: $\mathbf{x x x x} \times x x x_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ID12_5 |  |  |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| ID12_5 | $7: 0$ | rw | WUF Identifier Bits 12...5 |

## SWK_IDO_CTRL

SWK WUF Identifier bits 4... 0 (Address $0100110_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: 0xxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved |  |  | ID4_0 |  |  | RTR | IDE |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | r | Reserved, always reads as 0 |
| ID4_0 | $6: 2$ | rw | WUF Identifier Bits 4..0 |
| RTR | 1 | rw | Remote Transmission Request Field (acc. ISO 11898-1) <br> $0_{B} \quad$, Normal Data Frame <br> $1_{B} \quad$, Remote Transmission Request |
|  |  |  | rw |
| IDE | 0 | Identifier Extension Bit <br> $0_{B} \quad$, Standard Identifier Length (11 bit) <br> $1_{B} \quad$, Extended Identifier Length (29 bit) |  |

Note: $\quad$ The setting RTR = 1 is not allowed for wake-up frames according to the ISO11898-2

Serial Peripheral Interface

## SWK_MASK_ID3_CTRL

SWK WUF Identifier Mask bits $28 . . .21$ (Address $0100111^{\text {B }}$ ) POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{x x x x ~ x x x x ~}_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | MASK_ID28_21 |  |  |  |  |  |

rw

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| MASK_ID28 | $7: 0$ | rw | WUF Identifier Mask Bits 28...21 |
| _21 |  |  | $0_{B} \quad$, Unmasked - bit is ignored |
|  |  |  | $1_{B} \quad$, Masked - bit is compared in CAN frame |

Note: $\quad$ Masking WUF bits is done by setting the respective MASK bit to ' 1 '

SWK_MASK_ID2_CTRL
SWK WUF Identifier Mask bits 20... 13 (Address $010 \mathbf{1 0 0 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value: xxxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

rw

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| MASK_ID20 | 7:0 | rw | WUF Identifier Mask Bits 20...13 |
| _13 |  |  | $0_{B} \quad$, Unmasked - bit is ignored |
|  |  |  | $1_{B} \quad$, Masked - bit is compared in CAN frame |

## SWK_MASK_ID1_CTRL

SWK WUF Identifier Mask bits 12... 5 (Address $010 \mathbf{1 0 0 1}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: xxxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| MASK_ID12_5 |  |  |  |  |  |  |  |

rw

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| MASK_ID12 | 7:0 | rw | WUF Identifier Mask Bits 12...5 |
| $\ldots$ |  |  | $0_{B} \quad$, Unmasked - bit is ignored |
|  |  |  | $1_{B} \quad$,Masked - bit is compared in CAN frame |

Serial Peripheral Interface

## SWK_MASK_IDO_CTRL

SWK WUF Identifier bits 4... 0 (Address 010 1010 ${ }_{B}$ )
POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: 0xxx xx00 ${ }_{B}$


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | r | Reserved, always reads as 0 |
| MASK_ | $6: 2$ | rw | WUF Identifier MASK Bits 4..0 |
| ID4_0 |  |  | $0_{\mathrm{B}} \quad$, Unmasked - bit is ignored |
| $1_{\mathrm{B}} \quad$, Masked - bit is compared in CAN frame |  |  |  |
| Reserved | $1: 0$ | r | Reserved, always reads as 0 |

SWK_DLC_CTRL
SWK Frame Data Length Code Control (Address 010 1011 ${ }_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value: 0000 xxxx $_{B}$


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| Reserved | 7:4 | r | Reserved, always reads as 0 |
| DLC | 3:0 | rw | Payload length in number of bytes $0000_{\mathrm{B}}$, Frame Data Length $=0$ or cleared $0001_{\mathrm{B}}$, Frame Data Length $=1$ 0010 , Frame Data Length $=2$ $0011_{\mathrm{B}}$, Frame Data Length $=3$ $0100_{\mathrm{B}}$, Frame Data Length $=4$ $0101_{\mathrm{B}}$, Frame Data Length $=5$ $0110_{\mathrm{B}}$, Frame Data Length $=6$ $0111_{\mathrm{B}}$, Frame Data Length = 7 from $1000_{B}$ to $1111_{\mathrm{B}}$ Frame Data Length $=8$ |

Note: $\quad$ The number of transmitted bytes in the data field has to be indicated by the DLC. The DLC value consists of four bits. The admissible number of data bytes for a data frame is in a range from zero to eight. DLCs in the range of zero to seven indicate data fields of length of zero to seven bytes. DLCs in the range from eight to fifteen indicate data fields with a length of eight bytes. The configured DLC value has to match bit by bit with the DLC in the received wake-up frame (refer also to Chapter 5.6.2.3).

Lite CAN SBC Family
Serial Peripheral Interface

SWK_DATA7_CTRL
SWK Data7 Register (Address $010 \mathbf{1 1 0 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{x x x x ~ x x x x ~}{ }_{B}$

| 7 | 6 | 5 | 4 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |

rW

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA7 | $7: 0$ | rw | Data7 byte content(bit0=LSB; bit7=MSB) |

SWK_DATA6_CTRL
SWK Data6 Register (Address 010 1101 $_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: $\mathrm{xxxx}^{\text {xxxx }}$ B


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA6 | $7: 0$ | rw | Data6 byte content (bit0=LSB; bit7=MSB) |

SWK_DATA5_CTRL
SWK Data5 Register (Address $010 \mathbf{1 1 1 0}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value: xxxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DATA5 |  |  |  |  |  |  |  |

rW

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA5 | $7: 0$ | rw | Data5 byte content (bit0=LSB; bit7=MSB) |

SWK_DATA4_CTRL
SWK Data4 Register (Address $010 \mathbf{1 1 1 1}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value: xxxx xxxx $_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DATA4 |  |  |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA4 | $7: 0$ | rw | Data4 byte content (bit0=LSB; bit7=MSB) |

Lite CAN SBC Family
Serial Peripheral Interface

SWK_DATA3_CTRL
SWK Data3 Register (Address $011 \mathbf{0 0 0 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{x x x x ~ x x x x ~}{ }_{B}$

| 7 | 6 | 5 | 4 | 2 |  |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

rw

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA3 | $7: 0$ | rw | Data3 byte content (bit0=LSB; bit7=MSB) |

SWK_DATA2_CTRL
SWK Data2 Register (Address $011 \mathbf{0 0 0 1}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: xxxx xxxx


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA2 | $7: 0$ | rw | Data2 byte content (bit0=LSB; bit7=MSB) |

SWK_DATA1_CTRL
SWK Data1 Register (Address $011 \mathbf{0 0 1 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value: xxxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DATA1 |  |  |  |  |  |  |  |

rW

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA1 | $7: 0$ | rw | Data1 byte content (bit0=LSB; bit7=MSB) |

SWK_DATAO_CTRL
SWK Data0 Register (Address $011 \mathbf{0 0 1 1}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: xxxx xxxx ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DATAO |  |  |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| DATA0 | $7: 0$ | rw | Data0 byte content (bit0=LSB; bit7=MSB) |

## SWK_CAN_FD_CTRL

CAN FD Configuration Control Register (Address $011 \mathbf{0 1 0 0}_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{0 0 x x}$ xxxx $_{B}$

|  | 5 | 4 | 3 | 2 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved | DIS_ERR_CNT | RX_FILT_BYP |  | FD_FILTER | CAN_FD_EN |
| $r$ | rwh | rw |  | rw | rw |


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| Reserved | 7:6 | r | Reserved, always reads as 0 |
| $\begin{aligned} & \text { DIS_ERR_ } \\ & \text { CNT } \end{aligned}$ | 5 | rwh | Error Counter Disable Function <br> $0_{B} \quad$, Error Counter is enabled during SWK <br> $1_{B} \quad$, Error counter is disabled during SWK only if CAN_FD_EN = ' 1 ' |
| $\begin{aligned} & \text { RX_FILT_ } \\ & \text { BYP } \end{aligned}$ | 4 | rw | RX Receiver Filter Bypass <br> $0_{B} \quad$, RX Filter not bypassed <br> $1_{B} \quad$, RX Filter bypassed |
| FD_FILTER | 3:1 | rw | CAN FD Dominant Filter Time <br> $000_{\text {B }}, 50 \mathrm{~ns}$ <br> $001_{\mathrm{B}}, 100 \mathrm{~ns}$ <br> $010_{\mathrm{B}}, 150 \mathrm{~ns}$ <br> $011_{\mathrm{B}}, 200 \mathrm{~ns}$ <br> $100_{\mathrm{B}}, 250 \mathrm{~ns}$ <br> $101_{\mathrm{B}}, 300 \mathrm{~ns}$ <br> $110_{\mathrm{B}}, 350 \mathrm{~ns}$ <br> $111_{\mathrm{B}}, 700 \mathrm{~ns}$ |
| $\begin{aligned} & \text { CAN_FD_ } \\ & \text { EN } \end{aligned}$ | 0 | rw | Enable CAN FD Tolerant Mode $0_{B} \quad$,CAN FD Tolerant Mode disabled <br> $1_{B} \quad$, CAN FD Tolerant Mode enabled |

Note: The bit RX_FILT_BYP is bypassing the analog filter in the CAN receiver path; The FD_FILTER is not in the analog path of the CAN receiver and is not bypassed.

Note: DIS_ERR_CNT is cleared by the SBC at tsilence expiration.
Note: $\quad$ The Normal-Mode CAN receiver ( $\boldsymbol{R X}$ _ $\mathbf{W K}$ _ $\mathbf{S E L}=$ ( 1 ') has to selected with a CAN FD tolerant operation for baud rates > 1MBit/s

Serial Peripheral Interface

```
SWK_OSC_TRIM_CTRL
SWK Oscillator Trimming Register (Address \(011 \mathbf{1 0 0 0}_{B}\) )
POR / Soft Reset Value: \(x_{x x x}\) xxxx \(_{B}\); Restart Value: \(\mathbf{x x x x}\) xxx \(_{B}\)
```

| 7 | 6 | 5 | 4 | 3 | 2 | 1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved |  |  |  | TRIM_OSC |  |  |
| $r w$ |  |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | rw | Reserved, reads preset value - do not modify |
| TRIM_OSC | $6: 0$ | rw | Oscillator trimming (bit0=LSB; bit6=MSB); <br> (only writable if TRIM_EN = '11') |

Note: Due to CDR functionality, it is not required to change these values.

## SWK_OPT_CTRL

Selective Wake Options Register (Address 011 1001 $_{B}$ )
POR / Soft Reset Value: $000 \times$ xxxx $_{B}$; Restart Value: $x 00 x x_{x x} x_{B}$

| 7 |  | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| RX_WK_SEL | Reserved | Reserved |  |  |  |  |

\(\left.\begin{array}{l|l|l|l}\hline Field \& Bits \& Type \& Description <br>
\hline RX_WK_ \& 7 \& rw \& SWK Receiver selection (only accessible if TRIM_EN = '11') <br>
SEL \& \& \& 0_{B} \quad , Low-Power Receiver selected during SWK <br>

1_{B} \quad, Standard Receiver selected during SWK\end{array}\right]\)| Reserved | $6: 5$ | r | Reserved, always reads as 0 |
| :--- | :--- | :--- | :--- |
| Reserved | $4: 0$ | rw | Reserved, reads preset value - do not modify |

Note: $\quad$ The bit RX_WK_SEL is used to select the respective receiver during Selective Wake operation. The lowest quiescent current during Frame Detect Mode is achieved with the default setting RX_WK_SEL = '0', i.e. the Low-Power Receiver is already selected.

```
SWK_OSC_CAL_H_STAT
SWK Oscillator Calibration High Register (Address 011 1010}\mp@subsup{}{\textrm{B}}{}\mathrm{ )
POR / Soft Reset Value: 0000 0000; ; Restart Value: xxxx xxxx B
```

| 7 | 6 | 5 | 3 | 2 | 1 | 0 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |

Serial Peripheral Interface

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| OSC_CAL_H | $7: 0$ | r | Oscillator Calibration High Register |

SWK_OSC_CAL_L_STAT
SWK Oscillator Calibration Low Register (Address 011 1011 ${ }_{\mathrm{B}}$ ) POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{\text {B }}$; Restart Value: xxxx xxxx

| OSC_CAL_L |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| OSC_CAL_L | $7: 0$ | r | Oscillator Calibration Low Register |

## SWK_CDR_CTRL1

CDR Control 1 Register (Address $011 \mathbf{1 1 0 0}_{B}$ )
POR / Soft Reset Value: $0000 \mathbf{0 1 0 0}_{B}$; Restart Value: $0000 \times x 0 x_{B}$


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| Reserved | 7:4 | r | Reserved, always reads as 0 |
| SEL_FILT | 3:2 | rw | Select Time Constant of Filter <br> $00_{B}$, Time constant 8 <br> $01_{B}$, Time constant 16 (default) <br> $10_{\mathrm{B}}$, Time constant 32 <br> $11_{\mathrm{B}}$, adapt <br> distance between falling edges 2,3 bit: Time constant 32 distance between $f$. edges $4,5,6,7,8$ bit: Time constant 16 distance between falling edges 9,10 bit: Time constant 8 |
| Reserved | 1 | r | Reserved, always reads as 0 |
| CDR_EN | 0 | rw | Enable CDR <br> $0_{B} \quad$, CDR disabled <br> $1_{B} \quad$, CDR enabled |

Serial Peripheral Interface


Table 35 Frequency Settings of Internal Clock for the CDR

| SEL_OSC_CLK[1:0] | int. Clock for CDR |
| :--- | :--- |
| 00 | 80 MHz |
| 01 | 40 MHz |
| 10 | 20 MHz |
| 11 | 10 MHz |

Table 36 Recommended CDR Settings for Different Baud Rates

| SEL_OSC_CLK <br> [1:0] | Baudrate | SWK_BTLO_CTRL Value | SWK_CDR_LIMIT_HIGH <br> _CTRL Value | SWK_CDR_LIMIT_LOW_ <br> CTRL Value |
| :--- | :--- | :--- | :--- | :--- |
| 00 | 500 k | 10100000 | 10101000 | 10011000 |
| 01 | 500 k | 01010000 | 01010100 | 01001100 |
| 10 | 500 k | CDR Setting not recommended for this baudrate due to insufficient precision |  |  |
| 11 | 500 k | CDR Setting not recommended for this baudrate due to insufficient precision |  |  |
| 00 | 250 k | CDR Setting not to be used due to excessive time quanta (counter overflow) |  |  |
| 01 | 250 k | 10100000 | 10101000 | 10011000 |
| 10 | 250 k | 01010000 | 01010100 | 01001100 |
| 11 | 250 k | CDR Setting not recommended for this baudrate due to insufficient precision |  |  |
| 00 | 125 k | CDR Setting not to be used due to excessive time quanta (counter overflow) |  |  |
| 01 | 125 k | CDR Setting not to be used due to excessive time quanta (counter overflow) |  |  |
| 10 | 125 k | 10100000 | 01010000 | 10101000 |
| 11 | $\|l\| l$ |  |  |  |

Serial Peripheral Interface

## SWK_CDR_LIMIT_HIGH_CTRL

SWK CDR Upper Limit Control (Address $011 \mathbf{1 1 1 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{1 0 1 0} \mathbf{1 0 0 0}_{\mathbf{B}}$; Restart Value: $\mathbf{x x x x}$ xxxx $_{B}$

| CDR_LIM_H |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |

rW

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| CDR_LIM_H | $7: 0$ | rw | Upper Bit Time Detection Range of Clock and Data Recovery <br> SWK_BTLO_CTRL values $>+5 \%$ is clamped |

SWK_CDR_LIMIT_LOW_CTRL
SWK CDR Lower Limit Control (Address $011 \mathbf{1 1 1 1}_{\mathrm{B}}$ )
POR / Soft Reset Value: $1001 \mathbf{1 0 0 0}_{\mathrm{B}}$; Restart Value: $\mathbf{x x x x}$ xxxx $_{B}$

| 7 | 6 | 4 | 3 | 2 | 1 | 0 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

rw

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| CDR_LIM_L | 7:0 | rw | Lower Bit Time Detection Range of Clock and Data Recovery <br> SWK_BTLO_CTRL values $<-5 \%$ is clamped |

## Serial Peripheral Interface

### 13.6 SPI Status Information Registers

READ/CLEAR Operation (see also Chapter 13.3):

- One 16-bit SPI command consist of two bytes:
- the 7-bit address and one additional bit for the register access mode and
- following the data byte

The numbering of following bit definitions refers to the data byte and correspond to the bits D0...D7 and to the SPI bits $8 \ldots 15$ (see also figure).

- There are two different bit types:
- 'r' = READ: read only bits (or reserved bits)
- 'rc' = READ/CLEAR: readable and clearable bits
- Reading a register is done byte wise by setting the SPI bit 7 to " 0 " (= Read Only)
- Clearing a register is done byte wise by setting the SPI bit 7 to " 1 "
- SPI status registers are in general not cleared or changed automatically (an exception are the WD_FAIL bits). This must be done by the microcontroller via SPI command
The registers are addressed wordwise.
Table 37 Register Overview: SPI Status Information Registers

| Register Short Name | Register Long Name | Offset Address | Reset Value |
| :--- | :--- | :--- | :--- |
| General Status Registers |  |  |  |
| SUP_STAT_1 | Supply Voltage Fail Status | $1000000_{\mathrm{B}}$ | Page 152 |
| SUP_STAT_0 | Supply Voltage Fail Status | $1000001_{\mathrm{B}}$ | Page 153 |
| THERM_STAT | Thermal Protection Status | $1000010_{\mathrm{B}}$ | Page 154 |
| DEV_STAT | Device Information Status | $1000011_{\mathrm{B}}$ | Page 154 |
| BUS_STAT | Bus Communication Status | $1000100_{\mathrm{B}}$ | Page 155 |
| WK_STAT_0 | Wake-up Source and Information Status 0 | $1000110_{\mathrm{B}}$ | Page 156 |
| WK_STAT_1 | Wake-up Source and Information Status 1 | $1000111_{\mathrm{B}}$ | Page 157 |
| WK_LVL_STAT | WK Input Level | $1001000_{\mathrm{B}}$ | Page 157 |
| GPIO_OC_STAT | GPIO Overcurrent Status | $1010100_{\mathrm{B}}$ | Page 158 |
| GPIO_OL_STAT | GPIO Open-Load Status | $1010101_{\mathrm{B}}$ | Page 158 |

Selective Wake Status Registers

| SWK_STAT | Selective Wake Status | $1110000_{B}$ | Page 159 |
| :--- | :--- | :--- | :--- |
| SWK_ECNT_STAT | SWK Status | $1110001_{B}$ | Page 159 |
| SWK_CDR_STAT1 | CDR Status 1 Register | $1110010_{B}$ | Page 160 |
| SWK_CDR_STAT2 | CDR Status 2 Register | $1110011_{B}$ | Page 160 |

Family and Product Information Register

| FAM_PROD_STAT | Family and Product Identification Register | $1111110_{B}$ | Page $\mathbf{1 6 1}$ |
| :--- | :--- | :--- | :--- |

## Serial Peripheral Interface

### 13.6.1 General Status Registers

## SUP_STAT_1

Supply Voltage Fail Status (Address $\mathbf{1 0 0 0 0 0 0}{ }_{B}$ )
POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: 0xx0 00xx


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| Reserved | 7 | r | Reserved, always reads as 0 |
| VS_UV | 6 | rc | VS Undervoltage Detection ( $\mathrm{V}_{\mathrm{s}, \mathrm{uv}}$ ) <br> $0_{B} \quad$, No VS undervoltage detected <br> $1_{B} \quad$,VS undervoltage detected (detection is only active when VCC1 is enabled - see also note below) |
| vs_OV | 5 | rc | VS Overvoltage Detection ( $\mathbf{V}_{\mathrm{s}, \mathrm{uv}}$ ) <br> $0_{B} \quad$, No VS overvoltage detected <br> $1_{B} \quad$,VS overvoltage detected (detection is only active when VCC1 <br> is enabled - see also note below) |
| Reserved | 4:2 | r | Reserved, always reads as 0 |
| VCC1_ OV | 1 | rc | VCC1 Overvoltage Detection ( $\mathbf{V}_{\text {cc1,ov,r }}$ ) <br> $0_{B} \quad$, No VCC1 overvoltage warning <br> $1_{B} \quad, \mathrm{VCC1}$ overvoltage detected |
| VCC1 WARN | 0 | rc | VCC1 Undervoltage Prewarning ( $\mathrm{V}_{\mathrm{Pw}, \mathrm{f}}$ ) <br> $0_{B} \quad$, No VCC1 undervoltage prewarning <br> $1_{B} \quad$,VCC1 undervoltage prewarning detected |

## Notes

1. The VCC1 undervoltage prewarning threshold $\boldsymbol{V}_{P W, f} / \boldsymbol{V}_{P W, r}$ is a fixed threshold and independent of the VCC1 undervoltage reset thresholds.
2. VS under voltage monitoring is not available in SBC Stop Mode due to current consumption saving requirements. Exception: VS under voltage detection is also available in SBC Stop Mode if the VCC1 load current is above the active peak threshold (I_PEAK_TH) or if VCC1 is below the VCC1 prewarning threshold (VCC1_ WARN is set)
3. VS over voltage monitoring is not available in SBC Stop Mode due to current consumption saving requirements. Exception: VS over voltage detection is always available when the charge pump is enabled (CP_EN = ' 1 ') and also in SBC Stop Mode if the VCC1 load current is above the active peak threshold (I_PEAK_TH) or if VCC1 is below the VCC1 prewarning threshold (VCC1_ WARN is set)

Serial Peripheral Interface

## SUP_STAT_0

Supply Voltage Fail Status (Address $\mathbf{1 0 0} \mathbf{0 0 0 1}_{\text {B }}$ )
POR / Soft Reset Value: y000 $\mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: $x \mathbf{0 0 x} \times x \mathbf{x}$ x $_{\text {B }}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| POR | Reserved | VCC2_OT | VCC2_UV | VCC1_SC | Reserved | VCC1_UV |  |
| rC | r |  |  | rC | rC | rC | r |


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| POR | 7 | rc | Power-On Reset Detection $\begin{array}{ll} 0_{B} & , \text { No POR } \\ 1_{B} & , \text { POR occurred } \end{array}$ |
| Reserved | 6:5 | r | Reserved, always reads as 0 |
| VCC2_OT | 4 | rc | VCC2 Over Temperature Detection <br> $0_{B} \quad$, No over temperature <br> $1_{B} \quad$,VCC2 over temperature detected |
| VCC2_UV | 3 | rc | VCC2 Under Voltage Detection ( $\mathrm{V}_{\mathrm{cc} 2, \mathrm{uv}, \mathrm{f}}$ ) <br> $0_{B} \quad$, No VCC2 Under voltage <br> $1_{B} \quad$, VCC2 2 under voltage detected |
| VCC1_SC | 2 | rc | VCC1 Short to GND Detection (<Vrtx for $\mathbf{t} \boldsymbol{>} \mathbf{2 m s}$ after switch On) <br> $0_{B} \quad$, No short <br> $1_{B} \quad$,VCC1 short to GND detected |
| Reserved | 1 | r | Reserved, always reads as 0 |
| VCC1_UV | 0 | rc | VCC1 UV-Detection (due to Vrtx reset) <br> $0_{B} \quad$, No VCC1_UV detection <br> $1_{B} \quad$, VCC1 UV-Fail detected |

## Notes

1. The MSB of the POR/Soft Reset value is marked as ' $y$ ': the default value of the POR bit is set after Power-on reset (POR value $=1000$ 0000). However it is cleared after a SBC Soft Reset command (Soft Reset value $=$ 0000 0000).
2. During Sleep Mode, the bits VCC1_SC, VCC1_OV and VCC1_UV will not be set when VCC1 is Off
3. The VCC1_UV bit is never updated in SBC Restart Mode, in SBC Init Mode it is only updated after RSTN was released, it is always updated in SBC Normal and Stop Mode, and it is always updated in any SBC modes in a VCC1_SC condition (after VCC1_UV = 1 for >2ms).

Serial Peripheral Interface

THERM_STAT
Thermal Protection Status (Address $100 \mathbf{0 0 1 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value: 0000 xxxx $_{B}$


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 4$ | r | Reserved, always reads as 0 |
| TSD2_SAFE | 3 | rc | TSD2 Thermal Shut-Down Safe State Detection <br> $0_{B} \quad$, No TSD2 safe state detected <br> $1_{B} \quad$, TSD2 safe state detected: >16 consecutive TSD2 events <br> occurred, next TSD2 waiting time is 60s |
| TSD2 | 2 | rc | TSD2 Thermal Shut-Down Detection <br> $0_{B} \quad$, No TSD2 event <br> $1_{B} \quad$, TSD2 OT detected - leading to SBC Fail-Safe Mode |
| TSD1 | 1 | rc | TSD1 Thermal Shut-Down Detection <br> $0_{B} \quad$, No TSD1 fail <br> $1_{B} \quad$, TSD1 OT detected (affected module is disabled) |
| TPW | 0 | rc | Thermal Pre Warning <br> $0_{B} \quad$, No Thermal Pre warning <br> $1_{B} \quad$, Thermal Pre warning detected |

Note: $\quad$ Temperature warning and shutdown bits are not reset automatically, even if the temperature pre warning or the TSD condition is not present anymore.

## DEV_STAT

Device Information Status (Address $100 \mathbf{0 0 1 1}_{\text {B }}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathbf{B}}$; Restart Value: $\mathbf{x x 0 0} \mathbf{x x x x}$ B


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| DEV_STAT | 7:6 | rc | Device Status before Restart Mode <br> $00_{B}$, Cleared (Register must be actively cleared) <br> $01_{B}$, Restart due to failure (WD fail, TSD2, VCC1_UV, trial to access SLEEP MODE without any wake source activated); also after a wake-up from Fail-Safe Mode <br> $10_{B}$, Sleep Mode <br> $11_{B}$, Reserved |
| Reserved | 5:4 | r | Reserved, always reads as 0 |

Serial Peripheral Interface

| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| WD_FAIL | 3:2 | rh | Number of WD-Failure Events (1/2 WD failures depending on CFG1) <br> $00_{B}$, No WD Fail <br> $01_{B} \quad, 1 \times$ WD Fail, FO activation - Config 2 selected <br> $10_{B} \quad, 2 \times$ WD Fail, FO activation - Config $1 / 3 / 4$ selected <br> $11_{B} \quad$, Reserved (never reached) |
| SPI_FAIL | 1 | rc | SPI Fail Information <br> $0_{B} \quad$, No SPI fail <br> $1_{B} \quad$, Invalid SPI command detected |
| FAILURE | 0 | rc | Activation of Fail Output FO <br> $0_{B} \quad$, No Failure <br> $1_{B}$, Failure occurred |

## Notes

1. The bits DEV_STAT show the status of the device before exiting SBC Restart Mode. Either the device came from regular SBC Sleep Mode or a failure (SBC Restart or SBC Fail-Safe Mode) occurred. See also "Invalid SPI
Commands" in Chapter 13.2. Coming from SBC Sleep Mode will also be shown if there was a trial to enter SBC Sleep Mode without having cleared all wake flags before.
2. The WD_FAIL bits are implemented as a counter and are the only status bits, which are cleared automatically by the SBC. See also Chapter 11.1.1.
3. The SPI_FAIL bit can only be cleared via SPI command
4. In case of Config 2/4 the WD_Fail counter is frozen in case of WD trigger failure until a successful WD trigger.

## BUS_STAT

Bus Communication Status (Address $\mathbf{1 0 0} \mathbf{0 1 0 0}_{B}$ )
POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{B} ; \quad$ Restart Value: 000x xxxx ${ }_{B}$

| 7 | 5 4 |  | 3 | 10 |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved | Reserved | CANTO | SYSERR | CAN_FAIL | VCAN_UV |
| $r$ | $r$ | rc | rc | rc | rc |


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| Reserved | 7 | $r$ | Reserved, always reads as 0 |
| Reserved | 6:5 | r | Reserved, always reads as 0 |
| CANTO | 4 | rc | CAN Time Out Detection <br> $0_{B} \quad$, Normal operation <br> $1_{B} \quad$, CAN Time Out detected |
| SYSERR | 3 | rc | SWK System Error <br> $0_{B} \quad$, Selective Wake Mode is possible <br> $1_{B} \quad$, System Error detected, SWK enabling not possible |
| CAN_FAIL | 2:1 | rc | CAN Failure Status <br> $00_{B}$, No error <br> $01_{B}$, CAN TSD shutdown <br> $10_{B}$, CAN_TXD_DOM: TXD dominant time out detected (P_9.3.39) <br> $11_{B} \quad$, CAN_BUS_DOM: BUS dominant time out detected (P_9.3.40) |

Serial Peripheral Interface

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| VCAN_UV | 0 | rc | Under voltage CAN Bus Supply |
|  |  |  | $0_{B} \quad$, Normal operation |
|  |  |  | $1_{B} \quad$, CAN Supply under voltage detected. Transmitter disabled |

## Notes

1. CAN Recovery Conditions:
1.) TXD Time Out: TXD goes High or transmitter is set to Wake Capable or switched Off;
2.). Bus dominant time out: Bus will become recessive or transceiver is set to Wake Capable or switched Off.
3.) Supply under voltage: as soon as the threshold is crossed again, i.e. VCAN > VCAN_UV for CAN
4.)In all cases (also for TSD shutdown): to enable the Bus transmission again, TXD needs to be High (recessive) for a certain time (transmitter enable time).
2. The VCAN_UV comparator is enabled if the mode bit CAN_1 = ' 1 ', i.e. in CAN Normal or CAN Receive Only Mode.
3. CANTO is set only if CAN2 $=1$ (=SWK Mode enabled). It is set as soon as CANSIL was set and will stay set even in CANSIL it is reset. An interrupt is issued in SBC Stop- and SBC Normal Mode as soon as CANTO is set and the interrupt is not masked out, i.e. CANTO_MASK must be set to ' 1 '.
4. The SYSERR Flag is set in case of a configuration error and in case of an error counter overflow ( $n>32$ ). It is only updated if SWK is enabled (CAN_2 = ' 1 '). See also Chapter 5.6.3.6.
5. CANTO is set asynchronously to the INTN pulse. In order to prevent undesired clearing of CANTO and thus possibly missing this interrupt, the bit is prevented from clearing (i.e. cannot be cleared) until the next falling edge of INTN.

## WK_STAT_0

Wake-up Source and Information Status 0 (Address $100 \mathbf{0 1 1 0}_{B}$ ) POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\text {B }}$; Restart Value: 00xx x00x ${ }_{\text {B }}$


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 6$ | r | Reserved, always reads as 0 |
| CAN_WU | 5 | rc | Wake-up via CAN Bus <br> $0_{\mathrm{B}} \quad$, No Wake-up <br> $1_{\mathrm{B}} \quad$, Wake-up |
| TIMER_WU | 4 | rc | Wake-up via TimerX <br> $0_{\mathrm{B}} \quad$, No Wake-up <br> $1_{\mathrm{B}} \quad$, Wake-up |
| Reserved | $3: 1$ | r | Reserved, always reads as 0 |
| WK_WU | 0 | rC | Wake-up via WK <br> $0_{\mathrm{B}} \quad$, No Wake-up <br> $1_{\mathrm{B}} \quad$, Wake-up |

Note: $\quad$ The respective wake source bit will also be set when the device is woken from SBC Fail-Safe Mode

Lite CAN SBC Family
Serial Peripheral Interface

WK_STAT_1
Wake-up Source and Information Status 1 (Address $100 \mathbf{0 1 1 1}_{\text {B }}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: 0x00 0000 ${ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Reserved |  | GPIO_WK_WU | Reserved |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 5$ | r | Reserved, always reads as 0 |
| GPIO_WK_ | 4 | rc | Wake-up via GPIO if configured as WK <br> $0_{B} \quad$, No Wake-up <br> WU |
|  |  | $1_{\mathrm{B}} \quad$, Wake-up |  |
| Reserved | $3: 0$ | r | Reserved, always reads as 0 |

## WK_LVL_STAT

WK Input Level (Address $\mathbf{1 0 0} \mathbf{1 0 0 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathrm{xx0x} \mathbf{0 0 0 x}_{\mathrm{B}}$; Restart Value: $\mathrm{xx0x} 000 \mathrm{x}_{\mathrm{B}}$


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| $\begin{aligned} & \text { SBC_DEV } \\ & \text { _LVL } \end{aligned}$ | 7 | r | Status of SBC Operating Mode at TEST Pin <br> $0_{B} \quad$, User Mode activated <br> $1_{B} \quad$, SBC Development Mode activated |
| $\begin{aligned} & \text { CFGO_STAT } \\ & \text { E } \end{aligned}$ | 6 | r | Device Configuration Status on pin INTN <br> $0_{B} \quad$, No external pull-up resistor connected on INTN (Config 2/4) <br> $1_{B} \quad$, External pull-up resistor connected on INTN (Config 1/3) |
| Reserved | 5 | r | Reserved, always reads as 0 |
| GPIO_LVL | 4 | r | Status of GPIO if configured as GPIO (WK, LS or HS function) $\begin{array}{\|ll} 0_{B} & , \text { Low Level (=0) } \\ 1_{B} & , \text { High Level (=1) } \end{array}$ |
| Reserved | 3:1 | $r$ | Reserved, always reads as 0 |
| WK_LVL | 0 | r | Status of WK $\begin{array}{ll} 0_{B} & , \text { Low Level }(=0) \\ 1_{B} & , \text { High Level }(=1) \end{array}$ |

Note: $\quad$ WK_LVL_STAT is updated in SBC Normal and Stop Mode and also in SBC Init and Restart Mode. See below for exceptions. In Cyclic Sense or wake mode, the registers contain the sampled level, i.e. the registers are updated after every sampling.

## Serial Peripheral Interface

Note: $\quad$ GPIO_LVL is updated in SBC Normal and Stop Mode and also in SBC Init and Restart Mode if configured as wake input, low-side switch or high-side switch without Cyclic Sense (in case of FO configuration the status is flagged with the FAILURE bit). In case the respective feature is disabled then the WK_LVL_STAT bit will not be updated.

Note: In case the HV measurement function is enabled (WK_MEAS=1), then the bits WK_LVL and GPIO_LVL are not updated and reset.

## GPIO_OC_STAT

GPIO Overcurrent Status (Address $101 \mathbf{0 1 0 0}_{\text {B }}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{0 x 0 0} \mathbf{0 0 0 0}_{B}$

| 7 | 6 | 5 | 4 | 3 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved | GPIO_OC |  |  | Reserved |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | r | Reserved, always reads as 0 |
| GPIO_OC | 6 | rC | Overcurrent Detection on GPIO (if configured as LS or HS) <br>  |
| Reserved $\quad$ No OC |  |  |  |
| $1_{B} \quad$, OC detected |  |  |  |

Note: $\quad$ The same status bit is used for the low-side and high-side configuration. The bit always applies for the actual configuration. In case the switch is disabled or another configuration is used then a flagged bit will stay set until it is cleared by the microcontroller;

GPIO_OL_STAT
GPIO Open-Load Status (Address 101 0101 ${ }_{B}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: $\mathbf{0 \times 0 0} \mathbf{0 0 0 0}_{\mathrm{B}}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved | GPIO_OL | Reserved |  |  |  |  |  |
| $r$ | rc |  |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | r | Reserved, always reads as 0 |
| GPIO_OL | 6 | rc | Open-Load Detection on GPIO (if configured as HS) <br> $0_{B} \quad$, No OL <br> $1_{B} \quad$, OL detected |
| Reserved | $5: 0$ | r | Reserved, always reads as 0 |

Serial Peripheral Interface

### 13.6.2 Selective Wake Status Registers

## SWK_STAT

Selective Wake Status (Address $\mathbf{1 1 1} \mathbf{0 0 0 0}_{B}$ )
POR / Soft Reset Value: $0000 \mathbf{0 0 0 0}_{B}$; Restart Value: $\mathbf{0 x 0 0} \mathbf{x x x x}$ B

| 7 | 6 | 5 | 4 | 3 | 2 | 1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved | SYNC | Reserved | CANSIL | SWK_SET | WUP | WUF |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | 7 | r | Reserved, always reads as 0 |
| SYNC | 6 | r | Synchronisation (at least one CAN frame without fail must have <br> been received) |

$0_{B} \quad$, SWK function not working or not synchronous to CAN bus
$1_{B} \quad$,Valid CAN frame received, SWK function is synchronous to CAN bus

|  |  |  | CAN bus |
| :---: | :---: | :---: | :---: |
| Reserved | 5:4 | r | Reserved, always reads as 0 |
| CANSIL | 3 | r | CAN Silent Time during SWK operation <br> $0_{B} \quad$,tsilence not exceeded <br> $1_{B} \quad$, set if tsilence is exceeded. |
| SWK_SET | 2 | $r$ | $\begin{array}{ll}\text { Selective Wake Activity } \\ \mathrm{O}_{\mathrm{B}} & \text {, Selective Wake is not active } \\ 1_{\mathrm{B}} & \text {, Selective Wake is activated }\end{array}$ |
| WUP | 1 | r | Wake-up Pattern Detection <br> $0_{B} \quad$, No WUP <br> $1_{B} \quad$, WUP detected |
| WUF | 0 | r | SWK Wake-up Frame Detection (acc. ISO 11898-2:2016) <br> $0_{B} \quad$, No WUF <br> $1_{B} \quad$, WUF detected |

Note: $\quad$ SWK_SET is set to flag that the selective wake functionality is activated (SYSERR $=0$, CFG_VAL $=1$, CAN_2 = 1). The selective wake function is activated via a CAN mode change, except if CAN = ' 100 '.

## SWK_ECNT_STAT

SWK Status (Address 111 0001 $_{\text {B }}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathbf{B}}$; Restart Value: $\mathbf{0 0 x x ~ x x x x ~}_{\text {B }}$

| 7 | 6 | 5 | 4 | 3 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Reserved |  |  |  |  |  |  |
| $r$ |  |  | ECNT |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| Reserved | $7: 6$ | r | Reserved, always reads as 0 |

Serial Peripheral Interface

| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| ECNT | $5: 0$ | r | SWK CAN Frame Error Counter |
|  |  |  | $000000_{B}$, No Frame Error |
|  |  |  | $1111_{B}$, 31 Frame Errors have been counted |
|  |  |  | $0000_{B}$, Error counter overflow - SWK function is disabled |

Note: If a frame has been received that is valid according to ISO 11898-1 and the counter is not zero, then the counter shall be decremented. If the counter has reached a value of 32, the following actions shall be performed: Selective Wake function shall be disabled, SYSERR shall be set and CAN Wake Capable function shall be enabled, which leads to a wake-up with the next WUP.

## SWK_CDR_STAT1

CDR Status 1 Register (Address $111 \mathbf{0 0 1 0}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{1 0 1 0} \mathbf{0 0 0 0}_{\mathbf{B}}$; Restart Value: xxxx xxxx $_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| NAVG_SAT | $7: 0$ | r | Output Value from Filter Block <br> N_AVG is representing the integer part of the number of selected <br> input clock frequency per CAN bus bit. <br> N_AVG[11:4] e.g.160.75 |

SWK_CDR_STAT2
CDR Status 2 Register (Address $111 \mathbf{0 0 1 1}_{\mathrm{B}}$ )
POR / Soft Reset Value: $\mathbf{0 0 0 0} \mathbf{0 0 0 0}_{\mathrm{B}}$; Restart Value: $\mathrm{xxxx}^{\mathbf{~ x x x x}}{ }_{B}$

| 7 | 6 | 5 | 4 | 3 | 2 | 1 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | NAVG_SAT |  |  |  |  |  |


| Field | Bits | Type | Description |
| :--- | :--- | :--- | :--- |
| NAVG_SAT | $7: 4$ | r | Output Value from Filter Block <br> N_AVG is representing the fractional part of the number of selected <br> input clock frequency per CAN bus bit. <br> N_AVG[3:0] e.g.160.75 |
| Reserved | $3: 0$ | r | Reserved, always reads as 0 |

### 13.6.3 Family and Product Information Register

FAM_PROD_STAT
Family and Product Identification Register (Address $1111110^{1_{B}}$ )
POR / Soft Reset Value: 0101 yyyу ${ }_{\text {в }}$ Restart Value: 0101 уууу $_{\text {в }}$


| Field | Bits | Type | Description |
| :---: | :---: | :---: | :---: |
| FAM | 7:4 | r | SBC Family Identifier (bit4=LSB; bit7=MSB) $0001_{B}$, Driver SBC Family 00 10, , DC/DC-SBC Family $0011_{\mathrm{B}}$, Mid-Range SBC Family $0100_{B}$, Multi-CAN SBC Family $0101_{\mathrm{B}}$, LITE SBC Family $0111_{B}$, Mid-Range+ SBC Family $\mathrm{xxx} \mathrm{x}_{\mathrm{B}}$, reserved for future products |
| PROD | 3:0 | r | ```SBC Product Identifier (bit0=LSB; bit3=MSB) \(0110_{\mathrm{B}}\), TLE9461ES (VCC1 = 5V, no SWK) / TLE9461-3ES (VCC1 = 5V, SWK) \(0111_{\mathrm{B}}\), TLE9461ESV33 (VCC1 = 3.3V, no SWK) / TLE9461-3ESV33 (VCC1 = 3.3V, SWK) \(1110_{\mathrm{B}}\), TLE9471ES (VCC1 = 5V, no SWK) / TLE9471-3ES(VCC1 = 5V, SWK) \(1111_{\mathrm{B}}\), TLE9471ESV33 (VCC1 = 3.3V, no SWK) / TLE9471-3ESV33 (VCC1 = 3.3V, SWK)``` |

## Notes

1. The actual default register value after $P O R$, Soft Reset or Restart of $P R O D$ depends on the respective device. Therefore the value ' $y$ ' is specified.
2. SWK = Selective Wake feature in CAN Partial Networking standard

Serial Peripheral Interface

### 13.7 Electrical Characteristics

## Table 38 Electrical Characteristics

$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V}, T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$, all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | Min. | Typ. | Max. |  |  |

## SPI frequency

| Maximum SPI frequency | $f_{\text {SPI, max }}$ | - | - | 4.0 | MHz | $1)$ | P_16.7.1 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |

SPI Interface; Logic Inputs SDI, CLK and CSN

| H-input Voltage Threshold | $V_{1 H}$ | - | - | $\begin{array}{\|l\|} \hline 0.7 \times \\ V_{\mathrm{CC} 1} \\ \hline \end{array}$ | V | - | P_16.7.2 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| L-input Voltage Threshold | $V_{\text {IL }}$ | $\begin{aligned} & 0.3 \times \\ & V_{\mathrm{CC} 1} \end{aligned}$ | - | - | V | - | P_16.7.3 |
| Hysteresis of input Voltage | $V_{\mathrm{IHY}}$ | $\begin{array}{\|l} 0.08 \times \\ V_{\mathrm{CC} 1} \\ \hline \end{array}$ | $\begin{aligned} & 0.12 \times \\ & V_{\mathrm{CC} 1} \\ & \hline \end{aligned}$ | $\begin{aligned} & 0.4 \times \\ & V_{\mathrm{CC} 1} \end{aligned}$ | V | 1) | P_16.7.4 |
| Pull-up Resistance at pin CSN | $R_{\text {ICSN }}$ | 25 | 40 | 55 | $\mathrm{k} \Omega$ | $V_{\text {CSN }}=0.7 \times V_{\text {CC1 }}$ | P_16.7.5 |
| Pull-down Resistance at pin SDI and CLK | $R_{\text {ICLK/SDI }}$ | 25 | 40 | 55 | $k \Omega$ | $\begin{aligned} & V_{\mathrm{SDI} / \mathrm{CLK}}= \\ & 0.2 \times V_{\mathrm{CC} 1} \end{aligned}$ | P_16.7.6 |
| Input Capacitance at pin CSN, SDI or CLK | $C_{1}$ | - | 10 | - | pF | 1) | P_16.7.7 |

## Logic Output SDO

| H-output Voltage Level | $V_{\text {SDOH }}$ | $\begin{aligned} & 0.8 \times \\ & V_{\mathrm{CC} 1} \\ & \hline \end{aligned}$ | - | - | V | $I_{\text {DOH }}=-1.6 \mathrm{~mA}$ | P_16.7.8 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| L-output Voltage Level | $V_{\text {SDOL }}$ | - | - | $\begin{aligned} & 0.2 \times \\ & V_{\mathrm{CC} 1} \end{aligned}$ | V | $I_{\text {DOL }}=1.6 \mathrm{~mA}$ | P_16.7.9 |
| Tristate Leakage Current | $I_{\text {SDOLK }}$ | -10 | - | 10 | $\mu \mathrm{A}$ | $\begin{aligned} & V_{\mathrm{CSN}}=V_{\mathrm{CC} 1} ; \\ & 0 \mathrm{~V}<V_{\mathrm{DO}}<V_{\mathrm{CC1}} \end{aligned}$ | P_16.7.10 |
| Tristate Input Capacitance | $C_{\text {SDO }}$ | - | 10 | 15 | pF | 1) | P_16.7.11 |

Data Input Timing ${ }^{1)}$

| Clock Period | $t_{\text {pCLK }}$ | 250 | - | - | ns | - | P_16.7.12 |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Clock High Time | $t_{\text {CLKH }}$ | 125 | - | - | ns | - | P_16.7.13 |
| Clock Low Time | $t_{\text {CLKL }}$ | 125 | - | - | ns | - | P_16.7.14 |
| Clock Low before CSN Low | $t_{\text {bef }}$ | 125 | - | - | ns | - | P_16.7.15 |
| CSN Setup Time | $t_{\text {lead }}$ | 250 | - | - | ns | - | P_16.7.16 |
| CLK Setup Time | $t_{\text {lag }}$ | 250 | - | - | ns | - | P_16.7.17 |
| Clock Low after CSN High | $t_{\text {beh }}$ | 125 | - | - | ns | - | P_16.7.18 |
| SDI Set-up Time | $t_{\text {DISU }}$ | 100 | - | - | ns | - | P_16.7.19 |
| SDI Hold Time | $t_{\text {DIHO }}$ | 50 | - | - | ns | - | P_16.7.20 |
| Input Signal Rise Time at pin <br> SDI, CLK and CSN | $t_{\text {rIN }}$ | - | - | 50 | ns | - | P_16.7.21 |

## Serial Peripheral Interface

Table 38 Electrical Characteristics (cont'd)
$V_{\mathrm{S}}=5.5 \mathrm{~V}$ to $28 \mathrm{~V}, T_{\mathrm{j}}=-40^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$, all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

| Parameter | Symbol | Values |  |  | Unit | Note or <br> Test Condition | Number |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | Min. | Typ. | Max. |  |  | P_16.7.22 |
| Input Signal Fall Time at pin <br> SDI, CLK and CSN |  | - | - | 50 | ns | - |  |
| Delay Time for Mode Changes | $t_{\text {Del,Mode }}$ | - | - | 6 | $\mu \mathrm{~s}$ | 2) includesinternal <br> oscillator <br> tolerance | P_16.7.23 |
| CSN High Time |  |  |  |  |  |  |  |

Data Output Timing ${ }^{1)}$

| SDO Rise Time | $t_{\text {rSDO }}$ | - | 30 | 80 | ns | $C_{\mathrm{L}}=100 \mathrm{pF}$ | $P_{-} 16.7 .25$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| SDO Fall Time | $t_{\text {fSDO }}$ | - | 30 | 80 | ns | $C_{\mathrm{L}}=100 \mathrm{pF}$ | $P_{\_} 16.7 .26$ |
| SDO Enable Time | $t_{\text {ENSDO }}$ | - | - | 50 | ns | low impedance | $P_{-} 16.7 .27$ |
| SDO Disable Time | $t_{\text {DISSDO }}$ | - | - | 50 | ns | high impedance | $P_{-} 16.7 .28$ |
| SDO Valid Time | $t_{\text {VASDO }}$ | - | - | 50 | ns | $C_{\mathrm{L}}=100 \mathrm{pF}$ | $P_{-} 16.7 .29$ |

1) Not subject to production test; specified by design
2) Applies to all mode changes triggered via SPI commands


Figure 49 SPI Timing Diagram

Note: $\quad$ Numbers in drawing correlate to the last 2 digits of the Number field in the Electrical Characteristics table.

Application Information

## 14 Application Information

Note: $\quad$ The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty of a certain functionality, condition or quality of the device.

### 14.1 Application Diagrams



Figure 50 TLE9461-3ES V33 Application Diagram

## Notes

1. This is a very simplified example of an application circuit. The function must be always verified in the real application.
2. Reverse polarity protection circuitry ( $D 2, R 10, R 11$ ) is mandatory for reverse polarity requirements, i.e. if load is not to be turned On. To further reduce the quiescent current, a diode can be placed optionally in series with GND and R11.

Application Information

Figure 51 shows the required circuitry for an off-board LED control using the GPIO pin with the high-side switch configuration.


Figure 51 Simplified Application Diagram showing a off-board LED control with the GPIO pin

Note: $\quad$ This is a very simplified example of an application circuit. The off-board LED control function must be verified in the real application. The external circuitry is a minimum requirement and may vary depending on respective requirements. The same protection requirments apply for the configuration of FO/GPIO as low-side switch or wake input.

Application Information


Figure 52 Simplified Application Diagram showing the Alternative High-Voltage Measurement Function via WK/SENSE and FO/GPIO

Note: $\quad$ This is a simplified example of an application circuit. The function must be verified in the real application. WK must be connected to signal to be measured and FO/GPIO is the output to the microcontroller supervision function. The maximum current into WK must be $<500 \mathrm{uA}$. The minimum current into WK should be >5uA to ensure proper operation.

## Lite CAN SBC Family

Application Information


Figure 53 Increasing the Robustness of the pin TEST during Debugging or Programming

Application Information

Table 39 Bill of Material for Simplified Application Diagram

| Ref. | Typical Value | Purpose / Comment |
| :---: | :---: | :---: |
| Capacitances |  |  |
| C2 | $68 \mu \mathrm{~F}$ | Buffering capacitor to cut off battery spikes, value depending on application requirements |
| C3 | 100nF ceramic | EMC, blocking capacitor, ceramic X 7 R or equivalent, $\mathrm{ESR}<50 \mathrm{~m} \Omega$ |
| C4 | $2.2 \mu \mathrm{~F}$ low ESR | Blocking capacitor, min. $1 \mu \mathrm{~F}$ for stability and max. $47 \mu \mathrm{~F}$ recommended |
| C5 | 100nF ceramic | Spike filtering, ceramic X7R or equivalent, ESR $<50 \mathrm{~m} \Omega$ to improve stability of supply for microcontroller; not needed for SBC |
| C6 | $2.2 \mu \mathrm{~F}$ low ESR | Blocking capacitor, min. 470nF for stability; if used for CAN supply place a 100 nF ceramic capacitor in addition very close to VCAN pin for optimum EMC behavior |
| C7 | 4.7nF / OEM dependent | Split termination stability |
| C8,9 | 10nF | Spike filtering, as required by application, mandatory protection for off-board connections, (see also Simplified Application Diagram with the Alternative Measurement Function) |
| C10 | 22 nF | As required by application and GPIO current capability (see also Chapter 11.1.2), mandatory protection for off-board connections |

## Resistances

| R1 | $1 \mathrm{k} \Omega$ | Device protection against reverse battery |
| :---: | :---: | :---: |
| R2 | $60 \Omega$ / OEM dependent | CAN bus termination |
| R3 | $60 \Omega$ / OEM dependent | CAN bus termination |
| R4 | $10 \mathrm{k} \Omega$ | Wetting current of the switch, as required by application |
| R5,6 | $10 \mathrm{k} \Omega$ | WK pin current limitation, e.g. for ISO pulses (see also Simplified Application Diagram with the Alternative Measurement Function) |
| R7, 8 | depending on application and microcontroller | Voltage Divider resistor to adjust measurement voltage to microcontroller ADC input range (see also Simplified Application Diagram with the Alternative Measurement Function) |
| R9 | $10 \Omega$ | As required by application, ESD protection, mandatory protection for off-board connections only |
| R10, 11 | $47 \mathrm{k} \Omega$ | Reverse battery protection |
| R12 | $100 \mathrm{k} \Omega$ | Leakage discharge resistor |

## Active Components

| D1 | e.g. BAS 3010A, Infineon | Reverse polarity protection for VS supply pins |
| :--- | :--- | :--- |
| D2 | e.g. BAS 21, Infineon | Reverse battery protection |
| D3 | 12V Zener Diode | Gate protection |
| D4 | e.g. BAS 21, Infineon | Reverse battery protection for measurement circuitry |
| D5 | e.g. LED | circuit example: Illumination LED |
| T1 | e.g. IPB80N04S4-04 | Terminal 30 (KI. 30) Switch, N-MOSFET |
| T2 | e.g. IPB80N04S4-04 | Reverse battery protection, N-MOSFET |

TLE9461-3ES V33

## Lite CAN SBC Family

Application Information

Table 39 Bill of Material for Simplified Application Diagram (cont'd)

| Ref. | Typical Value | Purpose / Comment |
| :--- | :--- | :--- |
| T3 | e.g. BCR191W | High active FO control |
| uC | e.g. TC2xxx | Microcontroller |

Application Information

### 14.2 ESD Tests

Tests for ESD robustness according to IEC61000-4-2 "GUN test" ( $150 \mathrm{pF}, 330 \Omega$ ) have been performed. The results and test condition are available in a test report. The values for the tests are listed below.

Table 40 ESD "GUN test"1/2)

| Performed Test | Result | Unit | Remarks |
| :--- | :--- | :--- | :--- |
| ESD at pins CANH, CANL, VS, WK, VCC2 <br> versus GND | $>6$ | kV | positive pulse |
| ESD at pins CANH, CANL, VS, WK, VCC2 <br> versus GND | $<-6$ | kV | negative pulse |

1) ESD susceptibility "ESD GUN" according to EMC 1.3 Test specification, Section 4.3 (IEC 61000-4-2). Tested by external test house (IBEE Zwickau, EMC Test report Nr. 02-05-18).
2) ESD Test "Gun Test" is specified with external components for pins VS, WK, and VCC2. See the application diagram in Chapter $\mathbf{1 4 . 1}$ for more information

EMC and ESD susceptibility tests according to SAE J2962-2 (V. 2014-01-23) have been performed. Tested by external test house (Jakob Mooser GmbH, Test report Nr. 145 / 2018) Lite CAN SBC Family

Application Information

### 14.3 Thermal Behavior of Package



Figure 54 Thermal Resistance ( $R_{\text {th_JA }}$ ) vs. Cooling Area

Application Information

Cross Section (JEDEC 2s2p) with Cooling Area
Cross Section (JEDEC 1s0p) with Cooling Area

*: means percentual Cu metalization on each layer


PCB (top view)


PCB (bottom view)


PCB attached at Housing

Figure 55 Board Setup

Board setup is defined according JESD 51-2, -5, -7.
Board: $75 \times 75 \times 1.5 \mathrm{~mm}^{3}$ with 2 inner copper layers ( $35 \mu \mathrm{~m}$ thick), with thermal via array under the exposed pad contacting the first inner copper layer and $300 \mathrm{~mm}^{2}$ cooling area on the bottom layer ( $70 \mu \mathrm{~m}$ ).

### 14.4 Further Application Information

- Please contact us for information regarding the pin FMEA
- For further information you may contact http://www.infineon.com/


## Package Outlines

## $15 \quad$ Package Outlines



1) DOES NOT INCLUDE PLASTIC OR METAL PROTRUSION OF 0.15 MAX. PER SIDE
2) DAMBAR PROTUSION SHALL BE MAXIMUM 0.1MM TOTAL IN EXCESS OF LEAD WIDTH

ALL DIMENSIONS ARE IN UNITS MM
THE DRAWING IS IN COMPLIANCE WITH ISO 128 \& PROJECTION METHOD 1 [ $\overbrace{\text { © }}$ ]

Figure 56 PG-TSDSO-24-1 Dimensions

## Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

## Revision History

## 16 Revision History

| Revision | Date | Changes |
| :---: | :---: | :---: |
| 1.0 | 2018-08-01 | Initial Release |
| 1.1 | 2019-09-27 | Datasheet updated: <br> - Editorial changes <br> - Updated Table 25 <br> - added P_9.3.55 and P_9.3.56 (no product change) <br> - tightened P_9.3.18 <br> - tightened P_9.3.8 and P_9.3.9 by additional footnote <br> - Fixed wrong symbol for P_13.9.56 <br> - Added max. recommendation for C4 in Table 39 |
| 1.2 | 2022-04-08 | Datasheet updated: <br> - Editorial changes <br> - Fixed wrong symbol for Drop-out voltage <br> - Updated register field 2MHZ_FREQ default value <br> - Updated P_9.3.32 and P_9.3.33 <br> - Modified typical value (no product change) <br> - Footnote removed <br> - Updated register description for SYS_STATUS_CTRL_0 and SYS_STATUS_CTRL_1. Removed "Cleared after Soft Reset" <br> - Fixed wrong unit of measurement in Figure $\mathbf{1 3}$ <br> - Added footnote 5) on parameters P_4.4.11 and P_4.4.12 |

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[^0]:    1) The level is determined by the wake comparator and is shown as Low or High, i.e. the feature might not be useful if a duty cycle of $0 \%<$ DC $<100 \%$ is applied
